



Space engineering

Testing

Foreword

This Standard is one of the series of ECSS Standards intended to be applied together for the management, engineering, product assurance and sustainability in space projects and applications. ECSS is a cooperative effort of the European Space Agency, national space agencies and European industry associations for the purpose of developing and maintaining common standards. Requirements in this Standard are defined in terms of what shall be accomplished, rather than in terms of how to organize and perform the necessary work. This allows existing organizational structures and methods to be applied where they are effective, and for the structures and methods to evolve as necessary without rewriting the standards.

This Standard has been prepared by the ECSS-E-ST-10-03 TA Task Force, reviewed by the ECSS Executive Secretariat and approved by the ECSS Technical Authority.

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Change log

<p>ECSS-E-10-03A 15 February 2002</p>	<p>First issue</p>
<p>ECSS-E-10-03B</p>	<p>Never issued</p>
<p>ECSS-E-ST-10-03C 1 June 2012</p>	<p>Second issue.</p>
<p>ECSS-E-ST-10-03C Rev.1 31 May 2022</p>	<p>Second issue, Revision 1</p> <p>Changes with respect to ECSS-E-ST-10-03C (1 June 2012) are identified with revision tracking.</p> <p>Main changes are:</p> <ul style="list-style-type: none"> • Scope: Clarification on applicability perimeter, including not covering space vehicle constellation • Thermal Tests: <ul style="list-style-type: none"> o New and more clear definitions, (thermal vacuum test, thermal test at room pressure and thermal test at mission pressure, they are no more in the Glossary), o Thermal Ambient Test not used and substituted by Thermal Test at mission pressure, o Alternative methods are addressed as reference to the Handbook o “thermal” word in thermal parameters (cycles, levels, gradient and so on) changed as “temperature”, o Test for switch on capability at equipment level was updated to cover test at maximum and minimum temperature, o New requirement on power status during thermal tests at equipment level and parameter monitoring. • Test on solar arrays and panel: <ul style="list-style-type: none"> o overall align of the Testing Standard with the new version of ECSS-E-ST-20-08, o new requirements for solar array performance tests in addition to flasher test, o additional requirement for after storage phase, o functional tests requirements at equipment level during thermal tests for solar arrays are now expanded. • Pressure test: <ul style="list-style-type: none"> o Overall alignment with new version of ECSS-E-ST-32-02, o requirements on proof pressure test rephrased to enlarge the objective of the test. • Input test Tolerance and measurement uncertainties: <ul style="list-style-type: none"> o “tolerance” definition was substituted by “test input tolerance” whereas “accuracy of measurement” was deleted and substituted by

“measurement uncertainty” to be in accordance with actual International Standards,

- o some requirements rephrased to avoid confusion between "uncertainty" (quantitative evaluation) and "error" (quantitative, but unknown),
- o Table 4-2 now addresses typical values for test centres and no more requirements.
- Sine burst test replaced Transient test at space segment equipment level, because rarely used, and it is merged with Transient at space segment element level.
- Microvibration and Audible noise:
 - o new requirements for microvibration in particular to cover signal measurement and background noise measurement and background noise mitigation actions,
 - o requirements on Audible noise were changed, and some deleted, at equipment level to account for the tight dependence on the mounting structure.
- Polarity test: new requirement for polarity test of non-critical modes.

Detailed changes:

Added requirements:

4.6.3h-i; 5.5.2.7c-e; 5.5.2.8c-e; 5.5.3.1i; 5.5.4.1s; 6.5.1.5e; 6.5.2.10b-d; 6.5.2.11a-d; 6.5.7.1d-f.

Modified requirements:

4.1.a Note; 4.3.2.3b; 4.3.2.4c; 4.3.5c; 4.4.1a, c and h; 4.4.2a-d; Table 4-1; 4.4.3a-b; Table 4-2; 4.5.2e; 4.5.3c Note deleted; 4.6.2a; 4.6.4b; 4.6.5c Note; 5.1c and e; Figure 5-1; Table 5-1; Table 5-2; Table 5-3; Table 5-4, Table 5-5; Table 5-6; 5.5.1.1l-m; 5.5.1.2b; 5.5.1.3b Note; 5.5.2.1a; 5.5.2.6a Note; 5.5.2.8a; 5.5.3.1a, c and h; 5.5.3.2a-b; 5.5.4.1a, b, g and l; 5.5.4.1p Note; 5.5.4.3a-b and d; 5.5.5.5a; 5.5.6.1.1a and c; 5.5.6.1.2a; 6.1a Note; 6.1b and d; 6.1.e Note; Table 6-1; Table 6-2; Table 6-3; Table 6-4; Table 6-5; Table 6-6; 6.4b (reference to Table corrected); 6.5.1.2.1c and f; 6.5.1.2.2a Note2; 6.5.1.2.3b; 6.5.1.5b; 6.5.1.6a and b; 6.5.2.1d; 6.5.2.3a-b; 6.5.2.5a-c, e and g; 6.5.2.6a; 6.5.2.10a; 6.5.3.3a; 6.5.4.1a, k Note; 6.5.4.3a, b and d; 6.5.7.1c; Annex B 2.1<7>a; Annex B 2.1<9>a; Annex C 2.1<8>a.

Only term “AIT P” changed to AIT Plan:

4.1c-d; 4.3.2.2b; 4.3.2.4b; 4.3.3.2a-b; in Annex A, Annex B and Annex C.

Deleted requirements:

4.4.1b; 4.4.2e; 4.4.3e; 4.5.2c-d; 5.5.6.1.1b; 5.5.6.1.2b; 5.5.6.1.3a-b; 6.5.3.1b; 6.5.7.1a-b; Annex B 2.1<9>b.

- PUID number of Table 4-2 deleted and replaced by new OUID number as the Table is now only called from a Note
- Several clause headings modified
- Cross references in Annex D created

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Introduction

The requirements on the systems engineering process are gathered in ECSS-E-ST-10; while specific aspects are further elaborated in dedicated standards, in particular: ECSS-E-ST-10-06, ECSS-E-ST-10-02 and the present standard (ECSS-E-ST-10-03)

In the System Engineering branch (ECSS-E-10) this standard aims at a consistent application of on ground testing requirements to allow proper qualification and acceptance of space products

Experience has demonstrated that incomplete or improper on ground testing approach significantly increase project risks leading to late discovery of design or workmanship problem(s) or in-orbit failure(s).

Testing is part of the system engineering process as defined in ECSS-E-ST-10. This starts at the early phase of the mission when defining verification process in terms of the model philosophy and sequences of tests and ends at the last testing phase prior launch.

In the level of decomposition of a space system, this standard addresses the requirements for space segment element and space segment equipment.

The document is organised such that:

- clause 4 provides requirements for overall test programme, test management test conditions, test input tolerances and measurement uncertainties;
- clause 5 provides requirements for Space segment equipment;
- clause 6 provides requirements for Space segment element;
- clause 7 provides requirements for Pre-launch testing.

Clauses 5 and 6 are organised as follows:

- general requirements for the products under test applicable to all models (clause 5.1 or 6.1);
- requirements applicable to qualification model (clause 5.2 or 6.2);
- requirements applicable to acceptance model (clause 5.3 or 6.3);
- requirements applicable to protoflight model (clause 5.4 or 6.4);
- detailed implementation requirements (clause 5.5 or 6.5);

In the clause providing requirements for each model (i.e. clauses 5.2, 5.3, 5.4, 6.2, 6.3 and 6.4), the first table of the clause:

- lists all types of test and defines their applicability and conditions;
- links to the second table of the clause that defines tests level and duration;

- provides reference to the clause defining the detailed implementation requirements for the given test (clause 5.5 or 6.5).

For space segment equipment, the required sequence of tests, for each model, is defined by tailoring the two tables in clause 5.2, 5.3 or 5.4.

Since testing activities are part of the overall verification activities, test documentation to be produced (DRD's) are either specified in the ECSS-E-ST-10-02 (case of the test report) or in this document.

Annex D gives guidelines for performing the tailoring of this standard as well as the generation of the compliance and verification matrices.

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Scope

This standard addresses the requirements for performing verification by testing of space segment elements and space segment equipment on ground prior to launch. The document is applicable for tests performed on qualification models, flight models (tested at acceptance level) and protoflight models.

The standard provides:

- Requirements for test programme and test management,
- Requirements for retesting,
- Requirements for redundancy testing,
- Requirements for environmental tests,
- General requirements for functional and performance tests,

NOTE Specific requirements for functional and performance tests are not part of this standard since they are defined in the specific project documentation.

- Requirements for qualification, acceptance, and protoflight testing including qualification, acceptance, and proto-flight models' test margins and duration,
- Requirements for test factors, test condition, test [input](#) tolerances, and [measurement uncertainties](#),
- General requirements for development tests pertinent to the start of the qualification test programme,

NOTE Development tests are specific and are addressed in various engineering discipline standards.

- Content of the necessary documentation for testing activities (e.g. DRD).

Due to the specific aspects of the following types of test, this Standard does not address:

- Space system testing (i.e. testing above space segment element), in particular the system validation test,
- [Testing peculiarities of space vehicles constellations](#),
- In-orbit testing,
- Testing of space segment subsystems,

NOTE Tests of space segment subsystems are often limited to functional tests that, in some case, are run on dedicated models. If relevant,

qualification tests for space segment subsystems are assumed to be covered in the relevant discipline standards.

- Testing of hardware below space segment equipment levels (including assembly, parts, and components),
- Testing of stand-alone software,

NOTE For verification of flight or ground software, ECSS-E-ST-40 and ECSS-Q-ST-80 apply.

- Testing of two-phase heat transport equipment,

NOTE For acceptance and qualification testing of two-phase heat transport equipment, ECSS-E-ST-31-02 applies.

- Tests of launcher segment, subsystem and equipment, and launch facilities,
- Tests of facilities and ground support equipment,
- Tests of ground segment.

This standard may be tailored for the specific characteristic and constrains of a space project in conformance with ECSS-S-ST-00. Annex D gives guidelines for performing this tailoring.

Normative references

The following normative documents contain provisions which, through reference in this text, constitute provisions of this ECSS Standard. For dated references, subsequent amendments to, or revision of any of these publications do not apply. However, parties to agreements based on this ECSS Standard are encouraged to investigate the possibility of applying the more recent editions of the normative documents indicated below. For undated references, the latest edition of the publication referred to applies.

ECSS-S-ST-00-01	ECSS system - Glossary of terms
ECSS-E-ST-10-02	Space engineering - Verification
ECSS-E-ST-20	Space engineering - Electrical and electronic
ECSS-E-ST-20-01	Space engineering - Multipactor design and test
ECSS-E-ST-20-06	Space engineering - Spacecraft charging
ECSS-E-ST-20-07	Space engineering - Electromagnetic compatibility
ECSS-E-ST-20-08	Space engineering - Photovoltaic assemblies and components
ECSS-E-ST-31	Space engineering - Thermal control general requirements
ECSS-E-ST-32	Space engineering - Structural general requirements
ECSS-E-ST-32-02	Space engineering - Structural design and verification of pressurized hardware
ECSS-E-ST-32-10	Space engineering - Structural factors of safety for spaceflight hardware
ECSS-E-ST-32-11	Space engineering - Modal survey assessment
ECSS-E-ST-33-01	Space engineering - Mechanisms
ECSS-M-ST-40	Space project management - Configuration and information management
ECSS-Q-ST-10-09	Space product assurance - Nonconformance control system
ECSS-Q-ST-20-07	Space product assurance - Quality assurance for test centres
ECSS-Q-ST-40	Space product assurance - Safety
ECSS-Q-ST-70-01	Space product assurance - Cleanliness and contamination control
ISO 3740:2019	Acoustics - Determination of sound power levels of noise sources - Guidelines for the use of basic standards

Terms, definitions and abbreviated terms

3.1 Terms from other standards

- a. For the purpose of this standard; the terms and definitions from ECSS-S-ST-00-01 apply, and in particular the following:
 1. commissioning
 2. flight model
 3. lifetime
 4. protoflight model
 5. qualification model
 6. space segment element
 7. space segment equipment
 8. space segment subsystem
 9. structural model
 10. system
 11. test
- b. For the purpose of this standard, the following terms and definitions from ECSS-E-ST-10-02 apply:
 1. model philosophy
- c. For the purpose of this Standard, the following terms and definitions from ECSS-E-ST-31 apply:
 1. acceptance temperature range
 2. design temperature range
 3. minimum switch ON temperature
 4. predicted temperature range
 5. qualification temperature range
 6. temperature reference point (TRP)
- d. For the purpose of this Standard, the following terms and definitions from ECSS-E-ST-32 apply:
 1. factor of safety (FOS)
 2. limit load (LL)
 3. maximum design pressure (MDP)
 4. proof test
- e. For the purpose of this Standard, the following terms and definitions from ECSS E ST-32-02 apply:
 1. burst pressure
 2. design burst pressure
 3. proof factor
 4. proof pressure

3.2 Terms specific to the present standard

3.2.1 24-hour equivalent noise exposure level

equivalent sound pressure level (L_{eq}) to which the crew members are exposed over a 24-hour period; expressed in dBA

NOTE 0 dBA corresponds to 20 μ Pa.

3.2.2 abbreviated functional test (AFT)

See "reduced functional test (RFT)"

3.2.3 acceptance level

test level required by increasing the severity of an extreme level expected to be encountered during the specified product lifetime for the purpose of workmanship verification.

3.2.4 acceptance margin

increase in severity of the environmental, mechanical, electrical, EMC, or operational extreme levels expected to be encountered during the specified product lifetime for the purpose of workmanship verification

NOTE This margin can include an increase in level, an extension of range, an increase in duration or cycles of exposure, as well as any other appropriate increase in severity.

3.2.5 crewed space segment element

space segment design to ensure the safe presence of crew onboard

3.2.6 dwell time

duration necessary to ensure that internal parts or subassembly of a space segment equipment have achieved thermal equilibrium, from the start of temperature stabilisation phase, i.e. when the temperature reaches the targeted test temperature plus or minus the test tolerance

3.2.7 environmental tests

tests applied to a product simulating (together or separately) environmental conditions as encountered during its operational life cycle

NOTE Environmental tests cover natural and induced environments.

3.2.8 full functional test (FFT)

comprehensive test that demonstrates the integrity of all functions of the item under test, in all operational modes, including back-up modes and all foreseen transitions

NOTE 1 The main objectives of this test is to demonstrate absence of design manufacturing and integration error.

NOTE 2 FFT exists at the different level of decomposition of a space segment element. For satellite they also called system functional test (SFT) or integrated system test (IST).

3.2.9 maximum expected acceleration

acceleration value determined from the combined effects of the steady state acceleration and the transient response of the item as it will experience during its life time

NOTE 1 This term is equivalent to limit load (as defined in E-ST-32).

NOTE 2 Examples of events during life time are transportation, handling, engine ignition, engine burnout, and stage separation.

3.2.10 maximum expected acoustic spectrum

maximum value of the time average root-mean-square (r.m.s.) sound pressure level (SPL) in each frequency band occurring inside the payload fairing, orbiter, or cargo bay, which occurs during flight events

NOTE 1 E.g. lift-off, powered flight or re-entry.

NOTE 2 The maximum expected acoustic environment test spectrum is specified in octave or 1/3 octave bands over a frequency range of 31,5 Hz to 10 kHz. The duration of the maximum environment is the total period when the overall amplitude is within 6 dB of the maximum overall amplitude.

3.2.11 maximum expected shock

worst cases of the collection of the shock at their mounting interface due to every possible cause

NOTE 1 For example: causes of shocks are stage, shroud or satellite separation pyro devices, non-explosive actuators, mechanisms with energy release, appendage latching, and fuel valves.

NOTE 2 Shocks can be characterized by their time histories, shock response spectrum, or impulse geometry.

NOTE 3 Refer to ECSS-E-HB-32-25 for additional information.

3.2.12 maximum expected random vibration spectrum

maximum expected environment imposed on the space segment element and space segment equipment due to broad band random forcing functions within the launch element or space segment element during flight or from ground transportation and handling

NOTE 1 E.g. lift-off acoustic field, aerodynamic excitations, and transmitted structure-borne vibration.

NOTE 2 A different spectrum can exist for different space segment equipment zones or for different axis. The space segment equipment vibration levels are based on vibration response measurements or model prediction made at the space segment equipment attachment points during ground acoustic tests or during flight. The duration of the maximum environment is the total period during flight when the overall level is within 6 dB of the maximum overall level.

NOTE 3 The power spectral density is based on a frequency resolution of 1/6 octave (or narrower) bandwidth analysis, over a frequency range of 20 Hz to 2000 Hz.

3.2.13 maximum predicted temperature

maximum value of the predicted temperature range

3.2.14 minimum predicted temperature

minimum value of the predicted temperature range

3.2.15 notching

reduction of the input level or spectrum to limit structural responses at resonant frequencies according to qualification or acceptance loads during a vibration test

NOTE Notching is a general accepted practice in vibration testing to avoid over testing of the item under test. Implementation of notching is subject to customer approval and when relevant to Launcher authority approval

3.2.16 operational modes

combination of operational configurations or conditions that can occur during the product lifetime for space segment equipment or space segment element

NOTE For example: Power-on or power-off, command modes, readout modes, attitude control modes, antenna stowed or deployed, and spinning or de-spun.

3.2.17 performance test

test to verify that the item under test performs according to its specifications while respecting its operational requirements

NOTE Performance tests are mission specific therefore their details are not specified under this standard.

3.2.18 polarity test

test to verify the correct polarity of the functional chains (mainly AOCS) or equipment of the space segment element from sensors to actuators, through a number of interfaces and processing.

NOTE 1 A polarity error can be generated throughout the development process: interface documentation, design, H/W manufacturing, S/W development, satellite AIT, satellite database.

NOTE 2 A polarity error can be generated by any **component** of the functional chain: sensor or actuator design, sensor or actuator mounting, harness, interface units, software algorithms.

NOTE 3 Polarity inversion on Safe Mode control loops can cause a satellite loss.

NOTE 4 This term "sign test" is synonymous.

3.2.19 qualification level

test level required by increasing the severity of an acceptance level for the purpose of design margin demonstration

3.2.20 qualification margin

increase in severity of the environmental, mechanical, electrical, EMC, or operational extreme levels expected to be encountered during the specified product lifetime for the purpose of design margin demonstration

NOTE This margin can include an increase in level, an extension of range, an increase in duration or cycles of exposure, as well as any other appropriate increase in severity.

3.2.21 reduced functional test (RFT)

sub-set of the **full functional test** to verify the integrity of the major functions of the item under test, with a sufficiently high degree of confidence, in a relatively short time

NOTE The term "abbreviated functional test (AFT)" is synonymous.

3.2.22 residual life

time left before a product is no longer able to achieve minimum acceptable performance requirements, including availability

NOTE Criteria can be estimated in terms of serviceability or structural strength for example.

3.2.23 resolution

minimum readable value of a quantity on a measurement system

NOTE The resolution is accounted for in the **overall uncertainty evaluation**.

3.2.24 resonance search

frequency sweep of low level sinusoidal vibrations to characterise main resonant modes for preparing the higher level runs, and to show possible deficiencies in workmanship, as a consequence of high level runs

NOTE Resonance search is also known as “signature test”, “low level sinusoidal vibration test”, “low level sine sweep”, “low level sweep” or “low level test”.

3.2.25 reverberation time (T60)

duration necessary for the sound level to decrease by 60 dB after the switch off of the sound source

3.2.26 shock response spectrum (SRS)

graphical representation of a transient waveform determined by the response of a set of single degree of freedom oscillators using a defined amplification factor Q

NOTE 1 The Shock Response Spectrum can be defined for any input or response parameters of interest (displacement, velocity, or acceleration). For aerospace structures it is common to define the input transient in terms of acceleration.

NOTE 2 The acceleration amplification factor Q is conventionally chosen equal to 10, corresponding to a factor of critical damping equal to 5 %. In situations when damping is known, Q can be chosen accordingly.

NOTE 3 The Shock Response Spectrum allows characterizing the shock effect in order to estimate its severity or its damaging potential.

NOTE 4 There are several representations of Shock Response Spectrum, including positive, negative, primary, residual and maximax. The latter SRS envelopes the previous four and is the most commonly used for shock testing.

3.2.27 sign test

see “polarity test”

3.2.28 temperature cycle

transition from an initial temperature to the same temperature, with excursion within a specified range

3.2.29 temperature plateau

time, during specified steps of an environmental test, with fulfilment of specified stabilization criteria applicable to a temperature level.

NOTE Specified criteria cover the instants of entry and exit of the temperature plateau, and its total duration.

3.2.30 test block

aggregation of several tests grouped by discipline

3.2.31 test input tolerance

limiting or permitted **specified** range of values of a specified test level or of a **specified test duration** without affecting the test objectives

NOTE This **range** is typically specified as deviation from a specified value, or as an explicit range of allowed values. It can be symmetrical, as in $40 \pm 0,1$, or asymmetrical, such as $40 -0,2/+0,1$.

3.2.32 thermal test at room pressure

test conducted at room pressure and under predefined temperature conditions to demonstrate the capability of the test specimen to operate according to requirements

NOTE 1 Temperature conditions can be expressed as temperature level, gradient, difference and variation.

NOTE 2 The room pressure is the pressure at Earth surface level (about 1013 hPa).

NOTE 3 The terms "temperature cycling test at room pressure" and "room pressure temperature cycling test" are synonymous.

NOTE 4 The "temperature cycling test at room pressure" is also called "thermal cycling" (e.g., US standards).

3.2.33 thermal test at mission pressure

test conducted at mission pressure and under predefined temperature conditions to demonstrate the capability of the test specimen to operate according to requirements

NOTE 1 Temperature conditions can be expressed as temperature level, gradient, difference and variation.

NOTE 2 The pressure is representative of the mission dependent pressure. For example, Mars or Venus atmospheric pressure, pressure in a lander or during a balloon ascent/descent, a space station pressurized module.

NOTE 3 The terms "temperature cycling test at mission pressure" and "mission pressure temperature cycling test" are synonymous.

3.2.34 thermal vacuum

test conducted in vacuum under predefined temperature conditions to demonstrate the capability of the test item to operate according to requirements

NOTE 1 Temperature conditions can be expressed as temperature level, gradient, difference and variation.

NOTE 2 The terms "temperature cycling test in vacuum" and "vacuum temperature cycling test" are synonymous.

3.3 Abbreviated terms

For the purposes of this Standard the following abbreviated terms apply.

Abbreviation	Meaning
AFT	abbreviated functional test
AIT	assembly, integration and test
AIV	assembly, integration and verification
AVT	acceptance vibration test
CCB	configuration control board
CoG	centre of gravity
DRD	document requirements definition
EC	European Commission
EGSE	electrical ground support equipment
EM	engineering model
EMC	electromagnetic compatibility
EMCCP	electromagnetic compatibility control plan
EQM	engineering qualification model
ESD	electrostatic discharge
FFT	full functional test
FM	flight model
FOP	flight operation plan
GSE	ground support equipment
HFE	human factors engineering
HMI	human-machine interface
ICD	interface control document
KIP	key inspection point
LCDA	launcher coupled dynamic analysis
LCL	latching current limiter
LEOP	launch and early orbit phase

Abbreviation	Meaning
MDP	maximum design pressure
MIP	mandatory inspection point
MoI	moment of inertia
NC	noise criterion
NCR	nonconformance report
NRB	nonconformance review board
OSPL	overall sound pressure level
PFM	protoflight model
PIM	passive intermodulation
PSD	power spectral density
PT	performance test
PTR	post test review
QM	qualification model
r.m.s.	root-mean-square
RF	radio frequency
RFT	reduced functional test
SEP	system engineering plan
SFT	system functional test
SPL	sound pressure level
SRS	shock response spectrum
SVT	system validation test
TB	thermal balance
TC	telecommand
TCS	thermal control system
TM	telemetry
TPRO	test procedure
TR	test review
TRB	test review board
TRP	temperature reference point
TRPT	test report
TRR	test readiness review
TV	thermal vacuum
T_{\max}^A	maximum value of the acceptance temperature range required at a unit TRP
T_{\min}^A	minimum value of the acceptance temperature range required at a unit TRP

Abbreviation	Meaning
T_{\max}^D	maximum value of the design temperature range required at a unit TRP
T_{\min}^D	minimum value of the design temperature range required at a unit TRP
T_{\max}^Q	maximum value of the qualification temperature range required at a unit TRP
T_{\min}^Q	minimum value of the qualification temperature range required at a unit TRP
T_{Nop}	non-operating temperature
T_{Op}	operating temperature
TSPE	test specification
TT&C	telemetry, tracking and command
TWT	travelling wave tube
VCD	verification control document
VP	verification plan

3.4 Nomenclature

The following nomenclature applies throughout this document:

- The word “shall” is used in this Standard to express requirements. All the requirements are expressed with the word “shall”.
- The word “should” is used in this Standard to express recommendations. All the recommendations are expressed with the word “should”.

NOTE It is expected that, during tailoring, recommendations in this document are either converted into requirements or tailored out.

- The words “may” and “need not” are used in this Standard to express positive and negative permissions, respectively. All the positive permissions are expressed with the word “may”. All the negative permissions are expressed with the words “need not”.
- The word “can” is used in this Standard to express capabilities or possibilities, and therefore, if not accompanied by one of the previous words, it implies descriptive text.

NOTE In ECSS “may” and “can” have completely different meanings: “may” is normative (permission), and “can” is descriptive.

- The present and past tenses are used in this Standard to express statements of fact, and therefore they imply descriptive text.

General requirements

4.1 Test programme

ECSS-E-ST-10-03_0750001

- a. A coherent test programme shall be established, encompassing each verification stage and level to implement the verification by testing.

NOTE 1 The testing programme is performed incrementally at different product decomposition levels.

NOTE 2 Refer to clause 3.1 for determining the type of item for which the test programme is defined (i.e. space segment equipment or space segment element) and to [ECSS-S-ST-00-01 Glossary of terms](#).

NOTE 3 The number and type of testing levels depends upon the complexity of the project and on its characteristics in accordance with the Verification programme (see ECSS-E-ST-10-02).

NOTE 4 The test programme documentation is defined in 4.3.3.

ECSS-E-ST-10-03_0750002

- b. The customer and the supplier shall agree the need to treat a space segment element as a space segment equipment.

NOTE This is typically the case for small instrument.

ECSS-E-ST-10-03_0750003

- c. AIT [Plan](#) and test specifications shall be derived from the product requirements, verification plan and verification control document (VCD).

NOTE Verification plan and VCD are defined in ECSS-E-ST-10-02.

ECSS-E-ST-10-03_0750004

- d. Test procedures shall be derived from test specifications and AIT [Plan](#).

ECSS-E-ST-10-03_0750005

- e. Test programme and its implementation shall be in conformance with safety requirements of ECSS-Q-ST-40 and ECSS-Q-ST-20-07.

4.2 Development test prior qualification

ECSS-E-ST-10-03_0750006

- a. Development test of a product shall be completed prior to the start of its formal qualification testing.

NOTE Development tests are conducted over a range of operating conditions that can exceed the design range.

ECSS-E-ST-10-03_0750007

- b. Development tests shall not be conducted on qualification or flight models or parts of it.

ECSS-E-ST-10-03_0750008

- c. Records of test configuration, test results and other pertinent data shall be maintained.

NOTE This kind of information can be used for investigation when failure occurs during the qualification and acceptance, or for other investigations.

4.3 Test management

4.3.1 General

ECSS-E-ST-10-03_0750009

- a. The supplier shall assign clear responsibility for the implementation of the test programme.

ECSS-E-ST-10-03_0750010

- b. The customer, or its duly appointed representative, shall have the right to participate to all test phases.

4.3.2 Test reviews

4.3.2.1 Test programme

ECSS-E-ST-10-03_0750011

- a. The test programme shall be decomposed in blocks.

NOTE The general test programme is reviewed at the CDR as per ECSS-M-ST-10.

ECSS-E-ST-10-03_0750012

- b. The definition of the blocks of requirement 4.3.2.1a shall be agreed between the customer and supplier.

NOTE 1 Test block definition depends mainly on the item under test, the facility and the contractual agreement. A test block can include one or more tests. For equipment, usually one test block covers the full test programme.

NOTE 2 Typical test blocks for space segment elements are:

- Integration
- Alignment
- Leak/proof pressure
- Mechanical (Static load test, sinusoidal, acoustic, random, modal survey, shock)
- EMC conducted
- EMC radiated/auto-compatibility/RF
- Thermal (TB/TV test)
- Functional and performance test
- Final preparation

ECSS-E-ST-10-03_0750013

c. Each test block shall include the following formal reviews:

1. test readiness review (TRR);
2. post test review(s) (PTR);
3. test review board (TRB).

NOTE 1 TRRs from several blocks can be combined, TRRs can also be combined with a PTR of the previous block.

NOTE 2 Depending on the nature of the test, the customer can decide to establish additional key-points between formal reviews. Typical examples are transition between level and axes in vibration tests and transition between test phases in TV/TB tests.

4.3.2.2 Test readiness review (TRR)

ECSS-E-ST-10-03_0750014

a. A TRR shall be held before the start of the test activity to verify that all conditions allow to proceed with the test.

ECSS-E-ST-10-03_0750015

b. The TRR shall address the following topics:

1. test documentation availability and suitability, including:
 - (a) approved AIT Plan,
 - (b) approved test specification,
 - (c) test predictions (when relevant),
 - (d) approved test procedures (including contingency and emergency procedures),

- (e) approved measurement point plan,
 - (f) approved test facility readiness report,
 - (g) approved test schedule, and
 - (h) acceptance data package of lower level items.
2. item under test configuration;
 3. test configuration/set-up;
 4. inspection status report of KIP, MIP, or both;
 5. test facility, environmental conditions, test instrumentations, calibration, maintenance status;
 6. cleanliness condition, hazard and safety;
 7. ground support equipment (GSE) and infrastructures;
 8. status of nonconformances that affect the item under test, its associated GSE, or the test facility;
 9. waivers status, and deviations;
 10. personnel qualification and availability;
 11. results from test rehearsal using the test facility with or without the item under test, when relevant;
 12. test pass/fail criteria completeness;
 13. assignment of responsibilities;
 14. test schedule.

NOTE 1 For 4.3.2.2b.1(f), the content of the facility readiness report is defined in ECSS-Q-ST-20-07.

NOTE 2 The level of details according to which each topic is addressed, is different for the general test programme TRR than for each block test TRR.

ECSS-E-ST-10-03_0750016

- c. The following parties shall participate to the TRR:
1. the chairperson, who is the product assurance manager of the authority responsible for the test;
 2. product assurance from all involved parties;
 3. project engineer from all involved parties;
 4. AIT from all involved parties;
 5. specialists, when necessary from all involved parties;
 6. facility representative;
 7. other as relevant.

NOTE For example launcher authority for tests related to launcher interface or other company representative that will take over the responsibility of the hardware after delivery.

ECSS-E-ST-10-03_0750017

- d. All the open points shall be clearly identified and actions assigned with closure date before the execution of the test.

ECSS-E-ST-10-03_0750018

- e. The output of the TRR shall be a decision to proceed with the test or not.

4.3.2.3 Post test review (PTR)

ECSS-E-ST-10-03_0750019

- a. A PTR shall be held in order to formally declare the test completed and allow the release of the item under test and test facility for further activity.

NOTE The release of the test facility includes the breaking of the test configuration.

ECSS-E-ST-10-03_0750020

- b. The PTR shall address the following topics:

1. verification that all test data were acquired, recorded, and archived in conformance with the test specification and test procedure requirements;
2. verification that the process for test anomalies and NCRs, raised during the test, was initiated, and all needed inspection, test data and test configuration were acquired;
3. confirmation that tests were performed according to the AIT [Plan](#), the test specification and the test procedures, with the exceptions of what is covered by agreed procedure variations or NCRs or [Open Works](#);
4. status of compliance of the item under test to the relevant requirement;
5. post test status of GSE;
6. post item under test configuration based on inspection and cleanliness report;
7. identification of the open points with assignment of actions for their closure, as well as lessons learned drawn.

ECSS-E-ST-10-03_0750021

- c. The following parties shall participate to the PTR:

1. product assurance;
2. project engineer;
3. AIT;
4. facility representative;
5. other, including specialist, as relevant.

NOTE For example launcher authority for tests related to launcher interface or other company representative that will take over the responsibility of the hardware after delivery.

4.3.2.4 Test review board (TRB)

ECSS-E-ST-10-03_0750022

- a. A TRB shall be held to review all results and conclude on the test completeness and achievement of objectives.

ECSS-E-ST-10-03_0750023

- b. The TRB shall address the following topics:

1. test documentation availability, including:
 - (a) test report as per ECSS-E-ST-10-02 Annex C,
 - (b) facility report when relevant,
 - (c) inspection report including cleanliness report,
 - (d) list of NCRs,
 - (e) copy of NCRs raised during test with the related NRB minutes of meeting, and associated request(s) for waiver, and
 - (f) list of procedure deviations.
2. compliance with the test specification, and variations to the AIT Plan;
3. status of compliance of the item under test to the relevant requirement;
4. post test status of GSE;
5. post item under test configuration based on inspection and cleanliness report;
6. review of all still open NCRs raised during test in order to assess that there is no impact on the test objectives achievement;
7. lessons learned to be drawn.

ECSS-E-ST-10-03_0750024

- c. The following parties shall participate to the TRB:

1. product assurance;
2. project engineer;
3. facility representative;
4. other, including specialist, as relevant.

NOTE For example AIT, in support of project engineering, or launcher authority for tests related to launcher interface or other company representative that will take over the responsibility of the hardware after delivery.

4.3.3 Test documentation

4.3.3.1 General

Clauses 4.3.3.2 to 4.3.3.5 define the Test programme documentation (AIT Plan, Test specification, Test procedure, and Test report) generated at all product levels.

These documents are derived from the System Engineering Plan (SEP) and from the Verification Plan (VP).

4.3.3.2 Assembly, integration and test plan (AIT Plan)

ECSS-E-ST-10-03_0750025

- a. The supplier shall establish the AIT Plan in conformance with the DRD in Annex A.

NOTE At space segment equipment level, the AIT Plan can be called test plan.

ECSS-E-ST-10-03_0750026

- b. The agreed AIT Plan shall be available, at the latest, for the TRR of the test programme.

ECSS-E-ST-10-03_0750027

- c. The way the requirement 4.3.3.2b is achieved shall be agreed between the customer and the supplier.

4.3.3.3 Test specification (TSPE)

ECSS-E-ST-10-03_0750028

- a. The supplier shall establish the test specification in conformance with the DRD in Annex B.

ECSS-E-ST-10-03_0750029

- b. The agreed test specification shall be available at the relevant test block TRR and on time to allow procedure preparation.

ECSS-E-ST-10-03_0750030

- c. The way the requirement 4.3.3.3b is achieved shall be agreed between the customer and the supplier.

4.3.3.4 Test procedure (TPRO)

ECSS-E-ST-10-03_0750031

- a. The supplier shall establish the test procedure in conformance with the DRD in Annex C.

ECSS-E-ST-10-03_0750032

- b. The test procedure, derived from the agreed test specification, shall be available at the relevant test block TRR.

ECSS-E-ST-10-03_0750033

- c. The way the requirement 4.3.3.4b is achieved shall be agreed between the customer and the supplier.

4.3.3.5 Test report (TRPT)

ECSS-E-ST-10-03_0750034

- a. The supplier shall establish the test report in conformance with the DRD in Annex C of ECSS-E-ST-10-02.

NOTE The test report describes test execution, results and conclusions in the light of the test requirements. It contains the test description and the test results including the as-run test procedures, the considerations and conclusions with particular emphasis on the close-out of the relevant verification requirements including any deviation.

ECSS-E-ST-10-03_0750035

- b. The test report shall be available prior to the TRB.

4.3.4 Anomaly or failure during testing

ECSS-E-ST-10-03_0750036

- a. Any failure or anomaly during testing shall be recorded.

ECSS-E-ST-10-03_0750037

- b. All nonconformances shall be managed in conformance with ECSS-Q-ST-10-09.

ECSS-E-ST-10-03_0750038

- c. The NRB shall decide on the necessity and extent of any retest activity in order to demonstrate the correctness of the disposition made.

4.3.5 Test data

ECSS-E-ST-10-03_0750039

- a. Test measurements and the environmental conditions shall be recorded for subsequent evaluation.

ECSS-E-ST-10-03_0750040

- b. A database of parameters shall be established for trend analysis.

ECSS-E-ST-10-03_0750041

- c. Trend analysis shall be performed using test data acquired across [sequences of tests](#).

4.4 Test conditions, input tolerances, and measurement uncertainties

4.4.1 Test conditions

- ECSS-E-ST-10-03_0750042
- a. The TSPE shall establish the required test conditions.
- ECSS-E-ST-10-03_0750043
- b. <<deleted>>
- ECSS-E-ST-10-03_0750044
- c. If an item is tested in conditions different from the ones in which it is expected to operate, then the test levels and durations shall account for the possible differences in behaviour.
- NOTE In this case, the test levels and durations are modified based on analyses. For example to prevent effects of convective heat transfer that can reduce temperature differences.
- ECSS-E-ST-10-03_0750045
- d. Cleanliness and contamination control for test programmes shall conform to ECSS-Q-ST-70-01.
- ECSS-E-ST-10-03_0750046
- e. The quality and safety management system used to operate and maintain test facility(ies) shall be recognized by the customer.
- NOTE As example, in accordance to quality and safety management system requirements from ECSS-Q-ST-20-07.
- ECSS-E-ST-10-03_0750047
- f. Test facilities, tools and instrumentation shall not prevent to fulfil the tests objectives.
- ECSS-E-ST-10-03_0750048
- g. The EGSE or other support systems of the item under test shall:
1. not jeopardize the results of tests;
 2. be immune to signals used for susceptibility tests;
 3. be designed to comply with the applicable legislation, including safety (e.g. EC Directives).
- ECSS-E-ST-10-03_0750049
- h. The combination of test set-up, test levels, test durations, and operational modes shall not create conditions that can:
1. induce failures of the item under test,
 2. lead to rejection of adequate item under test, or
 3. create hazardous conditions.

4.4.2 Test input tolerances

ECSS-E-ST-10-03_0750050

- a. The test input tolerances bands shall be agreed by the customer and specified in the TSPE.

ECSS-E-ST-10-03_0750051

- b. For the purpose of 4.4.2a, test input tolerances shall account for the uncertainty budget and confidence level of the measurement instrument(s) and test equipment used to control and monitor the test parameters.

NOTE 1 JCGM 100 series, EA-4/16 and EA-4/02 guidelines and ISO/IEC 17025 general requirements can be used to build up the measurement uncertainty budgets.

NOTE 2 The test input tolerances specified in Table 4-1 are the allowable ranges within which the test parameters, as measured, can vary.

ECSS-E-ST-10-03_0750052

- c. Quantitative requirements demonstrated by measured values shall account for associated uncertainties, and be compared with the specified test values.

ECSS-E-ST-10-03_0750053

- d. The test input tolerances specified in Table 4-1 shall be applied to the specified test values.

ECSS-E-ST-10-03_0750054

- e. <<deleted>>

Table 4-1: Allowable test input tolerances

ECSS-E-ST-10-03_0750439

Test parameters	Test Input Tolerances	
	Low	High
1. Temperature		
above 80K, only at space segment equipment level. At space segment element level, see Table 6-2, Table 6-4, Table 6-6	Tmin +0/-4 K	Tmax -0/+4 K
T < 80 K	To be defined case by case	
2. Relative humidity	± 10 %	
3. Pressure (in vacuum chamber)		
> 1,3 hPa	± 15 %	
1,3 10 ⁻³ hPa to 1,3hPa	± 30 %	
< 1,3 10 ⁻³ hPa	± 80 %	
4. Acceleration (steady state) and static load	-0 / +10 %	
5. Sinusoidal vibration		
Frequency (5 Hz to 2000 Hz)	± 2 % (or ±1 Hz whichever is greater)	
Amplitude	± 10 %	
Sweep rate (Oct/min)	± 5 %	

Test parameters	Test Input Tolerances
6. Random vibration	
Amplitude (PSD, frequency resolution better than 10Hz)	
20 Hz - 1000 Hz	-1 dB / +3 dB
1000 Hz - 2000 Hz	± 3 dB
Random overall g r.m.s.	± 10 %
7. Acoustic noise	
Sound pressure level, Octave band centre (Hz)	
31,5	-2 dB /+4 dB
63	-1 dB /+3 dB
125	-1 dB /+3 dB
250	-1 dB /+3 dB
500	-1 dB /+3 dB
1000	-1 dB /+3 dB
2000	-1 dB /+3 dB
Overall	-1 dB /+3 dB
Sound pressure level homogeneity per octave band	+/- 2 dB
8. Microvibration	
Acceleration	±10 %
Forces or torque	±10 %
9. Audible noise (for Crewed space segment element only)	
Sound-power (1/3 octave band centre frequency)	
32,5 Hz - 160 Hz	±3 dB
160 Hz – 16 kHz	±2 dB
9. Shock	
Response spectrum amplitude (1/12 octave centre frequency or higher)	
Shock level	- 3 dB/ + 6 dB 50 % of the SRS amplitude above 0 dB
10. Solar radiation	
in reference plane	± 4 % of the set value
in reference volume	± 6 % of the set value
11. Infrared radiation	
Mean value	± 3 % on reference plane(s)
12. Test duration	-0/+10 %

4.4.3 Measurement uncertainties

ECSS-E-ST-10-03_0750055

- a. The allowable measurement uncertainties shall be agreed by the customer and specified in the TSPE.

NOTE 1 This is important for the selection of the test facility, test instrumentation and GSE.

NOTE 2 Table 4-2 provides typical values from test centers.

ECSS-E-ST-10-03_0750056

- b. The measurement uncertainty shall be demonstrated based on approved calibration procedures, with traceability to international measurement standards.

ECSS-E-ST-10-03_0750057

- c. All test instrumentation shall be within the normal calibration period at the time of the test.

ECSS-E-ST-10-03_0750058

- d. Any anomaly of test instrumentation, detected at the first calibration sequence after the test, shall be reported.

ECSS-E-ST-10-03_0750059

- e. <<deleted>>

Table 4-2: Typical measurement uncertainties from test centers

Test parameters	Uncertainty interval with 95% confidence level
1. Mass	
Space segment equipment and space segment element	$\pm 0,05 \%$ or 1 g whatever is the heavier
2. Centre of gravity (CoG)	
Space segment equipment	Within a 1 mm radius sphere
Space segment element	$\pm 2,5$ mm along launch axis ± 1 mm along the other 2 axes
3. Moment of inertia (MoI)	
Space segment equipment and Space segment element	$\pm 3 \%$ for each axis
4. Leak rate	One magnitude lower than the system specification, in $\text{Pa m}^3 \text{s}^{-1}$ at standard conditions (1013,25 Pa and 288,15 K).
5. Audible noise (for Crewed space segment element only)	
32,5 Hz to 160 Hz	± 3 dB
160 Hz to 16 kHz	± 2 dB
6. Temperature	
above 80 K	± 2 K
$T < 80$ K	To be defined case by case
7. Pressure (in vacuum chamber)	
$> 1,3$ hPa	$\pm 15 \%$
$1,3 \cdot 10^{-3}$ hPa to 1,3 hPa	$\pm 30 \%$
$< 1,3 \cdot 10^{-3}$ hPa	$\pm 80 \%$
8. Acceleration (steady state) and static load	$\pm 10 \%$
9. Frequency for mechanical tests	$\pm 2 \%$ (or ± 1 Hz whichever is greater)
10. Acoustic noise	$\pm 0,1$ dB
11. Strain	$\pm 10 \%$
12. EMC	See ECSS-E-ST-20-07 clause 5.2.1.
13. ESD	See ECSS-E-ST-20-06 See ECSS-E-ST-20-07 clause 5.2.1 for ESD test on space segment equipment.

4.5 Test objectives

4.5.1 General requirements

ECSS-E-ST-10-03_0750060

- a. The test programme shall be defined taking into account the agreed model philosophy.

NOTE The model philosophy, including model definition, is detailed in ECSS-E-HB-10-02.

ECSS-E-ST-10-03_0750061

- b. When preparing the overall test programme of a space segment element tests linked to compatibility with ground and launch segment shall also be included.

NOTE This covers in particular the system validation test.

4.5.2 Qualification testing

ECSS-E-ST-10-03_0750062

- a. Qualification testing shall be performed to provide evidence that the space segment element or equipment performs in accordance with its specifications in the intended environments with the specified qualification margins.

NOTE 1 The Qualification test programme requirements are defined in ECSS-E-ST-10-02 requirement 5.2.4.2b. and 5.2.4.2c.

NOTE 2 This evidence is used, further to analysis as relevant, to provide via verification reports (defined in ECSS-E-ST-10-02 Annex F) the elements for the close-out of the VCD (defined in ECSS-E-ST-10-02 Annex B).

ECSS-E-ST-10-03_0750063

- b. Qualification testing shall be conducted on dedicated qualification models except when using protoflight approach.

ECSS-E-ST-10-03_0750064

- c. <<deleted>>

ECSS-E-ST-10-03_0750065

- d. <<deleted>>

ECSS-E-ST-10-03_0750066

- e. In case destructive tests are needed (e.g. Burst test), a representative model different from the QM shall be used or the test be performed at the end of the qualification programme.

NOTE This model can be simplified but needs to fully represent the function tested.

- f. The qualification test levels and durations shall be as specified in Table 5-2 for space segment equipment and in Table 6-2 for space segment element.

NOTE The test durations identified in Table 5-2 and Table 6-2 are the minimum values.

4.5.3 Acceptance testing

- a. Acceptance testing shall be performed to provide evidence that the space segment element or equipment performs in accordance with the specifications in the intended environments with the specified acceptance margins.

NOTE This evidence is used, further to analysis as relevant, to provide via verification reports (defined in ECSS-E-ST-10-02 Annex F) the elements for the close-out of the VCD (defined in ECSS-E-ST-10-02 Annex B).

- b. Acceptance testing shall be performed on each flight product, except the one used as Protoflight, to assure freedom from workmanship defects and flawed materials in conformance with ECSS-E-ST-10-02.

- c. The acceptance programme shall be performed, after a qualification programme has been completed (as per clause 4.5.2 or clause 4.5.4).

- d. The acceptance test levels and durations shall be as specified in Table 5-4 for space segment equipment, and in Table 6-4 for space segment element levels.

NOTE The test durations identified in Table 5-4 and Table 6-4 are the minimum values.

4.5.4 Protoflight testing

4.5.4.1 Overview

Protoflight testing is the combination of the qualification and acceptance testing objectives on the first flight model.

The protoflight approach can be applied at each level of decomposition of space system.

To minimize risk, a space segment elements protoflight approach can include test(s) on dedicated model(s), which can later be refurbished in PFM. An example of this is the development of a Structural Model for early mechanical qualification.

4.5.4.2 Requirements

ECSS-E-ST-10-03_0750072

- a. Protoflight testing shall be performed on the first flight model to provide evidence that the space segment element or equipment performs in accordance with the specifications in the intended environments with the specified qualification margins and to confirm its readiness for delivery and subsequent usage, being free from workmanship defects and flawed materials.

NOTE This evidence is used, in addition to analysis as relevant, to provide via verification reports (defined in ECSS-E-ST-10-02 Annex F) the elements for the close-out of the VCD (defined in ECSS-E-ST-10-02 Annex B).

ECSS-E-ST-10-03_0750073

- b. In case destructive tests are needed (e.g. Burst test), a representative model different from the PFM shall be used.

NOTE This model can be simplified but needs to fully represent the function tested.

ECSS-E-ST-10-03_0750074

- c. The protoflight test levels and durations shall be as specified in Table 5-6 for space segment equipment and in Table 6-6 for space segment element levels.

NOTE 1 The general approach is to select:

- test levels: as qualification levels;
- test durations: as acceptance durations.

NOTE 2 The test durations identified in Table 5-6 and Table 6-6 are the minimum values.

4.6 Retesting

4.6.1 Overview

ECSS-E-ST-10-02 identifies several situations, in which re-verification is required. However, as the scope and the nature of retesting differ so much, test requirements are defined on a case-by-case basis. Examples of cases involving retesting are described in clauses 4.6.2 to 4.6.5 below.

4.6.2 Implementation of a design modification after completion of qualification

ECSS-E-ST-10-03_0750075

- a. The configuration control board (CCB), as per ECSS-M-ST-40, shall convene to evaluate and decide the extent of the qualification sequence of tests to be repeated.

4.6.3 Storage after protoflight or acceptance testing

ECSS-E-ST-10-03_0750076

- a. The supplier shall identify the testing requirements during storage and post-storage.

NOTE These requirements can be presented in the user manual.

ECSS-E-ST-10-03_0750077

- b. Periodic tests shall be assessed and performed with a frequency accounting for:
 1. space segment equipment degradation, and
 2. specific personnel know-how maintenance.

ECSS-E-ST-10-03_0750078

- c. Storage configuration shall be agreed with the customer in particular for the deployable mechanisms.

NOTE If deployable mechanisms are stored assembled with the space segment elements, the flight tension can be reduced.

ECSS-E-ST-10-03_0750079

- d. The periodic tests during storage shall cover:
 1. overall functional test,
 2. testing of the rotating parts,
 3. power consumption measurement,
 4. TT&C space segment subsystem through tests caps (space segment element switched ON),
 5. testing of the propulsion space segment subsystem pressure through the telemetry,
 6. visual inspection of the separately stored space segment equipment in a suitable clean work area,
 7. contamination tests on the contamination probes.

NOTE Example of age sensitive space segment equipment: Travelling wave tubes (TWTs), batteries and special lubricated mechanisms valves and motors.

ECSS-E-ST-10-03_0750080

- e. Any additional test to the one listed in 4.6.3d shall be identified for customer approval.

ECSS-E-ST-10-03_0750081

- f. The storage procedure shall be submitted to the customer for approval.

ECSS-E-ST-10-03_0750453

- g. Solar array(s) should be stored in a gaseous Nitrogen environment.

NOTE This recommendation is also relevant for the solar panels integrated with the photovoltaic assembly, during any transportation phase, and during any long term storage phase after a successful solar panel DRB (Delivery Review Board).

ECSS-E-ST-10-03_0750468

- h. The electrical functional and performance test as specified in 5.5.1.11 shall be repeated at the end of the storage, for a storage period longer than 2 years, before flight.

ECSS-E-ST-10-03_0750469

- i. For final Storage periods longer than 6 months and shorter than 2 years, the electrical functional and performance test as specified in 5.5.1.11 shall be repeated, however it can be performed without the Flasher.

4.6.4 Space segment element or equipment to be re-flown

ECSS-E-ST-10-03_0750083

- a. Space segment element or equipment to be re-flown shall be re-tested before the new flight in accordance with the verification programme and acceptance criteria defined for the new mission.

ECSS-E-ST-10-03_0750084

- b. High level (system or [space segment](#) element) functional testing shall be performed in preference to individual low level tests.

NOTE Post-landing testing is performed on space products to be recovered at the end of mission and on products which are re-flown.

4.6.5 Flight use of qualification Space segment element or equipment

ECSS-E-ST-10-03_0750085

- a. Use of qualification space segment element or equipment shall not be allowed unless agreed by the customer.

ECSS-E-ST-10-03_0750086

- b. Additional testing of qualification space segment element or equipment subsequently selected for flight shall be compatible with the residual life.

NOTE This is done when the customer considers the risk acceptable.

ECSS-E-ST-10-03_0750087

- c. In case of refurbishment or disassembly the qualification space segment element or equipment shall be subjected to an acceptance re-testing to be agreed with the customer.

NOTE The **extent** of the acceptance testing depends on the item past history and on the **extent** of the modification.

5

Space segment equipment test requirements

5.1 General requirements

ECSS-E-ST-10-03_0750088

- a. The test baseline and sequencing shall be tailored to the specific space segment equipment type for each project.

NOTE The types of space segment equipment are uniformly listed at the end of Table 5-1, Table 5-3, and Table 5-5.

ECSS-E-ST-10-03_0750089

- b. Where space segment equipment falls into two or more types, the combination of all required tests specified for each type shall be applied.

NOTE For example: A star sensor can be considered to fit both “electronic space segment equipment” and “optical space segment equipment” types, therefore, an EMC test is conducted since it is applicable for electronic space segment equipment, even though there is no requirement for optical space segment equipment.

ECSS-E-ST-10-03_0750090

- c. The sequence of tests, as specified in Figure 5-1, shall be performed, taking into account tests’ applicability, as defined for qualification in Table 5-1, for acceptance in Table 5-3, for protoflight in Table 5-5.

NOTE This sequence reflects the principle “Test like you fly”. It is based on a combination of:

- the order in which the environments are encountered during flight, and
- the capability to identify defects as early as possible in the test sequence.

ECSS-E-ST-10-03_0750091

- d. Any unusual or unexpected behaviour shall be evaluated to determine the existence of any trend potentially leading to anomaly or failure situation.

ECSS-E-ST-10-03_0750092

- e. PT and FFT shall be performed at the beginning and at the end of the test programme under room conditions as defined for clean rooms.

NOTE Those tests provide the criteria for judging the integrity of the space segment equipment

thought the overall test programme. The results of both tests should be identical within the test tolerances.

ECSS-E-ST-10-03_0750093

- f. RFT shall be performed before and after each environmental test block as well as before and after transportation.

NOTE This test allows verifying the integrity of the space segment equipment.

ECSS-E-ST-10-03_0750094

- g. PT, FFT or RFT, as relevant, shall be performed:
1. during thermal test(s), or
 2. when the space segment equipment is expected to be operational under another type of imposed environment.

NOTE The test definition corresponds to the expected operation of the item when the environment is being imposed.

ECSS-E-ST-10-03_0750095

- h. Space segment equipment, if operated during ascent and descent, shall be powered and configured in the corresponding operating mode during the environmental tests and parameters monitored to detect intermittent or persistent failures during the test.

ECSS-E-ST-10-03_0750096

- i. Any space segment equipment pressurized during ascent shall be tested as specified in ECSS-E-ST-32-02 clause 5.4.4, and verified for internal pressure decay.

ECSS-E-ST-10-03_0750097

- j. Adjustable protection functions shall be tested.

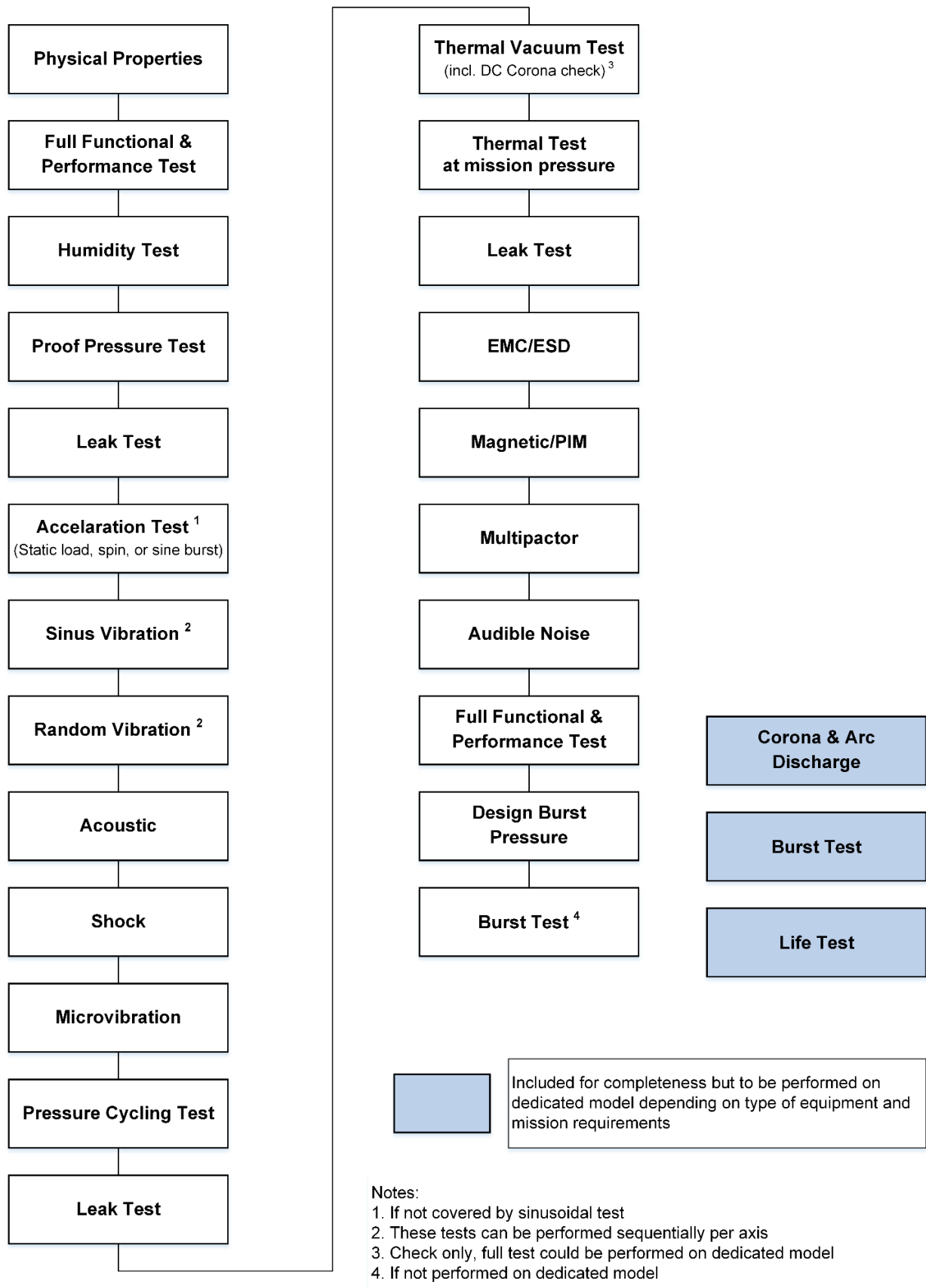


Figure 5-1: Space segment equipment sequence of tests

5.2 Qualification tests requirements

ECSS-E-ST-10-03_0750098

- a. The space segment equipment qualification test baseline shall consist of the tests specified in Table 5-1 in line with requirement 5.1b, according to the type of the space segment equipment.

Table 5-1: Space segment equipment - Qualification test baseline

ECSS-E-ST-10-03 0750441

Test	Reference clause	Ref. to Level & Duration	Applicability versus types of space segment equipment													Application notes
			a	b	c	d	e	f	g	h	i	j	k	l		
General																
Functional and performance (FFT/RFT)	5.5.1.1		R	R	R	R	R	R	R	R	R	R	R	R	R	For k (solar array), the deployment test is mandatory before and after the environmental tests (manual deployment before the environmental tests).
Humidity	5.5.1.2		X	X	X	X	X	X	X	X	X	X	X	-	X	For k (solar array) and l (solar panel), see ECSS-E-ST-20-08.
Life	5.5.1.3	See Table 5-2 No 1	X	X	R	R	X	X	R	X	X	R	-	-	-	To be performed on dedicated model. For l (solar panels), the life tests are covered by the ECSS-E-ST-20-08.
Burn-in	5.5.1.4		X	-	-	X	-	-	X	-	-	-	-	-	-	The test is performed in parallel with other functional & environmental tests.
Mechanical																
Physical properties	5.5.2.1		R	R	R	R	R	R	R	R	R	R	R	R	R	Upon agreement with customer the CoG and MoI is not measured by test but calculated.
Static load	5.5.2.2	See Table 5-2 No 2	X	X	X	X	X	X	X	X	X	X	X	X	-	One of the three types of test is performed if not covered by the sinusoidal vibration test.
Spin	5.5.2.2	See Table 5-2 No 3	X	X	X	X	X	X	X	X	X	X	X	X	-	
Sine Burst	5.5.2.2	See Table 5-2 No 4	X	X	X	X	X	X	X	X	X	X	X	X	-	
Random vibration	5.5.2.3	See Table 5-2 No 5	R	X	R	R	R	R	R	R	X	X	X	X	-	For k (solar array), the random vibration test should be added to acoustic test for fixed solar array mounted directly to the space segment element side wall (without offset bracket).
Acoustic	5.5.2.4	See Table 5-2 No 6	-	X	-	-	-	-	-	-	X	X	R	-	-	For b (antennas), i (optical), j (mechanism), random vibration or, acoustic or both tests are selected depending on the type, size and location of the space segment equipment.
Sinusoidal vibration	5.5.2.5	See Table 5-2 No 7	R	R	R	R	R	R	R	R	R	R	R	R	-	
Shock	5.5.2.6	See Table 5-2 No 8	R	X	R	R	R	X	R	X	R	R	-	-	-	If it is demonstrated that the susceptibility to shock of the space segment equipment is above the shock environment, the test needs not to be performed. For k (solar array) shock qualification is performed at components level and confirmed during the deployment test.
Micro-vibration generated environment	5.5.2.7		X	X	-	X	X	-	X	-	-	X	-	-	-	Test to be performed if the customer requires it because the equipment is expected to generate micro-vibrations that can degrade the mission.
Micro-vibration susceptibility	5.5.2.8	See Table 5-2 No 9	X	-	-	-	-	-	-	-	-	X	X	-	-	Test to be performed if the equipment functionality or performance is expected to be degraded by micro-vibrations.

Test	Reference clause	Ref. to Level & Duration	Applicability versus types of space segment equipment													Application notes
			a	b	c	d	e	f	g	h	i	j	k	l		
Structural integrity																
Leak	5.5.3.1	See Table 5-2 No 10	X	-	R	R	R	R	X	X	-	-	-	-	For a (electronic, electrical and RF equipment) these tests are mandatory only on sealed or pressurized space segment equipment.	
Proof pressure	5.5.3.2	See Table 5-2 No 11	X	-	-	R	R	R	R	-	-	-	-	-	For c (battery) proof pressure, pressure cycling and burst are performed at cell level (i.e. component level).	
Pressure cycling	5.5.3.3	See Table 5-2 No 12	X	-	-	R	R	R	R	-	-	-	-	-		
Design burst pressure	5.5.3.4	See Table 5-2 No 13	X	-	-	R	R	R	R	-	-	-	-	-	To be performed on dedicated model or at the end of the QM programme.	
Burst	5.5.3.5	See Table 5-2 No 14	X	-	-	R	R	R	R	-	-	-	-	-		
Thermal																
Thermal vacuum	5.5.4.1 & 5.5.4.2	See Table 5-2 No 15	R	X	R	R	R	X	R	R	R	R	-	R	For l (solar panels), thermal vacuum is complemented with the thermal tests performed on the DVT (Design Verification Test) coupon as described in the ECSS-E-ST-20-08.	
Thermal test at mission pressure	5.5.4.1 & 5.5.4.3	See Table 5-2 No 16	R	X	R	R	R	X	R	R	R	R	-	-	Temperature cycling test at mission pressure without temperature cycling test in vacuum is applicable only to space segment equipment that operate under a non-vacuum environment during their entire lifetime. In assessing this, depressurisation failure should be considered. Temperature cycling test at mission pressure and temperature cycling test in vacuum may be combined in sequence. Temperature cycling test at room pressure (also called "thermal cycling", by example, in US standards and in the version A of ECSS-E-ST-10-03) is not considered in this Standard.	
Electrical / RF																
EMC	5.5.5.1	See Table 5-2 No 17	R	X	X	X	X	X	X	X	X	X	X	X	For equipment without electronic test are limited to Bonding test.	
Magnetic	5.5.5.2		X	X	X	X	X	X	X	X	X	X	X	X	Magnetic test to be performed if justified by mission needs, in accordance with the EMCCP.	
ESD	5.5.5.3	See Table 5-2 No 18	R	X	X	X	X	X	X	X	X	X	X	X	For k (solar array) and l (solar panels), the ESD test is covered by the ECSS-E-ST-20-08.	
PIM	5.5.5.4	See Table 5-2 No 19	X	X	-	-	-	-	-	-	-	-	-	-		
Multipactor	5.5.5.5		X	X	-	-	-	-	-	-	-	-	-	-		
Corona and arc discharge	5.5.5.6	See Table 5-2 No 20	R	R	R	-	-	-	-	-	-	-	-	-	For condition of applicability of test, refer to 5.5.5.6.	
Mission specific																
Audible noise	5.5.6.1		R	-	-	R	R	-	R	-	-	R	-	-	Required for space segment equipment for crewed space segment element.	
Types of space segment equipment														Key		
a	Electronic, electrical and RF equipment		d	Valve		g	Thruster		j	Mechanism		R	Required			
b	Antenna		e	Fluid or propulsion equipment		h	Thermal equipment		k	Solar array		X	To be decided by the customer			
c	Battery		f	Pressure vessel		i	Optical equipment		l	Solar panel		-	Not required			

Test	Reference clause	Ref. to Level & Duration	Applicability versus types of space segment equipment											Application notes
			a	b	c	d	e	f	g	h	i	j	k	
<p>NOTE 1: Tests are categorized into "R" or "X" depending on the sensitivity of the space segment equipment type to the specific environment, the probability of encountering the environment, and project specificity.</p> <p>NOTE 2: All tests type are listed independently of their application status:</p> <ul style="list-style-type: none"> - the black shading indicates that the type of test is never required or optional - the grey shading indicates that there is no test level and duration specified in the Table 5-2 since it is not a test where an environment is applied to the item under test 														

Table 5-2: Space segment equipment - Qualification test levels and duration

ECSS-E-ST-10-03_0750442

No	Test	Levels	Duration	Number of applications	NOTES
1	Life	Expected environment and maximum operational load	For duration and cycles: For mechanisms, apply ECSS-E-ST-33-01 Table 4-3 For batteries, apply ECSS-E-ST-20	1 test	
2	Static load	KQ x Limit Load The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data (10 seconds minimum)	Worst combined load cases	Worst combined load cases are determined by analysis
3	Spin	\sqrt{KQ} x spin rate The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As specified by the project	1 test	
4	Sine Burst	KQ x Limit Load The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	As specified	
5	Random vibration	Maximum expected spectrum +3 dB on PSD values If margins higher than 3 dB are specified by the Launcher Authority, they apply.	2 minutes	On each of 3 orthogonal axes	
6	Acoustic	Maximum expected acoustic spectrum +3 dB If margins higher than 3 dB are specified by the Launcher Authority, they apply	2 minutes	1 test	
7	Sinusoidal vibration	KQ x Limit Load Spectrum The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	sweep at 2 Oct/min, 5 Hz - 140 Hz	On each of 3 orthogonal axes	

No	Test	Levels	Duration	Number of applications	NOTES
8	Shock	<p>Maximum expected shock spectrum +3 dB qualification margin</p> <p>(See note 1)</p>	<p>Duration representative of the expected environment</p> <p>(See note 2)</p>	<p>The number of shock application covering the complete life cycle of the FM H/W in all 3 orthogonal axes.</p> <p>(See note 3)</p>	<p>NOTE 1: Qualification programme test of space segment elements can include a test where the shock generative device is activated. This test is performed with no margins to consolidate the shock specification of the space segment equipment.</p> <p>NOTE 2: Typical duration is between 20ms and 30ms.</p> <p>NOTE 3: The number of applications can effectively take two values: 1, in case the space segment equipment will only be exposed to the flight shock event; or 3, in case the space segment equipment will also be exposed to a qualifying shock test at space segment element level (including a provision for an additional retest should then be considered).</p>
9	Microvibration susceptibility	<p>Specified environment (maximum predicted environment at space segment element level plus margin)</p>	<p>As needed for susceptibility determination</p>	<p>As specified by the project.</p>	

No	Test	Levels	Duration	Number of applications	NOTES
10	Leak	MDP	pressure maintained for 30 minutes as minimum	In conformance with Figure 5-1.	
11	Proof pressure	$j_{\text{proof}} \times \text{MDP}$ For the proof factor (j_{proof}), apply ECSS-E-ST-32-02 Tables 4-1 to 4-9.	5 minutes minimum hold time	The number of pressure application covering the complete life cycle of the FM HW.	
12	Pressure cycling	MDP	See ECSS-E-ST-32-02, clause 5.4.5	1 test	The MDP level can be exceeded. See ECSS-E-ST-32-02, clause 5.4.5
13	Design burst pressure	$j_{\text{burst}} \times \text{MDP}$ For the burst factor (j_{burst}), apply ECSS-E-ST-32-02 Tables 4-1 to 4-9.	30 seconds as minimum	1 test	
14	Burst	Pressure increased until burst occurs	Until burst occurs	1 test	On dedicated model or on QM (if performed on QM, this destructive test will be the last test to be done)

No	Test	Levels	Duration	Number of applications	NOTES
15	Thermal vacuum	$T_{\max}^Q \Big _{Op/NOp} = T_{\max}^A \Big _{Op/NOp} + 5^{\circ} C$ $T_{\min}^Q \Big _{Op/NOp} = T_{\min}^A \Big _{Op/NOp} - 5^{\circ} C$ <p>Lower qualification margin than +/-5 °C may be used for temperature below -170 °C.</p> <p>Higher qualification margin than +/- 5 °C may be used for temperature above 120 °C.</p>	8 temperature cycles or 1 or more temperature cycles if combined with temperature cycles at mission pressure (See note 1&2) For solar panels, 10 cycles with plateau equal or greater than 2 hours in the hot and cold extremes	1 test	Note 1: Vacuum temperature cycling test and mission pressure temperature cycling test are both performed for space segment equipment that operate under a non-vacuum environment after having been exposed to vacuum. Note 2: Number of temperature cycles and operating condition under vacuum and under mission pressure are selected based on mission profile.
16	Thermal test at mission pressure (see note 1 & 2)	$T_{\max}^Q \Big _{Op/NOp} = T_{\max}^A \Big _{Op/NOp} + 5^{\circ} C$ $T_{\min}^Q \Big _{Op/NOp} = T_{\min}^A \Big _{Op/NOp} - 5^{\circ} C$ <p>Lower qualification margin than +/-5 °C may be used for temperature below -170 °C.</p> <p>Higher qualification margin than +/-5 °C may be used for temperature above 120 °C.</p>	8 temperature cycles or 8 temperature cycles minus the number of temperature cycles performed during the thermal vacuum	1 test	Note 1: Example of mission are Mars or Venus missions. Note 2: Temperature cycling test at mission pressure without temperature cycling test in vacuum is applicable only to space segment equipment that operate under a non-vacuum environment during their entire lifetime. In assessing this, depressurisation failure should be considered.

No	Test	Levels	Duration	Number of applications	NOTES
17	EMC	See ECSS-E-ST-20-07 clause 5.4	See ECSS-E-ST-20-07 Clause 5.4	1 test	
18	ESD	See ECSS-E-ST-20-06 See ECSS-E-ST-20-07 clause 5.2.1. for ESD test See ECSS-E-ST-20-08 for the solar array and solar panels	See ECSS-E-ST-20-06 See ECSS-E-ST-20-07 clause 5.2.1. for ESD test See ECSS-E-ST-20-08 for the solar array and solar panels	1 test	
19	Passive Intermodulation	See ECSS-E-ST-20 clause 7.4		See ECSS-E-ST-20 clause 7.4	
20	Corona and arc discharge	Maximum operational voltage and maximum RF output power for RF equipment sweep over the critical pressure range over 10 hPa to 0, 1 hPa	10 to 15 minutes	1 test	For a given frequency, minimum gap within the space segment equipment, and given pressure a Paschen curve is defined. This curve has a minimum of power within the pressure range.

NOTE: The table does not include tests for some **room** conditions such as humidity and toxic-off gassing because they are performed exposing the hardware to the environment without margin.

5.3 Acceptance test requirements

ECSS-E-ST-10-03_0750099

- a. The space segment equipment acceptance test baseline shall consist of the tests specified in Table 5-3 in line with requirement 5.1b, according to the type of the space segment equipment.

Table 5-3: Space segment equipment - Acceptance test baseline

ECSS-E-ST-10-03 0750443

Test	Reference clause	Ref. to Level & Duration	Applicability versus types of space segment equipment												Application notes
			a	b	c	d	e	f	g	h	i	j	k	l	
General															
Functional and performance (FFT/RFT)	5.5.1.1		R	R	R	R	R	R	R	R	R	R	R	R	For k (solar array), the deployment test is mandatory before and after the environmental tests (manual deployment before the environmental tests).
Humidity			-	-	-	-	-	-	-	-	-	-	-	-	
Life			-	-	-	-	-	-	-	-	-	-	-	-	
Burn-in	5.5.1.4		X	-	-	X	-	-	X	-	-	-	-	-	To be performed, if the total duration of the acceptance sequence of tests is insufficient to detect material and workmanship defect occurring in the space segment equipment lifetime.
Mechanical															
Physical properties	5.5.2.1		R	R	R	R	R	R	R	R	R	R	R	R	Upon agreement with customer the CoG and MoI is not measured by test. but calculated.
Static load			-	-	-	-	-	X	-	-	-	-	-	-	General structural proof test is performed on pressure vessel if no covered by higher level test (e.g. sinusoidal with full tanks).
Spin			-	-	-	-	-	-	-	-	-	-	-	-	
Sine Burst			-	-	-	-	-	-	-	-	-	-	-	-	
Random vibration	5.5.2.3	See Table 5-4 No 1	R	X	R	R	R	R	R	R	X	X	X	-	For k (solar array), the random vibration test should be added to acoustic test for fixed solar array mounted directly to the space segment element side wall (without offset bracket).
Acoustic	5.5.2.4	See Table 5-4 No 2	-	X	-	-	-	-	-	-	X	X	R	-	For b (antennas), i (optical), j (mechanism), random vibration or acoustic test is selected depending on the type, size and location of the space segment equipment. For k (solar array), acoustic acceptance testing of recurrent FMs (from the second FM) can be omitted on condition that they are subjected to acceptance testing at space segment element level.
Sinusoidal vibration	5.5.2.5	See Table 5-4 No 3	-	-	-	-	-	-	-	-	-	-	R	-	For k (solar array), sinusoidal vibration acceptance testing of recurrent FMs (from the second FM) can be omitted on condition that they are subjected to acceptance testing at space segment element level, or in case of significant flight heritage on design, processes and manufacturers.
Shock			-	-	-	-	-	-	-	-	-	-	-	-	
Micro-vibration generated environment	5.5.2.7		X	X	-	X	X	-	X	-	-	X	-	-	Test to be performed if the customer requires it because the equipment is expected to generate micro-vibrations that can degrade the mission.
Micro-vibration suscep.	5.5.2.8	See Table 5-4 No 4	X	-	-	-	-	-	-	-	X	X	-	-	Test to be performed if the equipment functionality or performance is expected to be degraded by micro-vibrations.

Test	Reference clause	Ref. to Level & Duration	Applicability versus types of space segment equipment											Application notes			
			a	b	c	d	e	f	g	h	i	j	k		l		
Structural integrity																	
Leak	5.5.3.1	See Table 5-4 No 5	X	-	R	R	R	R	X	-	-	-	-	-	For a (electronic, electrical and RF equipment) required only on sealed or pressurized space segment equipment. For c (battery) proof pressure, is performed at cell level (i.e. component level).		
Proof pressure	5.5.3.2	See Table 5-4 No 6	-	-	-	R	R	R	X	-	-	-	-	-			
Pressure cycling			-	-	-	-	-	-	-	-	-	-	-	-			
Design burst pressure			-	-	-	-	-	-	-	-	-	-	-	-			
Burst			-	-	-	-	-	-	-	-	-	-	-	-			
Thermal																	
Thermal vacuum	5.5.4.1 & 5.5.4.2	See Table 5-4 No 7	R	X	R	R	R	X	R	R	R	R	-	R			
Thermal test at mission pressure	5.5.4.1 & 5.5.4.3	See Table 5-4 No 8	R	X	R	R	R	X	R	R	R	R	-	-	Temperature cycling test at mission pressure without temperature cycling test in vacuum is applicable only to space segment equipment that operate under a non-vacuum environment during their entire lifetime. In assessing this, depressurisation failure should be considered. Temperature cycling test at mission pressure and temperature cycling test in vacuum may be combined. Test not required for batteries that cannot be recharged after testing. Temperature cycling test at room pressure (also called "thermal cycling", by example, in US standards and in the version A of ECSS-E-ST-10-03) is not considered in this Standard.		
Electrical / RF																	
EMC	5.5.5.1	See Table 5-4 No 9	R	X	X	X	X	X	X	X	X	X	X	X	For equipment without electronic test are limited to bonding test.		
Magnetic	5.5.5.2		X	X	X	X	X	X	X	X	X	X	-	X	Magnetic test to be performed if justified by mission needs, in accordance with the EMCCP.		
ESD			-	-	-	-	-	-	-	-	-	-	-	-			
PIM	5.5.5.4	See Table 5-4 No 10	X	X	-	-	-	-	X	-	X	-	-	-			
Multipactor	5.5.5.5		X	X	-	-	-	-	-	-	-	-	-	-	May be performed on the FM or on a batch of RF components		
Corona and arc discharge	5.5.5.6	See Table 5-4 No 11	R	R	R	-	-	-	-	-	-	-	-	-	For condition of applicability of test, refer to 5.5.5.6.		
Mission specific																	
Audible noise	5.5.6.1		R	R	-	R	R	-	R	-	-	R	-	-	Required for space segment equipment for crewed space segment element.		
Types of space segment equipment													Key				
a	Electronic, electrical and RF equipment				d	Valve				g	Thruster				j	Mechanism	
b	Antenna				e	Fluid or propulsion equipment				h	Thermal equipment				k	Solar array	
c	Battery				f	Pressure vessel				i	Optical equipment				l	Solar panel	
													R	Required			
													X	To be decided by the customer			
													-	Not required			

Test	Reference clause	Ref. to Level & Duration	Applicability versus types of space segment equipment											Application notes
			a	b	c	d	e	f	g	h	i	j	k	
<p>NOTE 1: Tests are categorized into “R” or “X” depending on the sensitivity of the space segment equipment type to the specific environment, the probability of encountering the environment, and project specificity.</p> <p>NOTE 2: All tests type are listed independently of their application status:</p> <ul style="list-style-type: none"> - the black shading indicates that the type of test is never required or optional - the grey shading indicates that there is no test level and duration specified in the Table 5-4 since it is not a test where an environment is applied to the item under test 														

Table 5-4: Space segment equipment - Acceptance test levels and duration

ECSS-E-ST-10-03 0750444

No	Test	Levels	Duration	Number of applications	NOTES
1	Random vibration	Maximum expected spectrum +0dB on PSD values	1 minute	On each of 3 orthogonal axes	
2	Acoustic	Maximum expected acoustic spectrum +0dB	1 minute	1 test	
3	Sinusoidal vibration	KA x Limit Load Spectrum The acceptance factor KA is given in ECSS-E-ST-32-10 clause 4.3.1	Sweep at 4 Oct/min, 5 Hz - 140 Hz	On each of 3 orthogonal axes	
4	Microvibration susceptibility	Specified environment (maximum predicted environment at space segment element level plus margin)	As needed for susceptibility determination	As specified by the project.	
5	Leak	MDP	Pressure maintained for 30 minutes as minimum	In conformance with Figure 5-1.	
6	Proof pressure	$j_{proof} \times MDP$ For the proof factor (j_{proof}), apply ECSS-E-ST-32-02 Tables 4-1 to 4-9.	5 minutes minimum hold time	1	
7	Thermal vacuum	$T_{max}^A \Big _{Op/NOp} = T_{max}^D \Big _{Op/NOp} + 5^{\circ} C$ $T_{min}^A \Big _{Op/NOp} = T_{min}^D \Big _{Op/NOp} - 5^{\circ} C$ <p>Lower acceptance margin than +/-5 °C, may be used for temperature below -170 °C. Higher acceptance margin than +/-5 °C may be used for temperature above 120 °C.</p>	4 temperature cycles or 1 or more temperature cycles if combined with temperature cycles at mission pressure (See note 1 & 2)	1 test	<p>Note 1: Vacuum temperature cycling test and mission pressure temperature cycling test are both performed for space segment equipment that operate under a non-vacuum environment after having been exposed to vacuum.</p> <p>Note 2: Number of temperature cycles and operating condition under vacuum and under mission</p>

No	Test	Levels	Duration	Number of applications	NOTES
			<p>For solar panels, 5 cycles with plateau equal or greater than 1 hour in the hot and cold extremes. (See note 3)</p>		<p>pressure are selected based on mission profile.</p> <p>Note 3: The number of temperature cycles is modified on the following cases:</p> <ol style="list-style-type: none"> 1. In case the solar panel design or manufacturing process or manufacturer does not have flight heritage, 10 cycles with plateau equal or greater than 1 hour in the hot and cold extremes are performed. 2. In case the solar panel qualification is performed on one panel only, 10 cycles are performed as acceptance test with plateau equal or greater than 1 hour in the hot and cold extremes on a second panel. 3. In case of significant flight heritage on design, processes and manufacturers it can be reduced to 3 cycles with plateau equal or greater than 30 minutes in the hot and cold extremes. 4. After the fifth recurrent panel accepted, the number of cycles shall remain 5 with a plateau of 30 minutes in the hot and cold extremes.

No	Test	Levels	Duration	Number of applications	NOTES
8	Thermal test at mission pressure (see note 1 & 2)	$T_{\max}^A \Big _{Op/NOp} = T_{\max}^D \Big _{Op/NOp} + 5^\circ C$ $T_{\min}^A \Big _{Op/NOp} = T_{\min}^D \Big _{Op/NOp} - 5^\circ C$ <p>Lower acceptance margin than +/-5 °C may be used for temperature below -170 °C. Higher acceptance margin than +/-5 °C may be used for temperature above 120 °C. (See note 1).</p>	4 temperature cycles (See Note 2) or 4 temperature cycles minus the number of temperature cycles performed during the thermal vacuum test	1 test	Note 1: Example of mission are Mars or Venus missions Note 2: Temperature cycling test at mission pressure without temperature cycling test in vacuum is applicable only to space segment equipment that operate under a non-vacuum environment during their entire lifetime. In assessing this, depressurisation failure should be considered.
9	EMC	Apply ECSS-E-ST-20-07 clause 5.4	Apply ECSS-E-ST-20-07 Clause 5.4	1 test	
10	Passive intermodulation	For equipment see ECSS-E-ST-20 clause 7.4		See ECSS-E-ST-20 clause 7.4	
11	Corona and Arc discharge	Maximum operational voltage and maximum RF output power for RF equipment Sweep over the critical pressure range over 10 hPa to 0,1 hPa	10 to 15 minutes	1 test	For a given frequency, minimum gap within the space segment equipment, and given pressure a Paschen curve is defined. This curve has a minimum of power within the pressure range.
NOTE: The table does not include tests for some room conditions such as humidity and toxic-off gassing because they are performed exposing the hardware to the environment without margin.					

5.4 Protoflight test requirements

ECSS-E-ST-10-03_0750100

- a. The space segment equipment Protoflight test baseline shall consist of the tests specified in Table 5-5 in line with requirement 5.1b, according to the type of the space segment equipment.

ECSS-E-ST-10-03_0750101

- b. The following qualification tests shall be performed on a dedicated model and never on the Protoflight Model:
 - 1. life test
 - 2. burst pressure test,
 - 3. ESD.

Table 5-5: Space segment equipment - Protoflight test baseline

ECSS-E-ST-10-03 0750445

Test	Reference clause	Ref. to Level & Duration	Applicability versus types of space segment equipment											Application notes	
			a	b	c	d	e	f	g	h	i	j	k		l
General															
Functional and performance (FFT/RFT)	5.5.1.1		R	R	R	R	R	R	R	R	R	R	R	R	For k (solar array), the deployment test is mandatory before and after the environmental tests (manual deployment before the environmental tests).
Humidity	5.5.1.2		X	X	X	X	X	X	X	X	X	X	-	X	For k (solar array) and l (solar panel), see ECSS-E-ST-20-08.
Life	5.5.1.3	See Table 5-6 No 1	X	X	R	R	X	X	R	X	X	R	-	-	To be performed on dedicated model. For l (solar panels), the life tests are covered by the ECSS-E-ST-20-08.
Burn-in	5.5.1.4		X	-	-	X	-	-	X	-	-	-	-	-	The test is performed in parallel with other functional & environmental tests.
Mechanical															
Physical properties	5.5.2.1		R	R	R	R	R	R	R	R	R	R	R	R	Upon agreement with customer the CoG and MoI is not measured by test. but calculated.
Static load			-	-	-	-	-	-	-	-	-	-	-	-	
Spin	5.5.2.2	See Table 5-6 No 2	X	X	X	X	X	X	X	X	X	X	X	-	One of the two types of test is performed if not covered by the sinusoidal vibration test.
Sine Burst	5.5.2.2	See Table 5-6 No 3	X	X	X	X	X	X	X	X	X	X	X	-	
Random vibration	5.5.2.3	See Table 5-6 No 4	R	X	R	R	R	R	R	R	X	X	X	-	For k (solar array), the random vibration test should be added to acoustic test for fixed solar array mounted directly to the space segment element side wall (without offset bracket).
Acoustic	5.5.2.4	See Table 5-6 No 5	-	X	-	-	-	-	-	-	X	X	R	-	For b (antennas), i (optical), j (mechanism), random vibration or acoustic or both tests are selected depending on the type, size and location of the space segment equipment.
Sinusoidal vibration	5.5.2.5	See Table 5-6 No 6	R	R	R	R	R	R	R	R	R	R	R	-	
Shock	5.5.2.6	See Table 5-6 No 7	R	X	R	R	R	X	R	X	R	R	-	-	If it is demonstrated that the susceptibility to shock of the space segment equipment is above the shock environment, the test needs not to be performed. For k (solar array) shock qualification is performed at components level and confirmed during the deployment test.
Micro-vibration generated environment	5.5.2.7		X	X	-	X	X	-	X	-	-	X	-	-	Test to be performed if the customer requires it because the equipment is expected to generate micro-vibrations that can degrade the mission.
Micro-vibration susceptibility	5.5.2.8	See Table 5-6 No 8	X	-	-	-	-	-	-	-	X	X	-	-	Test to be performed if the equipment functionality or performance is expected to be degraded by micro-vibrations.

Test	Reference clause	Ref. to Level & Duration	Applicability versus types of space segment equipment											Application notes	
			a	b	c	d	e	f	g	h	i	j	k		l
Structural integrity															
Leak	5.5.3.1	See Table 5-6 No 9	X	-	R	R	R	R	X	X	-	-	-	-	For a (electronic, electrical and RF equipment) these tests are mandatory only on sealed or pressurized space segment equipment. For battery Proof pressure, is performed at cell level (i.e. component level).
Proof pressure	5.5.3.2	See Table 5-6 No 10	X	-	-	R	R	R	R	-	-	-	-		
Pressure cycling			-	-	-	-	-	-	-	-	-	-	-		
Design burst pressure			-	-	-	-	-	-	-	-	-	-	-		
Burst			-	-	-	-	-	-	-	-	-	-	-		
Thermal															
Thermal vacuum	5.5.4.1 & 5.5.4.2	See Table 5-6 No 11	R	X	R	R	R	X	R	R	R	R	-	R	For l (solar panels), thermal vacuum is complemented with the thermal tests performed on the DVT (Design Verification Test) coupon as described in the ECSS-E-ST-20-08.
Thermal test at mission pressure	5.5.4.1 & 5.5.4.3	See Table 5-6 No 12	R	X	R	R	R	X	R	R	R	R	-	-	Temperature cycling test at mission pressure without temperature cycling test in vacuum is applicable only to space segment equipment that operate under a non-vacuum environment during their entire lifetime. In assessing this, depressurisation failure should be considered. Temperature cycling test at mission pressure and temperature cycling test in vacuum may be combined. Temperature cycling test at room pressure (also called "thermal cycling", by example, in US standards and in the version A of ECSS-E-ST-10-03) is not considered in this Standard
Electrical / RF															
EMC	5.5.5.1	See Table 5-6 No 13	R	X	X	X	X	X	X	X	X	X	X	X	For equipment without electronic test are limited to bonding test.
Magnetic	5.5.5.2		X	X	X	X	X	X	X	X	X	X	X	X	Magnetic test to be performed if justified by mission needs, in accordance with the EMCCP.
ESD	5.5.5.3	See Table 5-6 No 14	R	X	X	X	X	X	X	X	X	X	X	X	To be performed on dedicated model. For k (solar array) and l (solar panels), the ESD test is covered by the ECSS-E-ST-20-08.
PIM	5.5.5.4	See Table 5-6 No 15	X	X	-	-	-	-	-	-	-	-	-	-	
Multipactor	5.5.5.5		X	X	-	-	-	-	-	-	-	-	-	-	May be performed on the PFM or on a batch of RF components
Corona and arc discharge	5.5.5.6	See Table 5-6 No 16	R	R	R	-	-	-	-	-	-	-	-	-	To be performed on dedicated model. For condition of applicability of test, refer to 5.5.5.6.
Mission specific															
Audible noise	5.5.6.1		R	-	-	R	R	-	R	-	-	R	-	-	Required for space segment equipment for crewed space segment element.

Test	Reference clause	Ref. to Level & Duration	Applicability versus types of space segment equipment											Application notes	
			a	b	c	d	e	f	g	h	i	j	k	l	
Types of space segment equipment													Key		
a Electronic, electrical and RF equipment	d Valve	g Thruster	j Mechanism	R Required											
b Antenna	e Fluid or propulsion equipment	h Thermal equipment	k Solar array	X To be decided by the customer											
c Battery	f Pressure vessel	i Optical equipment	l Solar panel	- Not required											
NOTE 1: Tests are categorized into "R" or "X" depending on the sensitivity of the space segment equipment type to the specific environment, the probability of encountering the environment, and project specificity.															
NOTE 2: All tests type are listed independently of their application status: - the black shading indicates that the type of test is never required or optional - the grey shading indicates that there is no test level and duration specified in the Table 5-6 since it is not a test where an environment is applied to the item under test															

Table 5-6: Space segment equipment - Protoflight test levels and duration

ECSS-E-ST-10-03_0750446

No	Test	Levels	Duration	Number of applications	NOTES
1	Life	Expected environment and maximum operational load	For duration and cycles: For mechanisms, apply ECSS-E-ST-33-01 Table 4-3. For batteries, apply ECSS-E-ST-20	1 test	
2	Spin	\sqrt{KQ} x spin rate The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	On each of 3 orthogonal axes	
3	Sine Burst	KQ x Limit Load The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	As specified	
4	Random vibration	Maximum expected spectrum +3 dB on PSD values If margins higher than 3 dB are specified by the Launcher Authority, they apply.	1 minute	On each of 3 orthogonal axes	
5	Acoustic	Maximum expected acoustic spectrum +3 dB If margins higher than 3 dB are specified by the Launcher Authority, they apply	1 minute	1 test	
6	Sinusoidal vibration	KQ x Limit Load Spectrum The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	sweep at 4 Oct/min, 5 Hz – 140 Hz	On each of 3 orthogonal axes	

No	Test	Levels	Duration	Number of applications	NOTES
7	Shock	Maximum expected shock spectrum +3 dB margin (See note 1)	As specified by the project. (See note 2)	1 test	NOTE 1: Qualification programme test of space segment elements can include a test where the shock generative device is activated. This test is performed with no margins to consolidate the shock specification of the space segment equipment. NOTE 2: Typical duration is between 20ms and 30ms.
8	Microvibration susceptibility	Specified environment (maximum predicted environment at space segment element level plus margin)	As needed for susceptibility determination	As specified by the project.	
9	Leak	MDP	Pressure maintained for 30 minutes as minimum	In conformance with Figure 5-1.	
10	Proof pressure	$j_{proof} \times MDP$ For the proof factor (j_{proof}), apply ECSS-E-ST-32-02 Tables 4-1 to 4-9.	5 minutes minimum hold time	1 test	

No	Test	Levels	Duration	Number of applications	NOTES
11	Thermal vacuum	$T_{\max}^Q \Big _{Op/NOp} = T_{\max}^A \Big _{Op/NOp} + 5^{\circ}C$ $T_{\min}^Q \Big _{Op/NOp} = T_{\min}^A \Big _{Op/NOp} - 5^{\circ}C$ <p>Lower qualification margin than +/-5C may be used for temperature below -170 °C.</p> <p>Higher qualification margin than +/-5 °C may be used for temperature above 120 °C.</p>	4 temperature cycles or 1 or more temperature cycles if combined with temperature cycles at mission pressure (See note 1 & 2) For solar panels, 10 cycles with plateau equal or greater than 2 hours in the hot and cold extremes.	1 test	Note 1: Vacuum temperature cycling test and mission pressure temperature cycling test are both performed for space segment equipment that operate under a non-vacuum environment after having been exposed to vacuum Note 2: Number of temperature cycles and operating conditions under vacuum and under mission pressure are selected based on mission profile.
12	Thermal test at mission pressure (see note 1 & 2)	$T_{\max}^Q \Big _{Op/NOp} = T_{\max}^A \Big _{Op/NOp} + 5^{\circ}C$ $T_{\min}^Q \Big _{Op/NOp} = T_{\min}^A \Big _{Op/NOp} - 5^{\circ}C$ <p>Lower qualification margin than +/-5 °C may be used for temperature below -170 °C.</p> <p>Higher qualification margin than +/-5 °C may be used for temperature above 120 °C.</p>	4 temperature cycles or 4 temperature cycles minus the number of temperature cycles performed during the thermal vacuum	1 test	Note 1: Examples of mission are Mars or Venus missions Note 2: Temperature cycling test at mission pressure without temperature cycling test in vacuum is applicable only to space segment equipment that operate under a non-vacuum environment during their entire lifetime. In assessing this, depressurisation failure should be considered.

No	Test	Levels	Duration	Number of applications	NOTES
13	EMC	See ECSS-E-ST-20-07 clause 5.4	See ECSS-E-ST-20-07 clause 5.4	1 test	
14	ESD	See ECSS-E-ST-20-06 See ECSS-E-ST-20-07 clause 5.2.1. for ESD test See ECSS-E-ST-20-08 for the solar array and solar panels	See ECSS-E-ST-20-06 See ECSS-E-ST-20-07 clause 5.2.1. for ESD test See ECSS-E-ST-20-08 for the solar array and solar panels	1 test	
15	Passive Intermodulation	See ECSS-E-ST-20 clause 7.4		See ECSS-E-ST-20 clause 7.4	
16	Corona and arc discharge	Maximum operational voltage and maximum RF output power for RF equipment sweep over the critical pressure range over 10 hPa to 0,1 hPa	10 to 15 minutes	1 test	For a given frequency, minimum gap within the space segment equipment, and given pressure a Paschen curve is defined. This curve has a minimum of power within the pressure range.
NOTE: The table does not include tests for some room conditions such as humidity and toxic-off gassing because they are performed exposing the hardware to the environment without margin.					

5.5 Space segment equipment test programme implementation requirements

5.5.1 General tests

5.5.1.1 Functional and performance tests

ECSS-E-ST-10-03_0750102

- a. Functional tests shall verify the complete function of the space segment equipment, under the specified operating and environment conditions and in all operational modes.

ECSS-E-ST-10-03_0750103

- b. Performance tests shall verify that the space segment equipment performances, under the specified environment, are compliant with the performances specification.

ECSS-E-ST-10-03_0750454

- c. Functional and performance test may be combined as single test depending on their complexity and time duration.

NOTE In this case the test is called functional and performance test.

ECSS-E-ST-10-03_0750105

- d. In case of internal redundancy, functional tests shall be performed on both chains taking into account the type of redundancy (e.g. hot or cold).

ECSS-E-ST-10-03_0750106

- e. In case of cross-strapped configurations, requirements for testing shall be agreed with the customer.

ECSS-E-ST-10-03_0750107

- f. Test parameters shall be varied throughout their specification ranges and the sequences expected in flight operation.

ECSS-E-ST-10-03_0750108

- g. Electrical tests shall include application of expected voltages, impedance, frequencies, pulses, and wave forms at the electrical interface of the space segment equipment, including all redundant circuits if any.

NOTE For antennas the electrical interface is understood to include the far field radiation pattern.

ECSS-E-ST-10-03_0750109

- h. Electrical test shall include the measurement of the electrical properties at the interfaces as specified in the ICD.

NOTE For example, power consumption, inrush current, signal characteristics, response time, expected voltages, impedances frequencies, pulses and waves forms characteristic at the interfaces, including redundant circuits if any.

ECSS-E-ST-10-03_0750110

- i. Fault voltage tolerance of interface circuit shall be tested to ensure absence of failure propagation risks.

ECSS-E-ST-10-03_0750111

- j. When accessible, protection functions shall be tested.

NOTE Example of protection function are over-voltage, and over-current.

ECSS-E-ST-10-03_0750112

- k. When protection function have the capability to be overwritten, the overwrite function shall be tested.

ECSS-E-ST-10-03_0750113

- l. For the solar panels and solar array, the electrical functional and performance tests shall include flasher test, Electroluminescence/Photoluminescence, bypass, blocking diodes and EEE parts electrical health check, insulation, continuity and visual inspection; with the test definition and conditions of the electrical health checks specified in clause 5.5.3 of ECSS-E-ST-20-08, except for:

1. insulation resistance where the test is applied to sections and not to individual strings
2. insulation test is not be performed between temperature sensor and sections.
3. blocking diode test is required at panel level and recommended at solar array level and space segment element level.

NOTE 1 The electrical functional and performance tests as listed above can be replaced by a validated alternative method to be agreed by the customer.

NOTE 2 For the solar array (i.e. at solar array level and space segment element level), the flasher test can be replaced by a combination of detailed measurements of transfer harness resistance, detailed checks of the continuity of the circuits, plus a detailed assessment of the electroluminescence/photoluminescence results.

ECSS-E-ST-10-03_0750114

- m. Functional tests of mechanisms and actuators shall include application of torque, load and motion as specified.

ECSS-E-ST-10-03_0750115

- n. When relevant, internal alignment shall be verified as part of the functional test.

5.5.1.2 Humidity test

ECSS-E-ST-10-03_0750116

- a. If the space segment equipment can be exposed to humidity level above 65 % during its life time then a humidity qualification test shall be performed.

NOTE More information on humidity effects can be found in ECSS-Q-ST-70-01.

ECSS-E-ST-10-03_0750117

- b. For qualification humidity test the space segment equipment shall be installed in the chamber and tested in accordance with the following processes and steps:

1. Pretest conditions. Keep the chamber temperature at room conditions with uncontrolled humidity.
2. Cycle 1. Perform the following process:
 - (a) Increase the temperature to +35 °C over a one hour period.
 - (b) Increase the humidity to not less than 95 % over a one hour period with the temperature maintained at +35 °C.
 - (c) Hold the conditions 5.5.1.2b.2(a) and 5.5.1.2b.2(b) for two hours.
 - (d) Reduced the temperature to +2 °C over a two hour period with the relative humidity stabilized at not less than 95 %.
 - (e) Hold conditions 5.5.1.2b.2(d) for two hours.
3. Cycle 2. Repeat the foregoing cycle but increase the temperature from +2 C to +35 °C over a two hour period (moisture is not added to the chamber until +35 °C is reached).
4. Cycle 3. Perform the following process:
 - (a) Increase the chamber temperature to +35 °C over a two hour period without adding any moisture to the chamber.
 - (b) Dry the test component with air at room temperature and 50 % maximum relative humidity by blowing air through the chamber for six hours.
 - (c) Set the volume of air used per minute equal to one to three times the test chamber volume.

NOTE A suitable container can be used in place of the test chamber for drying the test component.

5. Cycle 4. Perform the following process:
 - (a) Place the space segment equipment in the test chamber and increase the temperature to +35 °C.
 - (b) Increase the relative humidity to 90 % over a one hour period.
 - (c) Maintain conditions 5.5.1.2b.5(a) and 5.5.1.2b.5(b) for at least one hour.
 - (d) Reduce the temperature to +2 °C over a one hour period with the relative humidity stabilized at 90 %.
 - (e) Maintain conditions 5.5.1.2b.5(d) for at least one hour.
 - (f) Follow the drying cycle (Cycle 3).

6. Check the space segment equipment prior to the test and at the end of Cycle 3 (within 2 h after the drying) and visually inspect for deterioration or damage.
7. Test the space segment equipment functionally during the Cycle 4 period of stability (i.e. following the 1 h-period after reaching +35 °C and 90 % relative humidity conditions).
8. Inspect the space segment equipment visually for deterioration or damage after removal from the chamber.

5.5.1.3 Life test

ECSS-E-ST-10-03_0750118

- a. The life test for space segment equipment qualification shall be designed to demonstrate the ability of the space segment equipment to withstand the maximum operating time and the maximum number of predicted operational cycles during the “product lifetime” by providing the required performance at the end of life.

NOTE This test is performed on life-limited space segment equipment or part of it.

ECSS-E-ST-10-03_0750119

- b. The space segment equipment shall be set up to operate under the environmental conditions expected during actual operation.

NOTE Environments include e.g. [ground conditions](#), [temperature conditions](#), [mission pressure or space](#), [vacuum conditions](#), and various combinations of these.

ECSS-E-ST-10-03_0750120

- c. If the launch impacts the lifetime, test simulating the launch constraints shall be performed prior the lifetime test to ensure proper mechanical setting.

NOTE Examples of launch constraints are vibration, shock.

ECSS-E-ST-10-03_0750121

- d. The space segment equipment shall be either selected at random from production lot or be the qualification space segment equipment.

ECSS-E-ST-10-03_0750122

- e. The demonstration of the lifetime shall be performed in the expected environment, using the sum of the predicted nominal ground cycle and the in-orbit-cycle plus the qualification margins.

NOTE 1 For space segment equipment having a relatively low percentage duty cycle, it can be acceptable to compress the operational duty cycle to reduce the total test duration.

NOTE 2 For space segment equipment that operate continuously in orbit, or at very high duty cycles, accelerated test techniques can be employed

pending demonstration that this leads to realistic results and approval by the customer.

ECSS-E-ST-10-03_0750123

- f. Performances shall be monitored continuously or at regular intervals.

ECSS-E-ST-10-03_0750124

- g. All the components of an actuation chain shall be submitted to the same number of actuations.

NOTE Examples of such components are motors, bearing, and gears.

5.5.1.4 Burn-in test

ECSS-E-ST-10-03_0750125

- a. The total operating time and temperature for electrical space segment equipment burn-in, shall be agreed with the customer.

NOTE 1 Those parameters depend on the type of space segment equipment and of the level of test performed at components / subassembly level.

NOTE 2 The time of operation in thermal testing is part of the burn in time.

5.5.2 Mechanical tests

5.5.2.1 Physical properties measurements

ECSS-E-ST-10-03_0750126

- a. The following physical properties of space segment equipment shall be determined using tools and techniques that conform to the [maximum allowable uncertainty](#):

1. Dimensions and [structural](#) interfaces;
2. Mass;
3. Centre of gravity with respect to a given coordinate system for three mutually perpendicular axes;
4. [Moment](#) of inertia with respect to the given coordinate system.

NOTE For space segment equipment with simple shapes, the centre of gravity location and momenta of inertia can be determined by calculation.

ECSS-E-ST-10-03_0750127

- b. The space segment equipment shall be in launch configuration, unless this configuration cannot be reproduced on ground.

5.5.2.2 Acceleration test (static, spin or sine burst)

ECSS-E-ST-10-03_0750128

- a. The space segment equipment shall be mounted to a test fixture through its normal mounting points.

ECSS-E-ST-10-03_0750129

- b. When a centrifuge is used, it shall be ensured that the length of the arm (measured to the geometric centre of the space segment equipment) is at least five times the dimension of the space segment equipment measured along the arm.

NOTE This is to ensure uniform force distribution on the space segment equipment.

5.5.2.3 Random vibration test

ECSS-E-ST-10-03_0750130

- a. Random vibration tests shall be conducted in launch configuration for all axes.

ECSS-E-ST-10-03_0750131

- b. The induced cross axis accelerations at the attachment points shall be limited to the maximum test levels specified for the cross axis.

ECSS-E-ST-10-03_0750132

- c. In order to evaluate the space segment equipment integrity a resonance search shall be performed before and after the random vibration test.

ECSS-E-ST-10-03_0750133

- d. The success criteria for the resonance search shall be:

1. less than 5 % in frequency shift, for modes with an effective mass greater than 10 %;
2. less than 20 % in amplitude shift, for modes with an effective mass greater than 10 %.

ECSS-E-ST-10-03_0750134

- e. Detailed visual checks shall be carried out when functional tests are not performed.

ECSS-E-ST-10-03_0750135

- f. For space segment equipment which is designed to be re-flown, the qualification test duration per axis shall be in conformance with Table 5-2 plus 50 seconds per additional flight.

5.5.2.4 Acoustic test

ECSS-E-ST-10-03_0750136

- a. Acoustic tests shall be conducted in a reverberating chamber, with the space segment equipment in launch configuration mounted on a test fixture simulating the dynamic flight mounting conditions.

NOTE Acoustic tests are often but not always conducted on space segment equipment with large surfaces which are likely to be susceptible to acoustic noise excitations, e.g. solar arrays, antennas; for this type of space segment equipment random vibration testing is not performed.

ECSS-E-ST-10-03_0750137

- b. The space segment equipment and the test fixture shall be decoupled from chamber floor and wall structure born vibration.

ECSS-E-ST-10-03_0750138

- c. In order to evaluate the space segment equipment integrity a low level acoustic run (-8 dB the qualification level) shall be performed before and after the acoustic qualification run by determining resonant frequencies.

ECSS-E-ST-10-03_0750139

- d. The success criteria for the resonance search shall be:
1. less than 5 % in frequency shift, for modes with an effective mass greater than 10 %;
 2. less than 40 % in amplitude shift, for modes with an effective mass greater than 10 %.

ECSS-E-ST-10-03_0750140

- e. For space segment equipment which is designed to be re-flown, the qualification test duration shall be in conformance with Table 5-2 plus 50 seconds per additional flight.

5.5.2.5 Sinusoidal vibration test

ECSS-E-ST-10-03_0750141

- a. Sinusoidal tests shall be conducted in the launch configurations for all axes.

ECSS-E-ST-10-03_0750142

- b. A resonance search shall be performed before and after the sinusoidal vibration test to determine resonance frequencies to evaluate the space segment equipment integrity.

ECSS-E-ST-10-03_0750143

- c. The success criteria for the resonance search shall be:
1. less than 5 % in frequency shift, for modes with an effective mass greater than 10 %;
 2. less than 20 % in amplitude shift, for modes with an effective mass greater than 10 %.

ECSS-E-ST-10-03_0750144

- d. Detailed visual checks shall be carried out prior and after test to check for visual damage.

ECSS-E-ST-10-03_0750145

- e. The induced cross axis excitation shall be monitored to check that the response in the cross axis does not exceed the specification.

5.5.2.6 Shock test

ECSS-E-ST-10-03_0750146

- a. Shock tests shall be conducted in the item under test configuration relevant to the event where the shock is produced.

NOTE The shock tests demonstrate the ability of the space segment equipment to withstand the shocks encountered during the lifetime, e.g.: fairing separation, space segment equipment separation, booster burn out, apogee boost motor ignition, solar arrays and antennas deployment, shocks from landing of reusable [space segment](#) elements.

ECSS-E-ST-10-03_0750147

- b. Equipment powered during the event where the shock is produced, shall be powered during the test.

ECSS-E-ST-10-03_0750148

- c. The equipment shall be mounted to a fixture using its normal mounting points.

ECSS-E-ST-10-03_0750149

- d. The selected test method shall achieve the specified Shock Response Spectrum with a representative transient, comparable in shape and duration to the expected in-flight shock.

ECSS-E-ST-10-03_0750455

- e. To reduce the number of shock activations, axes and directions may be combined, provided the required environment is created.

ECSS-E-ST-10-03_0750151

- f. Detailed visual checks shall be carried out.

ECSS-E-ST-10-03_0750152

- g. Hardware integrity shall be verified after the test.

NOTE This is performed through several ways, like performance test, low level sinusoidal vibration pre and post test, modal survey, alignment.

ECSS-E-ST-10-03_0750153

- h. The induced cross axis excitation shall be monitored to check that the response in the cross axis do not exceed the specification.

ECSS-E-ST-10-03_0750154

- i. The homogeneity of the shock around the equipment under test shall be monitored by at least one pair of sensors mounted at opposite corners of the equipment.

5.5.2.7 Micro-vibration generated environment test

ECSS-E-ST-10-03_0750155

- a. The measurements of the space segment equipment interface dynamic forces and torques shall be performed.

ECSS-E-ST-10-03_0750156

- b. The space segment equipment shall be in its nominal operational configuration similar to the on-orbit operational conditions.

ECSS-E-ST-10-03_0750471

- c. The time signals of the measurements shall be recorded.

NOTE For example in a machine readable format.

ECSS-E-ST-10-03_0750472

- d. The background noise shall be measured, including each individual contribution from EGSE, MGSE, FGSE.

NOTE Example of FGSE: pumps.

ECSS-E-ST-10-03_0750473

- e. If necessary, for the purpose of the test, mitigation actions shall be taken to reduce the background noise.

NOTE Background noise can be due to the external environment (e.g. road, sea, wind, people around, other ongoing activities/tests), facilities (e.g. air conditioning, lights), MGSE, EGSE, FGSE (e.g. pumps). Background noise can be different depending on the time (night/day, presence of other activities).

5.5.2.8 Micro-vibration susceptibility test

ECSS-E-ST-10-03_0750157

- a. The performance parameters shall be measured when subjected to the **specified** micro-vibration environment.

ECSS-E-ST-10-03_0750158

- b. The space segment shall be in its nominal operational configuration similar to the on-orbit operational conditions.

ECSS-E-ST-10-03_0750474

- c. The time signals of the measurements of the performance parameters and of the applied micro-vibration environment shall be recorded.

NOTE For example in a machine readable format.

ECSS-E-ST-10-03_0750475

- d. The background noise shall be measured, including each individual contribution from EGSE, MGSE, FGSE.

NOTE Example of FGSE: pumps.

ECSS-E-ST-10-03_0750476

- e. If necessary, for the purpose of the test, mitigation actions shall be taken to reduce the background noise.

NOTE Background noise can be due to the external environment (e.g. road, sea, wind, people around, other ongoing activities/tests), facilities (e.g. air conditioning, lights), MGSE, EGSE, FGSE (e.g. pumps). Background noise can be different depending on the time (night/day, presence of other activities).

5.5.3 Structural integrity under pressure tests

5.5.3.1 Leak test

ECSS-E-ST-10-03_0750159

- a. Leak tests shall be performed only on sealed or pressurized space segment equipment, sensitive to loss of pressure or vacuum, or which contain hazardous substances.

ECSS-E-ST-10-03_0750160

- b. The leak test shall demonstrate the ability of sealed or pressurized space segment equipment to conform to the leak rates stated in the specifications.

ECSS-E-ST-10-03_0750161

- c. The leak test method employed shall have sensitivity and uncertainty consistent with the space segment equipment specified maximum allowable leak rate.

ECSS-E-ST-10-03_0750162

- d. The sensitivity of the leak test, in particular, shall be quantitatively less than the minimum leak rate to be detected by a factor of at least two to ensure reliability of measurements.

ECSS-E-ST-10-03_0750163

- e. Leak tests shall be performed prior to and following the completion of space segment equipment thermal and mechanical tests.

ECSS-E-ST-10-03_0750164

- f. Leak tests shall be conducted prior to and following proof pressure tests.

ECSS-E-ST-10-03_0750165

- g. When temperature potentially affects the sealing materials or surfaces, an evaluation of the hardware design and operational characteristics shall be

performed and, if technically warranted, the leak test conducted at the minimum and maximum qualification or acceptance temperature limits for respectively qualification or acceptance test.

ECSS-E-ST-10-03_0750166

- h. If seals are dependent upon differential pressure for proper sealing, leak tests shall also be performed with the space segment equipment pressurized at the maximum and the minimum differential pressure expected in operation.

NOTE This can be the case for valves.

ECSS-E-ST-10-03_0750477

- i. If the containment of hazardous fluids requires a design providing a double, redundant seal, the leak test shall be performed in two steps, testing separately the two seals.

5.5.3.2 Proof pressure test

ECSS-E-ST-10-03_0750167

- a. The proof pressure qualification test shall be performed to demonstrate that the equipment meets the specified requirements after having been submitted to the proof pressure.

NOTE One of the requirements for pressurized hardware can be maximum leak rate that is tested in a subsequent leak test.

ECSS-E-ST-10-03_0750168

- b. The proof pressure acceptance test shall be performed to demonstrate that the equipment meets the specified requirements after having been submitted to the proof pressure..

NOTE One of the requirements for pressurized hardware can be maximum leak rate that is tested in a subsequent leak test.

ECSS-E-ST-10-03_0750169

- c. The influence of temperature on test validity shall be in conformance with ECSS-E-ST-32-02 requirements 5.4.1c and 5.5.1b.

5.5.3.3 Pressure cycling test

ECSS-E-ST-10-03_0750170

- a. Pressure cycling test shall be performed in conformance with ECSS-E-ST-32-02 clause 5.4.5.

ECSS-E-ST-10-03_0750171

- b. The influence of temperature on test validity shall be taken into account by applying ECSS-E-ST-32-02 requirement 5.4.1c.

5.5.3.4 Design burst pressure test

ECSS-E-ST-10-03_0750172

- a. The influence of temperature on test validity shall be taken into account by applying ECSS-E-ST-32-02 requirement 5.4.1c.

ECSS-E-ST-10-03_0750173

- b. After burst pressure, no space segment equipment or any of its parts shall be used for further qualification activities or as flight hardware.

5.5.3.5 Burst test

ECSS-E-ST-10-03_0750174

- a. Burst test shall be performed in conformance with ECSS-E-ST-32-02 clause 5.4.7.

5.5.4 Thermal tests

5.5.4.1 Requirements applicable to thermal vacuum test and thermal test at mission pressure

ECSS-E-ST-10-03_0750175

- a. Both thermal vacuum test and thermal test at mission pressure shall be performed for space segment equipment that operate under a non-vacuum environment after having been exposed to vacuum.

NOTE 1 For example, in the case of a planetary mission within an atmosphere, the space segment equipment is tested in vacuum and in the mission atmosphere pressure.

NOTE 2 At space segment equipment level, the version C of ECSS-E-ST-10-03 does not consider a thermal test at room pressure (also called "thermal cycling", by example, in US standards and in the version A of ECSS-E-ST-10-03).

NOTE 3 At space segment equipment level, clause 5.5.4.4 of ECSS-E-HB-10-03 gives guidelines for assessment of alternative thermal testing approaches using room pressure temperature cycling tests.

ECSS-E-ST-10-03_0750176

- b. Thermal balance phase(s), if required, shall be included in the thermal vacuum test or in the thermal test at a pressure value corresponding to the type of mission.

NOTE E.g. for very dissipative equipment, equipment with important temperature differences at vacuum conditions, Earth atmospheric pressure, space station pressure or Mars pressure.

ECSS-E-ST-10-03_0750177

- c. All space segment equipment temperatures shall refer to the temperature reference point.

ECSS-E-ST-10-03_0750178

- d. The space segment equipment temperatures shall be defined for the following conditions:
1. minimum and maximum operating qualification and acceptance;
 2. minimum and maximum non-operating qualification, and acceptance;
 3. minimum switch ON and maximum (as relevant).

ECSS-E-ST-10-03_0750179

- e. The test level shall take into account the test tolerances as specified in Table 4-1.

ECSS-E-ST-10-03_0750180

- f. The temperature rate of change shall be lower than 20 K per minute.

ECSS-E-ST-10-03_0750181

- g. Functional test shall only start after a dwell time greater or equal to 2 hours, except for solar arrays, see Table 5-2, Table 5-4, Table 5-6 for plateau duration.

ECSS-E-ST-10-03_0750182

- h. Test profile, test configuration, number of cycles, extreme temperatures, temperature rate of change, stability criteria, dwell time duration, tests to be performed and success criteria shall be defined in the test specification.

ECSS-E-ST-10-03_0750183

- i. The test profile shall include a non operating cycle.

ECSS-E-ST-10-03_0750184

- j. The space segment equipment shall be subjected to functional test before and after the thermal test.

ECSS-E-ST-10-03_0750185

- k. Functional tests shall be performed as a minimum at hot and cold operating temperatures.

NOTE Test during transition are subjected to case by case decision.

ECSS-E-ST-10-03_0750186

- l. Equipment switch on capabilities shall be demonstrated at minimum switch-on temperature and at maximum switch-on temperature.

ECSS-E-ST-10-03_0750187

- m. In case of internal redundancy, thermal tests shall be performed on both chains taking into account the type of redundancy (e.g. hot or cold).

ECSS-E-ST-10-03_0750188

- n. In case of cross-strapped configurations, requirements for testing shall be agreed with the customer.

ECSS-E-ST-10-03_0750189

- o. The space segment equipment operative configuration during the test shall be the most severe one in the power time domain and from the power consumption point of view.

ECSS-E-ST-10-03_0750190

- p. Monitoring for corona shall be conducted during chamber pressure reduction for space segment equipment that are critical with regard to corona effect.

NOTE For thermal test at mission pressure, this is justified by the fact that atmospheric pressure can be lower than Earth atmospheric pressure.

ECSS-E-ST-10-03_0750191

- q. Test methods and test set-up shall be defined according to the thermal environment characteristics, the TCS thermal design and the space segment equipment itself.

ECSS-E-ST-10-03_0750192

- r. The test set-up shall ensure appropriate orientation for space segment equipment containing two phases heat transport equipment (e.g. heat pipe).

NOTE This means that the two phases heat transport equipment is horizontal or works in reflux mode.

ECSS-E-ST-10-03_0750478

- s. Outside the functional and performance tests of the required test profile, the equipment shall be continuously powered on, when compatible with test profile, and parameters monitored to detect intermittent or persistent defects.

5.5.4.2 Requirements applicable to thermal vacuum test

ECSS-E-ST-10-03_0750193

- a. Thermal vacuum testing shall be performed for space segment equipment whose operation occurs in space vacuum environment at any time of its lifetime.

ECSS-E-ST-10-03_0750194

- b. Space segment equipment shall be tested at a pressure of 10^{-5} hPa or less.

ECSS-E-ST-10-03_0750195

- c. Conditions and test set-up shall be such as to avoid contamination of the equipment.

ECSS-E-ST-10-03_0750456

- d. In line with requirement 5.5.4.2c the test profile should start with a maximum non-operating temperature.

ECSS-E-ST-10-03_0750197

- e. For solar array, continuity and insulation resistance shall be monitored during the test as per ECSS-E-ST-20-08 requirements 5.5.3.11.2 f and g.

5.5.4.3 Requirements applicable to thermal test at mission pressure

ECSS-E-ST-10-03_0750198

- a. Test approach with thermal test at mission pressure without vacuum test shall be selected only for space segment equipment that operates under a non-vacuum environment during their entire lifetime.

NOTE In assessing this, depressurisation failure should be considered.

ECSS-E-ST-10-03_0750199

- b. Pressure value shall be as per type of mission.

NOTE E.g. Earth atmospheric pressure, space station pressure, Mars pressure.

ECSS-E-ST-10-03_0750200

- c. Climatic conditions shall be such as to avoid condensation on the item under test.

ECSS-E-ST-10-03_0750201

- d. The space segment equipment shall be mounted in a temperature chamber if the atmospheric mission pressure is near the Earth atmospheric pressure and in a pressure chamber with temperature control capability or in a vacuum chamber with pressure and temperature control capabilities if the atmospheric mission pressure is different from the Earth atmospheric pressure.

5.5.5 Electrical/RF tests

5.5.5.1 EMC test

ECSS-E-ST-10-03_0750202

- a. The EMC test shall be performed in conformance with ECSS-E-ST-20-07 clause 5.

ECSS-E-ST-10-03_0750203

- b. For acceptance stage, the space segment equipment shall be subjected to the following tests, as per ECSS-E-ST-20-07:
1. bonding verification;
 2. power lines isolation;
 3. inrush current;
 4. conducted emission time domain (ripple and spikes) on power lines in the operating mode, which produces maximum emissions;
 5. conducted emission frequency domain on power lines in the operating mode, which produces maximum emissions.

ECSS-E-ST-10-03_0750204

- c. For RF space segment equipment sniff or spray test shall be performed at one or several frequencies used by the space segment equipment under test or in mission critical receive bands.

ECSS-E-ST-10-03_0750457

- d. Sniff or spray test should be performed with a guide to coax transitions at a controlled distance.

5.5.5.2 Magnetic test

ECSS-E-ST-10-03_0750206

- a. The magnetic test shall be performed in conformance with ECSS-E-ST-20-07 clause 4.2.5 and 5.4.5.

5.5.5.3 ESD test

ECSS-E-ST-10-03_0750207

- a. The ESD test on space segment equipment shall be performed in conformance with ECSS-E-ST-20-07 clause 5.4.12.

5.5.5.4 Passive intermodulation test

ECSS-E-ST-10-03_0750208

- a. The passive intermodulation test shall be performed in conformance with ECSS-E-ST-20.

5.5.5.5 Multipactor test

ECSS-E-ST-10-03_0750209

- a. The multipactor test shall be performed in conformance with ECSS-E-ST-20-01.

5.5.5.6 Corona and arc discharge test

ECSS-E-ST-10-03_0750210

- a. Corona and arc discharge test shall be performed for space segment equipment exposed to the critical low pressure atmosphere according to relevant Paschen curves during its lifetime.

NOTE Demonstration of margin for corona and arc discharges effect is mainly achieved by analysis, and by component/ sub assembly or development model level test. During space segment element qualification programme, it is unlikely that margin can be applied (i.e. on voltage or output power for RF), the test is then limited to a go/nogo test.

5.5.6 Mission specific test

5.5.6.1 Audible noise test

5.5.6.1.1 General

ECSS-E-ST-10-03_0750211

- a. During the audible noise test the [space segment equipment sound power level transmitted via airborne](#) shall be measured.

ECSS-E-ST-10-03_0750212

- b. <<deleted>>

ECSS-E-ST-10-03_0750213

- c. The noise level and exposure time shall be [measured](#) for each operational mode of the space segment equipment.

5.5.6.1.2 Equipment airborne sound pressure measurement

ECSS-E-ST-10-03_0750214

- a. The space segment equipment sound power measurements shall be performed in accordance with [ISO 3740:2019](#).

ECSS-E-ST-10-03_0750215

- b. <<deleted>>

5.5.6.1.3 <<deleted>>

ECSS-E-ST-10-03_0750216

- a. <<deleted>>

ECSS-E-ST-10-03_0750217

- b. <<deleted>>

Space segment element test requirements

6.1 General requirements

ECSS-E-ST-10-03_0750458

- a. When it is not feasible to test a space segment element as a single entity, it may be tested separately as several space segment elements or space segment equipment.

NOTE 1 For example, when it is not feasible due to its size, which can exceed the capacity of a test facility.

NOTE 2 For example, a test on a space segment element can be split into a service module test and a payload module test.

ECSS-E-ST-10-03_0750219

- b. The effects of item(s), which are interacting on the [space segment](#) element level, but which are not present during tests, shall be included with the support of simulators.

NOTE Simulators can be fluid, mechanical, thermal, electrical item(s) or software.

ECSS-E-ST-10-03_0750220

- c. The test baseline shall be tailored for each project.

ECSS-E-ST-10-03_0750221

- d. The sequence of [tests](#) shall be agreed by the customer depending on the nature of the space segment element and how performances are tested.

NOTE 1 For Infrared instrument or satellite including IR instrument the TV test is the one that allows performance verification, in this case it is often the last test performed.

NOTE 2 For RF radiometer the performance are verified in anechoic chamber, in this case the auto compatibility / Radiated EMC is often one of the last tests performed.

ECSS-E-ST-10-03_0750459

- e. For space segment element undergoing a PFM approach, the equipment that are part of it, should be acceptance tested.

NOTE This implies that the equipment design is [already](#) qualified.

ECSS-E-ST-10-03_0750223

- f. Any unusual or unexpected behaviour shall be evaluated to determine the existence of any trend potentially leading to anomaly or failure situation.

ECSS-E-ST-10-03_0750224

- g. Visual inspections shall be performed before and after each test.

6.2 Qualification test requirements

ECSS-E-ST-10-03_0750225

- a. When a full Qualification model is developed for a space segment elements qualification the test baseline shall consist of the tests specified in Table 6-1.

NOTE Other special tests can be performed depending upon the project characteristics and product lifetime cycle.

Table 6-1: Space segment element - Qualification test baseline

ECSS-E-ST-10-03_0750447

Test	Reference clause	Ref. to Level & Duration & Number of applications	Applicability	Conditions
General				
Optical alignment	6.5.1.1		R	
Functional (FFT / RFT)	6.5.1.2		R	
Performances (PT)	6.5.1.3		R	
Mission (MT)	6.5.1.4		R	
Polarity	6.5.1.5		R	
Launcher Interface	6.5.1.6		X	Mandatory for space segment element interfacing with launcher if not performed on FM (see Table 6-3).
Mechanical				
Physical properties	6.5.2.1		R	
Modal survey	6.5.2.2		X	
Static	6.5.2.3	Table 6-2 No 1	X	Mandatory if not performed at structure subsystem level
Spin	6.5.2.4	Table 6-2 No 2	X	Mandatory for spinning space segment elements with an acceleration greater than 2g or more to any part of the space segment element
Sine Burst	6.5.2.5	Table 6-2 No 3	X	Can replace a static test
Transient	6.5.2.5	Table 6-2 No 4	X	
Acoustic	6.5.2.6	Table 6-2 No 5	X	Acoustic test may be replaced by random vibration. For a small compact space segment element, acoustic testing does not provide adequate environmental simulation, and random vibration may replace the acoustic test.
Random vibration	6.5.2.7	Table 6-2 No 6	X	If acoustic test is performed, random vibration may be avoided.
Sinusoidal vibration	6.5.2.8	Table 6-2 No 7	R	Sinusoidal vibration may be replaced by transient combined with modal survey
Shock	6.5.2.9	Table 6-2 No 8	X	

Test	Reference clause	Ref. to Level & Duration & Number of applications	Applicability	Conditions
Micro-vibration susceptibility	6.5.2.10	Table 6-2 No 9	X	
Micro-vibration emission	6.5.2.11		X	Mandatory for crewed mission
Structural Integrity				
Proof pressure	6.5.3.1	Table 6-2 No 10	X	Mandatory for pressurized space segment elements or on pressurized equipment integrated in space segment element for which the test is feasible
Pressure Cycling	6.5.3.2	Table 6-2 No 11	X	Mandatory for pressurized space segment elements that will experience several re-entries.
Design Burst pressure	6.5.3.3	Table 6-2 No 12	X	Mandatory for pressurized space segment element may be performed on a dedicated hardware
Leak	6.5.3.4	Table 6-2 No 13	X	Mandatory for pressurized space segment elements or on pressurized equipment integrated in space segment element for which the test is feasible
Thermal				
Thermal vacuum	6.5.4.1 & 6.5.4.2	Table 6-2 No 14	R	
Thermal test at mission pressure	6.5.4.1 & 6.5.4.3	Table 6-2 No 15	X	Applicable to space segment elements that operate under a non-vacuum environment during their lifetime Temperature cycling test at mission pressure and temperature cycling test in vacuum may be combined in sequence. Temperature cycling test at room pressure (also called "thermal cycling", by example, in US standards and in the version A of ECSS-E-ST-10-03) is not considered in this Standard.
Thermal balance	6.5.4.4		R	
Electrical / RF				
EMC	6.5.5.2	Table 6-2 No 16	R	
Electromagnetic auto-compatibility	6.5.5.3		R	
PIM	6.5.5.4	Table 6-2 No 17	X	
Magnetic	6.5.5.5		X	

Test	Reference clause	Ref. to Level & Duration & Number of applications	Applicability	Conditions
Mission Specific				
Aero-thermodynamics	6.5.6.1		R	For space segment element performing atmospheric entry
Crewed Mission Specific				
Vibroacoustic emission	6.5.7.1		R	
HFE	6.5.7.2		R	
Toxic off gassing	6.5.7.3		R	
Audible noise	6.5.7.4		R	
<p>R Mandatory</p> <p>X To be decided on the basis of design features, required lifetime, sensitivity to environmental exposure, and expected usage.</p> <p>Note: All tests type are listed independently of their application status:</p> <ul style="list-style-type: none"> - the dark grey indicates that the type of test is never required or optional - the light grey indicates that there is no test level and duration specified in the Table 6-2 since it is not a test where an environment is applied to the item under test 				

Table 6-2: Space segment element - Qualification test levels and duration

ECSS-E-ST-10-03_0750448

No	Test	Levels	Duration	Number of applications	NOTES
1	static load	KQ x Limit Load The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	worst combined load cases	Worst combined load cases are determined by analysis
2	Spin	\sqrt{KQ} x spin rate The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As specified by the project.	1 test	
3	Sine Burst	KQ x Limit Load The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	on each of 3 orthogonal axes	
4	Transient	KQ x Limit Load The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	1 test on 3 axis or 1 longitudinal axis	
5	Acoustic	Maximum expected acoustic spectrum +3 dB If margins higher than 3 dB are specified by the Launcher Authority, they apply	2 minutes	1 test	
6	Random vibration	Maximum expected spectrum +3 dB on PSD values If margins higher than 3 dB are specified by the Launcher Authority, they apply.	2 minutes	on each of 3 orthogonal axes	

No	Test	Levels	Duration	Number of applications	NOTES
7	Sinusoidal vibration	KQ x Limit Load Spectrum The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	sweep at 2 Oct/min, 5 Hz - 100 Hz	on each of 3 orthogonal axes	
8	Shock	See NOTE 1	See NOTE 2	See NOTE 3	NOTE 1: Limited to a test where the shock generative device(s) is/are activated. This test is performed with no margins to consolidate the shock specification of the space segment equipment NOTE 2: Duration representative of the expected environment. NOTE 3: A minimum of two firing is recommended. Multi firing reduces uncertainty linked to firing-to-firing variability.
9	Micro vibration susceptibility	Specified environment (maximum predicted environment at space segment element level plus margin)	As needed for susceptibility determination	As specified by the project.	
10	Proof pressure	$j_{\text{proof}} \times \text{MDP}$ For the proof factor (j_{proof}), apply ECSS-E-ST-32-02 Tables 4-1 to 4-9.	5 minutes minimum hold time	1 test	The MDP to be used is the one of the weakest equipment composing the pressurized subsystem (i.e. the lowest one), See ECSS-E-HB-10-03, paragraph B.1

No	Test	Levels	Duration	Number of applications	NOTES
11	Pressure Cycling	From zero to MDP differential pressure	See ECSS-E-ST-32-02, paragraph 5.4.5.	1 test	The MDP level can be exceeded. See ECSS-E-ST-32-02, paragraph 5.4.5
12	Design burst pressure	$j_{burst} \times MDP$ For the burst factor (j_{burst}), apply ECSS-E-ST-32-02 Tables 4-1 to 4-9.	30 seconds as minimum	1 test	
13	Leak	MDP	to be agreed depending on test method	before and after environmental tests taking into account that one is already performed as part of proof test	
14	Thermal vacuum	To ensure that all equipment maximum temperatures are: -above T_{max}^A , and -as close as possible to T_{max}^Q , and -with no equipment temperature above T_{max}^Q To ensure that all equipment minimum temperatures are: -below T_{min}^A , and -as close as possible to T_{min}^Q , and -with no equipment temperature below T_{min}^Q	4 temperature cycles or 1 or more temperature cycles if combined with temperature cycles at mission pressure (see Note 1 & 2)	1 test	NOTE 1: Vacuum temperature cycling test and mission pressure temperature cycling test are both performed for space segment elements that operate under a non-vacuum environment after having been exposed to vacuum. NOTE 2: Number of temperature cycles and operating condition under vacuum and under mission pressure are selected based on mission profile

No	Test	Levels	Duration	Number of applications	NOTES
15	Thermal test at mission pressure (See Note 1 & 2)	To ensure that all equipment maximum temperatures are: -above T_{max}^A , and -as close as possible to T_{max}^Q , and -with no equipment temperature above T_{max}^Q To ensure that all equipment minimum temperatures are: -below T_{min}^A , and -as close as possible to T_{min}^Q , and -with no equipment temperature below T_{min}^Q	4 temperature cycles or 4 temperature cycles minus the number of temperature cycles performed during the thermal vacuum	1 test	NOTE 1: Example of mission are Mars and Venus missions NOTE 2: Temperature cycling test at mission pressure without temperature cycling test in vacuum is applicable only to space segment elements that operate under a non-vacuum environment during their lifetime. In assessing this, depressurisation failure should be considered.
16	EMC	Apply ECSS-E-ST-20-07 clause 5.3 and EMCCP.	Apply the project EMCCP (produced in conformance with. ECSS-E-ST-20 Annex A)	1 test	
17	Passive intermodulation	Apply ECSS-E-ST-20 clause 7.4	Apply ECSS-E-ST-20 clause 7.4	1 test	

6.3 Acceptance test requirements

ECSS-E-ST-10-03_0750226

- a. For space segment elements where full qualification has been obtained on another model(s), the Flight Model(s) acceptance test baseline shall consist of the tests specified in Table 6-3.

Table 6-3: Space segment element - Acceptance test baseline

ECSS-E-ST-10-03_0750449

Test	Reference clause	Ref. to Level & Duration & Number of applications	Applicability	Conditions
General				
Optical alignment	6.5.1.1		R	
Functional (FFT / RFT)	6.5.1.2		R	
Performances (PT)	6.5.1.3		R	
Mission (MT)	6.5.1.4		R	
Polarity	6.5.1.5		R	
Launcher Interface	6.5.1.6		X	Mandatory for space segment element interfacing with launcher if not performed on QM or PFM or in case of design change of launcher interface.
Mechanical				
Physical properties	6.5.2.1		R	MoI measurement can be deleted upon customer approval.
Modal survey			-	
Static			-	
Spin	6.5.2.4	Table 6-4 No 2	X	Mandatory for spinning space segment elements with an acceleration greater than 2 g or more to any part of the space segment element
Sine Burst	6.5.2.5	Table 6-4 No 3	X	As a possible way to reach required interface forces and moments
Transient			-	
Acoustic	6.5.2.6	Table 6-4 No 5	X	Acoustic test may be replaced by random vibration.
Random vibration	6.5.2.7	Table 6-4 No 6	X	For a small compact space segment element, acoustic testing does not provide adequate environmental simulation, and random vibration may replace the acoustic test. If acoustic test is performed, random vibration may be avoided.
Sinusoidal vibration	6.5.2.8	Table 6-4 No 7	X	Not needed if acoustic or random is performed

Test	Reference clause	Ref. to Level & Duration & Number of applications	Applicability	Conditions
Shock	6.5.2.9	Table 6-4 No 8	X	Limited to deployment of appendage and to launcher interface if modified from PFM or QM
Micro-vibration susceptibility	6.5.2.10	Table 6-4 No 9	X	If considered critical
Micro-vibration emission	6.5.2.11		X	Mandatory for crewed missions
Structural integrity				
Proof pressure	6.5.3.1	Table 6-4 No 10	X	Mandatory for pressurized space segment elements or on pressurized equipment integrated in space segment element for which the test is feasible
Pressure cycling			-	
Design burst pressure			-	
Leak	6.5.3.4	Table 6-4 No 13	X	Mandatory for pressurized space segment elements or on pressurized equipment integrated in space segment element for which the test is feasible
Thermal				
Thermal vacuum	6.5.4.1 & 6.5.4.2	Table 6-4 No 14	R	
Thermal test at mission pressure	6.5.4.1 & 6.5.4.3	Table 6-4 No 15	X	Applicable to space segment elements that operate under a non-vacuum environment during their lifetime Temperature cycling test at mission pressure and temperature cycling test in vacuum may be combined. Temperature cycling test at room pressure (also called "thermal cycling", by example, in US standards and in the version A of ECSS-E-ST-10-03) is not considered in this Standard.
Thermal balance			-	
Electrical / RF				
EMC	6.5.5.2	Table 6-4 No 16	R	Limited to Conducted emission and Grounding test as per ECSS-E-ST-20-07 clause 5.3.9
Electromagnetic auto-compatibility	6.5.5.3		R	
PIM	6.5.5.4	Table 6-4 No 17	X	
Magnetic	6.5.5.5		X	

Test	Reference clause	Ref. to Level & Duration & Number of applications	Applicability	Conditions
Mission Specific				
Aero-thermodynamics	6.5.6.1		R	For space segment element performing atmospheric entry
Crewed Mission Specific				
Vibroacoustic emission	6.5.7.1		R	
HFE	6.5.7.2		R	
Toxic off gassing	6.5.7.3		R	
Audible noise	6.5.7.4		R	
<p>R Mandatory</p> <p>X To be decided on the basis of design features, required lifetime, sensitivity to environmental exposure, and expected usage.</p> <p>Note: All tests type are listed independently of their application status:</p> <ul style="list-style-type: none"> - the dark grey indicates that the type of test is never required or optional - the light grey indicates that there is no test level and duration specified in the Table 6-4 since it is not a test where an environment is applied to the item under test 				

Table 6-4: Space segment element - Acceptance test levels and duration

ECSS-E-ST-10-03_0750450

No	Test	Levels	Duration	Number of applications	NOTES
1	Static load	N/A	N/A	N/A	
2	Spin	\sqrt{KA} x spin rate The acceptance factor KA is given in ECSS-E-ST-32-10 clause 4.3.1	As specified by the project.	1 test	
3	Sine Burst	KA x Limit Load Spectrum The acceptance factor KA is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	On each of 3 orthogonal axes	
4	Transient	N/A	N/A	N/A	
5	Acoustic	Maximum expected acoustic spectrum or as specified by Launcher authority	1 minute	1 test	
6	Random vibration	Maximum expected spectrum +0 dB on PSD values	1 minute	On each of 3 orthogonal axes	
7	Sinusoidal vibration	KA x Limit Load Spectrum The acceptance factor KA is given in ECSS-E-ST-32-10 clause 4.3.1	Sweep at 4 Oct/min, 5 Hz – 100 Hz	On each of 3 orthogonal axes	

No	Test	Levels	Duration	Number of applications	NOTES
8	Shock	See NOTE 1	See NOTE 2	1 activation	NOTE 1: Limited to a test where the shock generative device(s) is/are activated. NOTE 2: Duration representative of the expected environment.
9	Micro vibration susceptibility	Specified environment (maximum predicted environment at space segment element level plus margin)	As needed for susceptibility determination	As specified by the project.	
10	Proof pressure	$j_{\text{proof}} \times \text{MDP}$ For the proof factor (j_{proof}), apply ECSS-E-ST-32-02 Tables 4-1 to 4-9.	5 minutes minimum hold time	1 test	The MDP to be used is the one of the weakest equipment composing the pressurized subsystem (i.e. the lowest one), See ECSS-E-HB-10-03, paragraph B.1
11	Pressure cycling	N/A	N/A	N/A	
12	Design burst pressure	N/A	N/A	N/A	

No	Test	Levels	Duration	Number of applications	NOTES
13	Leak	MDP	For space segment elements to be agreed depending on test method	Before and after environmental tests taking into account that one is already performed as part of proof test	
14	Thermal vacuum	<p>To ensure that all equipment maximum temperatures are:</p> <ul style="list-style-type: none"> -above maximum predicted temperature, and -as close as possible to T_{max}^A, and -with no equipment temperature above T_{max}^A <p>To ensure that all equipment minimum temperatures are:</p> <ul style="list-style-type: none"> -below minimum predicted temperature, and -as close as possible to T_{min}^A, and -with no equipment temperature below T_{min}^A 	<p>3 temperature cycles +1 back up to be decided during test.</p> <p>or 1 or more cycles if combined with temperature cycles at mission pressure (see Note 1 & 2)</p>	1 test	<p>NOTE 1: Vacuum temperature cycling test and mission pressure temperature cycling test are both performed for space segment elements that operate under a non-vacuum environment after having been exposed to vacuum.</p> <p>NOTE 2: Number of temperature cycles and operating condition under vacuum and under mission pressure are selected based on mission profile</p>

No	Test	Levels	Duration	Number of applications	NOTES
15	Thermal test at mission pressure (See Note 1 & 2)	To ensure that all equipment maximum temperatures are: -above maximum predicted temperature, and -as close as possible to T_{max}^A , and -with no equipment temperature above T_{max}^A To ensure that all equipment minimum temperatures are: -below minimum predicted temperature, and -as close as possible to T_{min}^A , and -with no equipment temperature below T_{min}^A	3 temperature cycles or 3 temperature cycles minus the number of temperature cycles performed during the thermal vacuum	1 test	NOTE 1: Example of mission are Mars and Venus missions. NOTE 2: Temperature cycling test at mission pressure without temperature cycling test in vacuum is applicable only to space segment elements that operate under a non-vacuum environment during their lifetime. In assessing this, depressurisation failure should be considered.
16	EMC	Apply ECSS-E-ST-20-07 clause 5.3 and EMCCP	Apply the project EMCCP (produced in conformance with ECSS-E-ST-20 Annex A)	1 test	
17	Passive intermodulation	Apply ECSS-E-ST-20 clause 7.4	Apply ECSS-E-ST-20 clause 7.4	1 test	

6.4 Protoflight test requirements

ECSS-E-ST-10-03_0750227

- a. The space segment elements Proto-qualification test baseline shall consist of the tests specified in Table 6-5.

NOTE Other special tests can be performed depending upon the project characteristics and product lifetime cycle.

ECSS-E-ST-10-03_0750228

- b. When part of the qualification is obtained on other model(s), then the PFM shall be tested in accordance with Table 6-3 for the relevant type(s) of test.

NOTE For example, if mechanical qualification is obtained on a STM then the PFM is tested, for mechanical aspects, in accordance with the acceptance requirements.

Table 6-5: Space segment element - Protoflight test baseline

ECSS-E-ST-10-03_0750451

Test	Reference clause	Ref. to Level & Duration & Number of applications	Applicability	Conditions
General				
Optical alignment	6.5.1.1		R	
Functional (FFT / RFT)	6.5.1.2		R	
Performances (PT)	6.5.1.3		R	
Mission (MT)	6.5.1.4		R	
Polarity	6.5.1.5		R	
Launcher Interface	6.5.1.6		X	Mandatory for space segment element interfacing with launcher.
Mechanical				
Physical properties	6.5.2.1		R	
Modal survey	6.5.2.2		X	
Static	6.5.2.3	Table 6-6 No 1	X	Mandatory if not performed at structure subsystem level
Spin	6.5.2.4	Table 6-6 No 2	X	Mandatory for spinning space segment elements with an acceleration greater than 2 g or more to any part of the space segment element
Sine Burst	6.5.2.5	Table 6-6 No 3	X	Can replace a static test
Transient	6.5.2.5	Table 6-6 No 4	X	
Acoustic	6.5.2.6	Table 6-6 No 5	X	Acoustic test may be replaced by random vibration.

Test	Reference clause	Ref. to Level & Duration & Number of applications	Applicability	Conditions
Random vibration	6.5.2.7	Table 6-6 No 6	X	For a small compact space segment element, acoustic testing does not provide adequate environmental simulation, and random vibration may replace the acoustic test. If acoustic test is performed, random vibration may be avoided.
Sinusoidal vibration	6.5.2.8	Table 6-6 No 7	R	Sinusoidal vibration may be replaced by transient combined with modal survey
Shock	6.5.2.9	Table 6-6 No 8	X	
Micro-vibration susceptibility	6.5.2.10	Table 6-6 No 9	X	
Micro-vibration emission	6.5.2.11		X	Mandatory for crewed missions
Structural integrity				
Proof pressure	6.5.3.1	Table 6-6 No 10	X	Mandatory for pressurized space segment elements or on pressurized equipment integrated in space segment element for which the test is feasible
Pressure cycling	6.5.3.2	Table 6-6 No 11	X	Mandatory for pressurized space segment elements that will experience several re-entries.
Design burst pressure	6.5.3.3	Table 6-6 No 12	X	Mandatory for pressurized space segment element to be performed on a dedicated hardware
Leak	6.5.3.4	Table 6-6 No 13	X	Mandatory for pressurized space segment elements or on pressurized equipment integrated in space segment element for which the test is feasible
Thermal				
Thermal vacuum	6.5.4.1 & 6.5.4.2	Table 6-6 No 14	R	
Thermal test at mission pressure	6.5.4.1 & 6.5.4.3	Table 6-6 No 15	X	Applicable to space segment elements that operate under a non-vacuum environment during their lifetime. Temperature cycling test at mission pressure and temperature cycling test in vacuum may be combined. Temperature cycling test at room pressure (also called "thermal cycling", by example, in US standards and in the version A of ECSS-E-ST-10-03) is not considered in this Standard.
Thermal balance	6.5.4.4		R	

Test	Reference clause	Ref. to Level & Duration & Number of applications	Applicability	Conditions
Electrical / RF				
EMC	6.5.5.2	Table 6-6 No 16	R	
Electromagnetic auto-compatibility	6.5.5.3		R	
PIM	6.5.5.4	Table 6-6 No 17	X	
Magnetic	6.5.5.5		X	
Mission Specific				
Aero-thermodynamics	6.5.6.1		R	For space segment element performing atmospheric entry
Crewed Mission Specific				
Vibroacoustic emission	6.5.7.1		R	
HFE	6.5.7.2		R	
Toxic off gassing	6.5.7.3		R	
Audible noise	6.5.7.4		R	
<p>R Mandatory</p> <p>X To be decided on the basis of design features, required lifetime, sensitivity to environmental exposure, and expected usage.</p> <p>Note: All tests type are listed independently of their application status:</p> <ul style="list-style-type: none"> - the dark grey indicates that the type of test is never required or optional - the light grey indicates that there is no test level and duration specified in the Table 6-6 since it is not a test where an environment is applied to the item under test 				

Table 6-6: Space segment element - Protoflight test levels and duration

ECSS-E-ST-10-03_0750452

No	Test	Levels	Duration	Number of applications	NOTES
1	Static load	KQ × Limit Load The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	Worst combined load cases	Note: Worst combined load cases are determined by analysis
2	Spin	\sqrt{KQ} × spin rate The qualification factor KQ is given in ECSS-E-ST-32-10	As specified by the project	1 test	
3	Sine Burst	KQ × Limit Load The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	On each of 3 orthogonal axes	
4	Transient	KQ × Limit Load The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	As needed to record data	On each of 3 orthogonal axes	
5	Acoustic	Maximum expected acoustic spectrum +3 dB If margins higher than 3 dB are specified by the Launcher Authority, they apply	1 minute	1 test	
6	Random vibration	Maximum expected spectrum +3 dB on PSD values If margins higher than 3 dB are specified by the Launcher Authority, they apply	1 minute	On each of 3 orthogonal axes	
7	Sinusoidal vibration	KQ × Limit Load Spectrum The qualification factor KQ is given in ECSS-E-ST-32-10 clause 4.3.1	Sweep at 4 Oct/min, 5 Hz – 100 Hz	On each of 3 orthogonal axes	

No	Test	Levels	Duration	Number of applications	NOTES
8	Shock	See Note 1	See Note 2	1 activation	<p>NOTE 1: Limited to a test where the shock generative device(s) is/are activated.</p> <p>This test is performed with no margins to consolidate the shock specification of the space segment equipment</p> <p>NOTE 2: Duration representative of the expected environment.</p>
9	Micro vibration susceptibility	specified environment (maximum predicted environment at space segment element level plus margin)	As needed for susceptibility determination	As specified by the project.	
10	Proof pressure	$j_{\text{proof}} \times \text{MDP}$ For the proof factor (j_{proof}), apply ECSS-E-ST-32-02 Tables 4-1 to 4-9.	5 minutes minimum hold time	1 test	<p>The MDP to be used is the one of the weakest equipment composing the pressurized subsystem (i.e. the lowest one). See ECSS-E-HB-10-03, paragraph B.1</p>
11	Pressure cycling	See Note	See Note	See Note	Apply ECSS-E-ST-32-02C clause 5.4.5
12	Design burst pressure	$j_{\text{burst}} \times \text{MDP}$ For the burst factor (j_{burst}), apply ECSS-E-ST-32-02 Tables 4-1 to 4-9.	30 seconds as minimum	1 test	

No	Test	Levels	Duration	Number of applications	NOTES
13	Leak	MDP	To be agreed depending on test method	Before and after environmental tests taking into account that one is already performed as part of proof test	
14	Thermal vacuum	<p>To ensure that all equipment maximum temperatures are:</p> <ul style="list-style-type: none"> - above maximum predicted temperature, and - as close as possible to T_{max}^Q, and - with no equipment temperature above T_{max}^Q <p>To ensure that all equipment minimum temperatures are:</p> <ul style="list-style-type: none"> - below minimum predicted temperature, and - as close as possible to T_{min}^Q, and - with no equipment temperature below T_{min}^Q <p>The temperature excursion stops when the first unit reaches T_{max}^Q or T_{min}^Q</p>	<p>3 temperature cycles +1 back up to be decided during test.</p> <p>or 1 or more temperature cycles if combined with temperature cycles at mission pressure(see Note 1 & 2)</p>	1 test	<p>NOTE 1: Vacuum temperature cycling test and mission pressure temperature cycling test are both performed for space segment elements that operate under a non-vacuum environment after having been exposed to vacuum.</p> <p>NOTE 2: Number of temperature cycles and operating condition under vacuum and under mission pressure are selected based on mission profile</p>

No	Test	Levels	Duration	Number of applications	NOTES
15	Thermal test at mission pressure (See Note 1 & 2)	<p>To ensure that all equipment maximum temperatures are:</p> <ul style="list-style-type: none"> - above maximum predicted temperature, and - as close as possible to T_{max}^Q, and - with no equipment temperature above T_{max}^Q <p>To ensure that all equipment minimum temperatures are:</p> <ul style="list-style-type: none"> - below minimum predicted temperature, and - as close as possible to T_{min}^Q, and - with no equipment temperature below T_{min}^Q 	<p>3 temperature cycles (see Note 2)</p> <p>or 3 temperature cycles minus the number of temperature cycles performed during the thermal vacuum</p>	1 test	<p>NOTE 1: Examples of mission are Mars or Venus missions</p> <p>NOTE 2: Temperature cycling test at mission pressure without temperature cycling test in vacuum is applicable only to space segment elements that operate under a non-vacuum environment during their lifetime. In assessing this, depressurisation failure should be considered.</p>
16	EMC	Apply ECSS-E-ST-20-07 clause 5.3 and EMCCP	Apply the project EMCCP (produced in conformance with ECSS-E-ST-20 Annex A).	1 test	
17	Passive intermodulation	Apply ECSS-E-ST-20 clause 7.4	Apply ECSS-E-ST-20 clause 7.4	1 test	

6.5 Space segment elements test programme implementation requirements

6.5.1 General tests

6.5.1.1 Optical alignment measurement

ECSS-E-ST-10-03_0750229

- a. The measurements, conducted either in a suitable optical alignment facility or in normal clean room with adequate measurement system, shall be performed throughout space segment element test campaign; and as a minimum, at the start and at the end of the environmental test campaign.

NOTE Alignment verification is repeated to track any degradation or to ensure that variation of space segment equipment alignment in relationship with the reference axes remain within the specified limits.

6.5.1.2 Functional tests

6.5.1.2.1 General

ECSS-E-ST-10-03_0750230

- a. The FFT shall be performed in order to verify that the space segment element functions in conformance with the specification requirements in all operational modes, including back-up modes, and transients.

ECSS-E-ST-10-03_0750231

- b. The RFT content shall be agreed with the customer.

ECSS-E-ST-10-03_0750232

- c. Functional tests shall be performed, under **room** conditions **as defined for clean rooms**, at the beginning and at the end of the test programme providing the criteria for judging the integrity of the space segment element throughout the overall test programme.

NOTE The results of both tests should be identical within the test tolerances.

ECSS-E-ST-10-03_0750233

- d. Additional tests (PT, FFT or RFT as relevant) shall be performed during the thermal test.

NOTE The space segment element is expected to be operative under these conditions.

ECSS-E-ST-10-03_0750234

- e. Additional functional tests to be performed before and after each environmental exposure and transport(s) shall be agreed with the customer.

NOTE Those tests are limited to RFT to provide the criteria for judging successful survival of the space segment.

ECSS-E-ST-10-03_0750460

- f. The FFT activities should follow the expected mission sequence, properly involving the interested functions, with the [space segment](#) element correct configuration for the particular mission phase.

ECSS-E-ST-10-03_0750236

- g. If an on-board or an EGSE software update is needed during the test campaign, the step at which the software is loaded, as well as the level of retesting, shall be agreed with the customer.

6.5.1.2.2 Mechanical functional test

ECSS-E-ST-10-03_0750237

- a. The mechanical functions of the space segment element shall be tested under the specified operating conditions as a major input to verify that they conform to the specified performance.

NOTE 1 Test is complemented by analysis and test at equipment level to take into account other design parameters that cannot be tested at space segment element level and the effect of the environment simulation (zero G device).

NOTE 2 Examples of such mechanical functions are mechanisms, deployable [device](#), valves and other mechanical devices.

ECSS-E-ST-10-03_0750238

- b. For all mechanical operations that can be disturbed by Earth's gravity field, suitable ground support fixtures shall be employed to enable operation and evaluation of the devices.

ECSS-E-ST-10-03_0750239

- c. If, for test limitation reason, the function cannot be tested at space segment element level, alternative verification method, that can include test at a lower level, shall be proposed for customer approval.

ECSS-E-ST-10-03_0750240

- d. Mechanical functional verification shall be performed prior and subsequent to environmental test campaign.

6.5.1.2.3 Electrical functional test

ECSS-E-ST-10-03_0750241

- a. Electrical functional tests shall verify that the electrical functions of the space segment element can be performed under the specified operating conditions with the specified performance.

ECSS-E-ST-10-03_0750242

- b. The following protection functions shall be tested:

1. inter-locks, if any;
2. overriding capabilities of protection functions.

ECSS-E-ST-10-03_0750243

- c. During the electrical functional tests, all components shall be operated, including redundant space segment equipment and paths, taking into account the type of redundancy (e.g. hot or cold).

NOTE Pyrotechnic devices are replaced by simulators that can be energized and monitored.

ECSS-E-ST-10-03_0750244

- d. For cross-strapped configurations, requirements for testing shall be agreed with the customer.

ECSS-E-ST-10-03_0750245

- e. All TM/TC shall be tested with the actual data base used for operations.

ECSS-E-ST-10-03_0750246

- f. It shall be verified that autonomous functions are performed when the defined conditions, for which they are designed, are present.

ECSS-E-ST-10-03_0750247

- g. Any triggering of an autonomous action not in line with the conditions for which they are designed shall be tracked as an anomaly.

ECSS-E-ST-10-03_0750248

- h. Autonomous lockout or shutdown sequences shall be verified to ensure that they do not adversely affect other system operations during or subsequent to the intended lockout or shutdown.

ECSS-E-ST-10-03_0750249

- i. For non-regulated bus, one subset of functional tests, which is subject to agreement between customer and supplier, shall be run at both the minimum and maximum bus voltage level.

ECSS-E-ST-10-03_0750250

- j. The electrical functional verification shall ensure that no function other than the intended function is activated and no spurious signals or effects are present.

NOTE For example, an LCL trip-off does not affect any other distributed line.

ECSS-E-ST-10-03_0750461

- k. Actual tests of pyrotechnic devices may be conducted at space segment equipment or component levels.

ECSS-E-ST-10-03_0750252

- l. The space segment element communication links shall be tested in a representative operational way.

NOTE This includes test of cross strapping and all redundancies. It also includes the TM/TC if the frequency used can lead to interference. It can be combined with the RF auto-compatibility test. The RF auto-compatibility test is part of the overall electromagnetic auto-compatibility defined in clause 6.5.5.

6.5.1.3 Performance test

ECSS-E-ST-10-03_0750253

- a. Performance tests shall verify that the space segment element provide the specified performances for the required function.

NOTE Performance tests are mainly defined for payload. At satellite level performances are mostly checked at payload or subsystem level.

ECSS-E-ST-10-03_0750254

- b. For cross-strapped configuration, requirements for performance tests shall be agreed with the customer.

ECSS-E-ST-10-03_0750255

- c. Performance tests shall be performed under the necessary environmental conditions that allow performances to be achieved.

ECSS-E-ST-10-03_0750256

- d. Performance tests shall be performed after the end of the environmental test programme.

6.5.1.4 Mission test

ECSS-E-ST-10-03_0750257

- a. Mission tests shall include simulation of mission cases in nominal situations on the space segment element for the critical and main operations of the entire mission profile, within the constraints of what can be simulated on ground, with the events occurring in the actual flight sequence.

NOTE For example: final count-down, launch, ascent, separation, switch-on, early orbital operations, apogee motor operations, commissioning, mission operations, manoeuvres and return operations.

- b. Mission tests shall include simulation of mission cases in contingency situations on the space segment element for the critical and main contingency operations of the entire mission profile, within the constraints of what can be simulated on ground.

NOTE The critical and main contingency operations are for example those:

- when the space segment element is or could be in danger,
- which are time critical,
- to recover from a safe mode,
- to reconfigure the space segment element after a major failure.

ECSS-E-ST-10-03_0750259

- c. To reduce the risk of error accumulation during mission test, the space segment element shall be kept uninterrupted ON according to the test profile, to be agreed with the customer, in terms of modes, modes transition and modes duration.

NOTE The definition of the mission test takes into account the typical mission scenario, able to completely exercise all modes and transitions and all software functions under an interrupted operational environment.

ECSS-E-ST-10-03_0750260

- d. The mission tests on the space segment element shall be run with the final flight software configured as for flight.

6.5.1.5 Polarity test

ECSS-E-ST-10-03_0750261

- a. The polarity test shall cover all functional chains and equipment sensitive to polarity errors.

NOTE Polarity test is not limited to AOCS space segment equipment. For examples solar array drive mechanism.

ECSS-E-ST-10-03_0750262

- b. Polarity tests shall be performed, with the validated final software installed, in all **critical** modes, on all chains from sensor to actuator, with the **space segment element** in its final flight configuration.

NOTE A mode is deemed critical for polarity testing in case a polarity error in this mode would not be recoverable and lead to mission loss or severe degradation of mission performance.

ECSS-E-ST-10-03_0750263

- c. During the polarity test the AOCS shall be operated in the mode where the chain is used in the control loop.

ECSS-E-ST-10-03_0750264

- d. The polarity test shall be one of the last tests before shipment to the launch site.

ECSS-E-ST-10-03_0750479

- e. In addition to requirement 6.5.1.5b, for non-critical modes, polarity tests shall be performed in one of the following two ways:

1. identical to critical mode, or
2. by individual tests on sensors and actuators combined with the final version of the SW components relevant for overall polarity, demonstrating the validity of the end-to-end polarity by a synthesis of all these tests.

6.5.1.6 Launcher interface test

ECSS-E-ST-10-03_0750265

- a. The interface between the space segment element and the launcher shall be tested, using space segment elements or subset of them representative of the interfaces to be tested, under realistic conditions, to verify the related system requirements.

NOTE These tests cover the mechanical, electrical and data interfaces (e.g. clamp-band release test, space segment element-launcher fit check).

ECSS-E-ST-10-03_0750266

- b. The interface between the space segment element and the launch facility shall be verified before actual space segment element operation.

ECSS-E-ST-10-03_0750267

- c. The test to be executed and approach shall be covered in the contractual documentation between space segment element authority and launch segment authority (e.g. ICD, or user manual).

6.5.2 Mechanical tests

6.5.2.1 Physical properties measurements

ECSS-E-ST-10-03_0750268

- a. The physical properties measurement shall include:
 1. Mass
 2. Centre of Gravity
 3. Moment of Inertia

ECSS-E-ST-10-03_0750269

- b. Physical properties shall be measured for the launch and orbit insertion configurations, and atmospheric entry when relevant.

NOTE Depending upon the mission profile other configurations can be used.

ECSS-E-ST-10-03_0750270

- c. The tolerances shall be the minimum values specified in either Table 4-1 or in the launcher user's manual.

NOTE Launch configuration balance requirements are stated in the launcher user's manual.

ECSS-E-ST-10-03_0750462

- d. For a large space segment element, the physical properties may be calculated using data from equipment individual measurements providing the final results meet the specified **maximum allowable uncertainty**.

ECSS-E-ST-10-03_0750272

- e. Spin balance tests shall be used for spin stabilized systems.

ECSS-E-ST-10-03_0750273

- f. If spin balance tests are performed with an empty tank, a correlation with the analytical model (tank full) shall be performed.

NOTE Operational spin balance requirements vary widely depending on the mission profile and rate of spin; therefore, specific balance requirements and procedures are stated in the space segment element specifications.

6.5.2.2 Modal survey test

ECSS-E-ST-10-03_0750274

- a. The modal survey shall be conducted on a structural representative model in conformance with ECSS-E-ST-32-11.

6.5.2.3 Static load test

ECSS-E-ST-10-03_0750275

- a. Boundary conditions, in the static load test, shall be demonstrated to be representative of flight boundary constraints or alternatively test forces on boundary constraints be measured.

ECSS-E-ST-10-03_0750276

- b. When a dummy structure is used in the static load test, it shall be demonstrated that it is representative in terms of stiffness and as far as the constraints **imposed by** the replaced flight component are concerned.

6.5.2.4 Spin test

ECSS-E-ST-10-03_0750277

- a. Spin tests shall be conducted in spin operation configuration.
ECSS-E-ST-10-03_0750463
- b. When the appendage size prevents requirement 6.5.2.4a to be met alternative configuration may be considered.
ECSS-E-ST-10-03_0750279
- c. Propellant tanks shall be at least mass and stiffness representative during spin testing.

NOTE Simulated propellant can be used.

6.5.2.5 Transient and Sine Burst Tests

ECSS-E-ST-10-03_0750280

- a. Transient and sine burst tests shall be conducted in launch configuration.
NOTE Transient test reproduces launch events (coming from launcher data) in time domain on a shaker.

ECSS-E-ST-10-03_0750281

- b. Propellant storage tanks shall be at least mass and stiffness representative during transient and sine burst tests.
NOTE Simulated propellant can be used. Empty tank testing needs to be considered case by case.

ECSS-E-ST-10-03_0750282

- c. The internal pressure decay due to the leakage shall be verified for pressurized space segment equipment being part of the space segment element under test.

ECSS-E-ST-10-03_0750283

- d. Space segment element equipped with apogee or retro motors shall be tested for the vibration environment generated by the motor if
 1. the environment is not enveloped by the launch boost environment;
or
 2. the configuration during the apogee or retro motor burn is different from the launch configuration.

ECSS-E-ST-10-03_0750284

- e. A resonance search shall be performed before and after the transient and sine burst tests to determine resonance frequencies to evaluate the product integrity.

ECSS-E-ST-10-03_0750285

- f. The success criteria for the resonance search shall be:
 1. less than 5 % in frequency shift, for modes with an effective mass greater than 10 %;

2. less than 20 % in amplitude shift, for modes with an effective mass greater than 10 %.

ECSS-E-ST-10-03_0750286

- g. For the transient test, the excitation signals shall be derived from the space segment element and launcher loads coupled dynamic analysis (LCDA).

NOTE Although transient test methods are fairly advanced, a number of problems with respect to uncertainties resulting from the analytical process on the test input functions and statistical variations are still to be resolved. Transient tests can relatively easily replace longitudinal tests, but experience is very limited in lateral testing.

6.5.2.6 Acoustic test

ECSS-E-ST-10-03_0750287

- a. Acoustic tests shall be conducted with the space segment element in launch configuration mounted on a test fixture.

ECSS-E-ST-10-03_0750288

- b. The test fixture shall be decoupled from the chamber.

ECSS-E-ST-10-03_0750289

- c. Propellant tanks shall be at least mass and stiffness representative during acoustic testing.

NOTE Simulated propellant can be used.

ECSS-E-ST-10-03_0750290

- d. The internal pressure decay shall be verified for pressurized space segment equipment being part of the space segment element under test.

ECSS-E-ST-10-03_0750291

- e. Space segment equipment, within the space segment element, which operate during launch, shall be operated and monitored during the test.

ECSS-E-ST-10-03_0750292

- f. In case the launch configuration introduces specific acoustic loads, the test set up shall be representative of the launch configuration.

NOTE Examples are: several space segment elements attached to a common structure during launch, presence of test standing waves between opposite wall.

ECSS-E-ST-10-03_0750293

- g. In order to evaluate the product integrity a low level acoustic run shall be performed before and after the acoustic run for determining resonant frequencies.

NOTE Typical value for the low level acoustic is -8 dB the qualification level.

ECSS-E-ST-10-03_0750294

- h. The success criteria for the resonance search shall be:
1. less than 5 % in frequency shift, for modes with an effective mass greater than 10 %;
 2. less than 40 % in amplitude shift, for modes with an effective mass greater than 10 %.

6.5.2.7 Random vibration test

ECSS-E-ST-10-03_0750295

- a. Random vibration tests shall be conducted in launch configuration for all axes.

ECSS-E-ST-10-03_0750296

- b. Random excitations shall cover the three mutually orthogonal directions, one being parallel to the thrust axis.

ECSS-E-ST-10-03_0750297

- c. Propellant tanks shall be at least mass and stiffness representative during random testing.

NOTE Simulated propellant can be used.

ECSS-E-ST-10-03_0750298

- d. The internal pressure decay shall be verified for pressurized space segment equipment being part of the space segment element under test.

ECSS-E-ST-10-03_0750299

- e. Space segment element equipped with apogee or retro motors shall be tested for the vibration environment generated by the motor if

1. the environment is not enveloped by the launch boost environment;
or
2. the configuration during the apogee or retro motor burn is different from the launch configuration.

ECSS-E-ST-10-03_0750300

- f. Notching criteria and implementation shall be approved by the customer and, if relevant, by the launcher authority.

ECSS-E-ST-10-03_0750301

- g. The induced cross axis accelerations at the attachment points shall be limited to the maximum test levels specified for the cross axis.

ECSS-E-ST-10-03_0750302

- h. Space segment equipment, being part of the space segment element, that operates during launch shall be operated and monitored during the test.

ECSS-E-ST-10-03_0750303

- i. In order to evaluate the space segment element integrity a resonance search shall be performed before and after the random vibration test by determining resonant frequencies.

ECSS-E-ST-10-03_0750304

- j. The success criteria for the resonance search shall be:
 - 1. less than 5 % in frequency shift, for modes with an effective mass greater than 10 %;
 - 2. less than 20 % in amplitude shift, for modes with an effective mass greater than 10 %.

ECSS-E-ST-10-03_0750305

- k. For space segment element which is designed to be re-flown, the qualification test duration per axis shall be in conformance with Table 6-2 plus 50 seconds per additional flight.

6.5.2.8 Sinusoidal vibration test

ECSS-E-ST-10-03_0750306

- a. Sinusoidal vibration tests shall be conducted in launch configuration for the three mutually orthogonal directions, one being parallel to the thrust axis.

ECSS-E-ST-10-03_0750307

- b. Propellant storage tanks shall be at least mass and stiffness representative during sinusoidal vibration test.

NOTE Simulated propellant can be used.

ECSS-E-ST-10-03_0750308

- c. The internal pressure decay shall be verified for pressurized space segment equipment being part of the space segment element under test.

ECSS-E-ST-10-03_0750309

- d. Notching criteria and implementation shall be approved by the customer and, if relevant, by the launcher authority.

ECSS-E-ST-10-03_0750310

- e. Space segment element equipped with apogee or retro motors shall be tested for the vibration environment generated by the motor if
 - 1. the environment is not enveloped by the launch boost environment;
or
 - 2. the configuration during the apogee or retro motor burn is different from the launch configuration.

ECSS-E-ST-10-03_0750311

- f. Automatic protection measures shall be implemented during the test to prohibit excessive resonance build-up leading to hardware damage.

NOTE This is achieved for example by means of abort and notch accelerometers control.

ECSS-E-ST-10-03_0750312

- g. A resonance search shall be performed before and after the sinusoidal vibration tests to determine resonance frequencies to evaluate the product integrity and to compare the resonance frequency distribution with that of the mathematical model or modal survey.

NOTE 1 Any significant shift in resonance frequencies from those analytically determined is an indication of improper assembly or materials defects.

NOTE 2 This resonance search can be used to update the Finite Element Model in case of design modification w.r.t. the previously tested model.

ECSS-E-ST-10-03_0750313

- h. The success criteria for the resonance search shall be:
1. less than 5 % in frequency shift, for modes with an effective mass greater than 10 %;
 2. less than 20 % in amplitude shift, for modes with an effective mass greater than 10 %.

6.5.2.9 Shock test

ECSS-E-ST-10-03_0750314

- a. During shock tests the space segment element shall be in an operating mode representative of launch, ascent phases or configuration relevant during the shock actuation.

ECSS-E-ST-10-03_0750315

- b. The shock test shall yield the necessary data to pronounce the qualification of the space segment element.

NOTE The qualification is commonly achieved at equipment level, by comparing the flight shock environment with the equipment qualification status (including the qualification margin). The space segment element shock test also allows, where relevant, to justify the omission of equipment level shock testing.

ECSS-E-ST-10-03_0750316

- c. Separation shock tests shall be conducted by actuating the release devices and then verifying the separation.

ECSS-E-ST-10-03_0750317

- d. Shocks induced by release or latching of appendages shall be tested by actuating the relevant devices and then verifying for correct functionality.

ECSS-E-ST-10-03_0750318

- e. Shock sources that induce a shock response spectrum at any space segment equipment location that is within 6 dB of the envelope of the shock response

spectra from all shock sources shall be considered as significant shock source.

ECSS-E-ST-10-03_0750319

- f. Significant shock-producing devices or events, including those from sources not installed on the space segment element under test, shall be activated, simulated or demonstrated on representative hardware, and shock levels measured.

NOTE As an example, pyro valves are not activated at space segment element level but tested on representative panels with shock levels measured at sensitive locations.

ECSS-E-ST-10-03_0750320

- g. Activation of both primary and redundant devices inducing shock shall be carried out in the same sequence as they are intended to be operated.

ECSS-E-ST-10-03_0750321

- h. Space segment equipment operating during the shock phases shall be operated during the test, and the main functional parameters monitored.

ECSS-E-ST-10-03_0750322

- i. Space segment equipment not operating during the shock that can be damaged by shock, shall be monitored for input confirmation.

6.5.2.10 Micro-vibration susceptibility test

ECSS-E-ST-10-03_0750323

- a. During performance test on a space segment element, the effect of **each** potential source of **micro-vibration** shall be tested **separately** by comparing tests with and without perturbation.

NOTE 1 combined effects of several contributors can also be tested.

NOTE 2 Effect of a source of micro-vibrations can also depend on the operating mode (e.g. reaction wheel speed) and/or test configuration (e.g. gravity orientation effect).

NOTE 3 Susceptibility of the space segment element performance can also depend on the operating mode (e.g. integration time).

ECSS-E-ST-10-03_0750480

- b. The time signals of the measurements of the performance parameters as well as from the applied micro-vibration environment shall be recorded.

ECSS-E-ST-10-03_0750481

- c. The background noise shall be measured, including each individual contribution from EGSE, MGSE, FGSE.

NOTE Example of FGSE: pumps.

ECSS-E-ST-10-03_0750482

- d. If necessary, for the purpose of the test, mitigation actions shall be taken to reduce the background noise.

NOTE Background noise can be due to the external environment (e.g. road, sea, wind, people around, other ongoing activities/tests), facilities (e.g. air conditioning, lights), MGSE, EGSE, FGSE (e.g. pumps). Background noise can be different depending on the time (night/day, presence of other activities).

6.5.2.11 Micro-vibration emission test

ECSS-E-ST-10-03_0750483

- a. The micro-vibration environment induced by all activated disturbers during space segment element operation shall be measured, one by one.

NOTE 1 Combined effects of several contributors can be also measured.

NOTE 2 Effect of a source of micro-vibrations can also depend on the operating mode (e.g. reaction wheel speed) and/or test configuration (e.g. gravity orientation effect).

ECSS-E-ST-10-03_0750484

- b. The time signals of the measurements shall be recorded.

ECSS-E-ST-10-03_0750485

- c. The background noise shall be measured, including each individual contribution from EGSE, MGSE, FGSE.

NOTE Example of FGSE: pumps.

ECSS-E-ST-10-03_0750486

- d. If necessary, for the purpose of the test, mitigation actions shall be taken to reduce the background noise.

NOTE Background noise can be due to the external environment (e.g. road, sea, wind, people around, other ongoing activities/tests), facilities (e.g. air conditioning, lights), MGSE, EGSE, FGSE (e.g. pumps). Background noise can be different depending on the time (night/day, presence of other activities).

6.5.3 Structural integrity under pressure tests

6.5.3.1 Proof pressure test

ECSS-E-ST-10-03_0750324

- a. The proof pressure test shall be performed before the environment tests.

ECSS-E-ST-10-03_0750325

- b. <<deleted>>

ECSS-E-ST-10-03_0750326

- c. Requirements of ECSS-E-ST-32-02 clauses 5.4.1 and 5.4.2 for qualification and protoflight, and clauses 5.5.1 and 5.5.2 for acceptance shall be applied for proof pressure tests.

6.5.3.2 Pressure cycling test

ECSS-E-ST-10-03_0750327

- a. Requirements of ECSS-E-ST-32-02 clauses 5.4.1 and 5.4.5 shall be applied for pressure cycling tests.

6.5.3.3 Design burst pressure test

ECSS-E-ST-10-03_0750328

- a. The design burst pressure tests shall be conducted by exposing the space segment element in the flight configuration.

NOTE The model used can be a qualification or a structural model provided all pressure sensitive components are representative of the flight hardware.

ECSS-E-ST-10-03_0750329

- b. The pumping capability of the test facility shall maintain the pressure within the specified limits at all times.

ECSS-E-ST-10-03_0750330

- c. Requirements of ECSS-E-ST-32-02 clauses 5.4.1 and 5.4.6 shall be applied for design burst pressure tests.

6.5.3.4 Leak test

ECSS-E-ST-10-03_0750331

- a. All lines, joints and fittings shall be checked for leaks, on the fully assembled configuration of the space segment element.

ECSS-E-ST-10-03_0750332

- b. When the fully assembled configuration precludes accessibility to perform requirement 6.5.3.4a, leak tests shall be conducted on a configuration to be agreed with the customer.

ECSS-E-ST-10-03_0750333

- c. The method for checking leaks shall be selected according to the requirements to be met.

6.5.4 Thermal tests

6.5.4.1 Requirements applicable to thermal vacuum test and thermal tests at mission pressure

ECSS-E-ST-10-03_0750334

- a. Both thermal vacuum test and thermal test at mission pressure shall be performed for space segment elements that operate under a non-vacuum environment after having been exposed to vacuum.

NOTE At space segment element level, the version C of ECSS-E-ST-10-03 does not consider a thermal test at room pressure (also called "thermal cycling", by example, in US standards and in the version A of ECSS-E-ST-10-03).

ECSS-E-ST-10-03_0750335

- b. Test profile, test configuration, number of cycles, extreme temperatures, temperature rate of change, stability criteria, cycles and plateau duration, functional and performance tests to be performed and success criteria shall be defined in the test specification.

NOTE It is not mandatory to include the solar array or large appendages in a space segment element thermal vacuum test. If it is however included, precautions should be taken to avoid overstress.

ECSS-E-ST-10-03_0750336

- c. A reduced functional test shall be performed prior the closing of the chamber to validate the test configuration.

ECSS-E-ST-10-03_0750337

- d. The sequence of functional tests shall be defined in the test specification such that all space segment equipment are tested.

ECSS-E-ST-10-03_0750464

- e. The most severe operative configuration should be tested with regard to the power time domain, the power consumption and the thermal dissipation point of view.

ECSS-E-ST-10-03_0750339

- f. The equipment power ON/OFF status, throughout the test (including transitions), shall be defined in the test specification.

ECSS-E-ST-10-03_0750340

- g. Functional tests shall be performed as a minimum at hot and cold plateaux.

NOTE Mechanical functional test can be part of the functional test, pending on configuration or test set-up constraint

ECSS-E-ST-10-03_0750341

- h. Equipment switch on capabilities shall be demonstrated.

ECSS-E-ST-10-03_0750342

- i. In case of redundancy, thermal tests shall be performed on both chains taking into account the type of redundancy (e.g. hot or cold).

ECSS-E-ST-10-03_0750343

- j. In case of cross-strapped configurations, requirements for testing shall be agreed with the customer.

ECSS-E-ST-10-03_0750344

- k. Monitoring for corona shall be conducted during chamber pressure reduction for space segment equipment that are critical with regards to corona effect.

NOTE For thermal test at mission pressure, this is justified by the fact that atmospheric pressure can be lower than Earth atmospheric pressure.

ECSS-E-ST-10-03_0750345

- l. The temperatures of all the space segment equipment shall be monitored to ensure that the space segment equipment are not damaged during test.

ECSS-E-ST-10-03_0750346

- m. Equipment temperatures within the space segment elements shall refer to the equipment temperature reference points.

ECSS-E-ST-10-03_0750347

- n. Test methods and test set up shall be defined according to the thermal environment characteristics, the TCS thermal design, the space segment element itself and the need for thermal balance phases.

ECSS-E-ST-10-03_0750348

- o. The rate of temperature change during cooling, and heating shall be the same as those projected for the mission, but not exceed them.

ECSS-E-ST-10-03_0750349

- p. The test set-up and test modes shall be selected, in order to achieve the specified test temperatures within the specified stability and duration.

ECSS-E-ST-10-03_0750350

- q. The test set-up shall ensure appropriate orientation for space segment elements containing two phase heat transport device (e.g. heat pipes).

6.5.4.2 Requirements applicable to thermal vacuum test

ECSS-E-ST-10-03_0750351

- a. The set-up shall ensure that outgassing does not contaminate the space segment element.

ECSS-E-ST-10-03_0750352

- b. The pressure during the test shall be maintained $\leq 10^{-5}$ hPa.

6.5.4.3 Requirements applicable to thermal test at mission pressure

ECSS-E-ST-10-03_0750353

- a. Test approach with thermal test at mission pressure without vacuum test shall be selected only for space segment elements that operate under a non-vacuum environment during their entire lifetime.

NOTE In assessing this, depressurisation failure should be considered.

ECSS-E-ST-10-03_0750354

- b. Pressure value shall be as per type of mission.

NOTE e.g., Earth atmospheric pressure, Mars pressure, Space Station pressure

ECSS-E-ST-10-03_0750355

- c. Climatic conditions shall be such as to avoid condensation on the item under test.

ECSS-E-ST-10-03_0750356

- d. The space segment element shall be mounted in a temperature chamber if the atmospheric mission pressure is near the Earth atmospheric pressure and in a pressure chamber with temperature control capability or in a vacuum chamber with pressure and temperature control capabilities if the atmospheric mission pressure is different from the Earth atmospheric pressure.

6.5.4.4 Thermal balance test

ECSS-E-ST-10-03_0750357

- a. The thermal balance test shall be performed in conformance with ECSS-E-ST-31 clause 4.5.3.

6.5.5 Electromagnetic tests

6.5.5.1 General

For the requirements of clauses 6.5.5.2 two categories of space segment elements are considered:

- stand-alone space segment element,
- embedded space segment element.

6.5.5.2 Electromagnetic compatibility test

6.5.5.2.1 EMC test for stand-alone space segment element

ECSS-E-ST-10-03_0750358

- a. The space segment element shall be subjected to EMC tests, specified in the ECSS-E-ST-20-07 clause 5.3 and in conformance with the Annex A of ECSS-E-ST-20.

ECSS-E-ST-10-03_0750359

- b. When performing space segment element EMC test the compatibility tests with carrier or carried space segment elements shall also be included.

6.5.5.2.2 EMC test for embedded space segment element

ECSS-E-ST-10-03_0750360

- a. The space segment element shall be subjected to EMC tests, specified in the ECSS-E-ST-20-07 clause 5.4 and in conformance with the Annex A of ECSS-E-ST-20.

6.5.5.3 Electromagnetic auto-compatibility test

ECSS-E-ST-10-03_0750361

- a. When performing space segment element EMC auto compatibility test the following EMC requirements shall be included:
 1. use the most critical and sensitive operational modes, as defined by analysis;
 2. perform the auto-compatibility test in an anechoic chamber;
 3. operate the RF links in free space condition (i.e. no antenna cap, no coaxial or wave guide connection);
 4. do not use radiated susceptibility tests for auto-compatibility demonstration purpose.

6.5.5.4 Passive intermodulation test

ECSS-E-ST-10-03_0750362

- a. If results of PIM analysis show that PIM can be present, the space segment element shall be subjected to passive intermodulation tests.

NOTE For PIM analysis refer to ECSS-E-ST-20 clause 7.4.

- b. The operational configuration(s) for the PIM test shall conform to ECSS-E-ST-20 clause 7.4.

NOTE E.g. power level, temperature level.

6.5.5.5 Magnetic field measurements

ECSS-E-ST-10-03_0750364

- a. The magnetic field measurement shall be performed in a dedicated facility featuring Earth field compensation.

6.5.6 Mission specific tests

6.5.6.1 Aero-thermodynamic test

ECSS-E-ST-10-03_0750365

- a. The aero-thermodynamic tests shall be performed on dedicated scaled models in wind tunnels for different conditions.

NOTE 1 E.g. hot and cold hypersonic, low supersonic and subsonic.

NOTE 2 The aero-thermodynamic test verifies the aerodynamic and thermal loads on the space segment element performing atmospheric entry.

6.5.7 Crewed mission specific tests

6.5.7.1 Vibroacoustic emission test

ECSS-E-ST-10-03_0750366

- a. <<deleted>>

ECSS-E-ST-10-03_0750367

- b. >>deleted>>

ECSS-E-ST-10-03_0750368

- c. The vibroacoustic noise measurements shall be performed in nominal emission conditions for each disturbance source one by one.

NOTE 1 Combined effects of several contributors can also be measured.

NOTE 2 Effect of a source of micro-vibrations can also depend on the operating mode (e.g. reaction wheel speed) and/or test configuration (e.g. gravity orientation effect).

ECSS-E-ST-10-03_0750487

- d. The time signals of the measurement shall be recorded.

ECSS-E-ST-10-03_0750488

- e. The background noise shall be measured, including each individual contribution from EGSE, MGSE, FGSE.

NOTE Example of FGSE: pumps.

ECSS-E-ST-10-03_0750489

- f. If necessary, for the purpose of the test, mitigation actions shall be taken to reduce the background noise.

6.5.7.2 Human factor engineering (HFE) test

ECSS-E-ST-10-03_0750369

- a. The HFE tests shall be performed to demonstrate accessibility for man-machine interface usability and crew operability in a flight like environment by a representative population, using simulator or mock up.

NOTE The test verifies requirements related to human factor engineering.

6.5.7.3 Toxic off gassing test

ECSS-E-ST-10-03_0750370

- a. A toxic gas test shall be performed in thermal chamber to verify that the flight hardware does not produce toxic vapours that can build up to harmful levels for the crew in the closed loop life support system.

ECSS-E-ST-10-03_0750371

- b. The item under test shall be heated and maintained in temperature conditions, while the emitted gasses and vapours are detected.

ECSS-E-ST-10-03_0750372

- c. Toxic gas markers shall be used on the basis of the materials composing the item under test.

6.5.7.4 Audible noise test

ECSS-E-ST-10-03_0750373

- a. An audible noise test shall be performed to verify that the flight hardware does not produce audible noise levels that are detrimental to the crew health and safety.

ECSS-E-ST-10-03_0750374

- b. Measured values shall not be higher than NC 50.

ECSS-E-ST-10-03_0750375

- c. After a background noise measurement, the noise emission during space segment element operation shall be measured in the worst case emission conditions for qualification and in normal operation condition for acceptance.

ECSS-E-ST-10-03_0750376

- d. Noise levels shall limit crew noise exposure to a 24-hour equivalent of 65 A-weighted decibel (dBA).

ECSS-E-ST-10-03_0750377

- e. Cabin reverberation time (T60) shall not exceed 0,5 second +/- 0,1 second at 500 Hz (Octave centre frequency).

7**Pre-launch testing**

ECSS-E-ST-10-03_0750378

- a. Pre-launch tests shall confirm that all elements needed for the launch, including their interfaces are verified, and that their parameters are within the specified limits.

NOTE 1 Elements needed for the launch are: Launch segment element, space segment element and associated GSE.

NOTE 2 For space segment element, the set of parameters checked as part of pre-launch testing is a sub set of those used during AIT. The definition of this sub set is subject to agreement with the customer.

ECSS-E-ST-10-03_0750379

- b. Pre-launch tests results shall result in the authorizing the next pre-launch activities to be carried out.

NOTE For example leak test is performed to authorize fuelling.

ECSS-E-ST-10-03_0750380

- c. The procedures to be executed during the launch campaign shall be rehearsed before the start of the launch campaign.

NOTE This means that procedure used in pre-launch activities have been rehearsed, at least once during AIT.

ECSS-E-ST-10-03_0750381

- d. The impact of any change on the EGSE shall be evaluated and the rehearsal repeated if it is so derived from the evaluation.

ECSS-E-ST-10-03_0750382

- e. Pre-launch functional tests shall be performed to verify that no damage or performance degradation of the space segment element and its constituents has occurred during shipment or handling.

NOTE Verification of redundancy is included.

ECSS-E-ST-10-03_0750383

- f. When a space segment element is not transported fully assembled or is subsequently disabled, the final assembly at launch site shall be retested.

NOTE For example batteries, solar array. The level of retesting is subject to agreement with the customer.

ECSS-E-ST-10-03_0750384

- g. The pre-launch functional test shall include a verification of electrical power interfaces and command and control functions as well as, when relevant, of radio frequency interference.

ECSS-E-ST-10-03_0750385

- h. Circuit continuity, insulation and absence of stray energy shall be checked, at the level of the safe and arm plug connector, prior to connection the flight pyro arm plug.

ECSS-E-ST-10-03_0750386

- i. If the pyro connections are planned in the launch facility, circuit continuity, insulation shall be checked, at the level of the safe and arm plug connector, prior to connection.

ECSS-E-ST-10-03_0750387

- j. For crewed mission, final crew interface verification in all operational configurations shall be performed.

Annex A (normative)

Assembly, integration and test plan (AIT Plan) - DRD

A.1 DRD identification

A.1.1 Requirement identification and source document

This DRD is called from ECSS-E-ST-10-03, requirement 4.3.3.2a.

A.1.2 Purpose and objective

The assembly integration and test plan is the master plan for the product AIT process. It describes the complete AIT process and demonstrates together with the verification plan how the requirements are verified by inspection and test.

It contains the overall AIT activities and the related verification tools (GSE and facilities), the involved documentation, the AIT management and organization. It also contains the AIT schedule.

It is one of the major inputs to the project schedule and is used to provide the customer a basis for review and evaluation of the effectiveness of the AIT programme and its proposed elements.

An AIT [Plan](#) is prepared for the different verification levels covering in detail the AIT activities at that level and outlining the necessary lower level aspects.

The AIT [Plan](#) is complementary to the verification plan. It takes into account the test standards defined in the Customer requirements.

The availability of the verification plan is a prerequisite to the preparation of the AIT [Plan](#).

A.2 Expected response

A.2.1 Scope and content

<1> Introduction

ECSS-E-ST-10-03_0750388

- a. The AIT [Plan](#) shall contain a description of the purpose, objective, content and the reason prompting its preparation.

ECSS-E-ST-10-03_0750389

- b. Any open issue, assumption and constraint relevant to this document shall be stated and described.

<2> Applicable and reference documents

ECSS-E-ST-10-03_0750390

- a. The AIT Plan shall list the applicable and reference documents in support to the generation of the document.

<3> Definitions and abbreviations

ECSS-E-ST-10-03_0750391

- a. The AIT Plan shall list the applicable dictionary or glossary and the meaning of specific terms or abbreviations utilized in the document.

<4> Product presentation

ECSS-E-ST-10-03_0750392

- a. The AIT Plan shall briefly describe the selected models and their built status with reference to the verification plan (see ECSS-E-ST-10-02).

<5> Assembly, integration and test programme

ECSS-E-ST-10-03_0750393

- a. The AIT Plan shall document the AIT activities and associated planning.

ECSS-E-ST-10-03_0750394

- b. The AIT Plan shall include test matrix(ces) that link the various tests with the test specifications, test procedures, test blocks and hardware model.

ECSS-E-ST-10-03_0750465

- c. Assembly, integration and test programmes including inspections, should be detailed through dedicated activity sheets.

ECSS-E-ST-10-03_0750396

- d. Activity sheets shall include descriptions of the activity including the tools and GSE to be used, the expected duration of the activity, and the relevant safety or operational constraints.

ECSS-E-ST-10-03_0750466

- e. The sequencing of activities should be presented as flow charts.

<6> GSE and AIT facilities

ECSS-E-ST-10-03_0750398

- a. The AIT Plan shall list and describe the GSE, test software and AIT facilities to be used.

ECSS-E-ST-10-03_0750399

- b. The AIT Plan shall describe the logistics and list the major transportations.

<7> AIT documentation

ECSS-E-ST-10-03_0750400

- a. The AIT **Plan** shall describe the AIT documents to be produced and their content.

<8> Organization and management

ECSS-E-ST-10-03_0750401

- a. The AIT **Plan** shall describe the responsibility and management tools applicable to the described AIT process with reference to ECSS-E-ST-10-02.

ECSS-E-ST-10-03_0750402

- b. The AIT **Plan** shall describe the responsibilities within the project team, the relation to product assurance, quality control and configuration control (tasks with respect to AIT) as well as the responsibility sharing with external partners.

NOTE Tasks with respect to AIT include for example, anomaly handling, change control, safety, and cleanliness.

ECSS-E-ST-10-03_0750403

- c. The planned reviews and the identified responsibilities shall be stated.

<9> AIT schedule

ECSS-E-ST-10-03_0750404

- a. The AIT **Plan** shall provide the AIT schedule as reference.

A.2.2 Special remarks

None.

Annex B (normative)

Test specification (TSPE) - DRD

B.1 DRD identification

B.1.1 Requirement identification and source document

This DRD is called from ECSS-E-ST-10-03, requirement 4.3.3.3a.

B.1.2 Purpose and objective

The test specification (TSPE) describes in detail the test requirements applicable to any major test activity. In particular, it defines the purpose of the test, the test approach, the item under test and the set-up, the required GSE, test tools, test instrumentation and measurement **uncertainties**, test conditions **with tolerances**, test sequence, test facility, pass/fail criteria, required documentation, participants and test schedule.

Since major test activities often cover multiple activity sheets, the structure of the TSPE is adapted accordingly.

The TSPE is used as an input to the test procedures, as a requirements document for booking the environmental test facility and to provide evidence to the customer on certain details of the test activity in advance of the activity itself.

The TSPE is used at each level of the space system decomposition (i.e. equipment, space segment element)

The TSPE provides the requirements for the activities identified in the AIT **Plan** (as defined in Annex A of ECSS-E-ST-10-03).

The TSPE is used as a basis for writing the relevant test procedures (as defined in Annex C of ECSS-E-ST-10-03) and test report (as defined in Annex C of ECSS-E-ST-10-02).

In writing the test specification potential overlaps with the test procedure is minimized (i.e. the test specification gives emphasis on requirements, the test procedure on operative step by step instructions). For simple tests, merging TSPE and TPRO is acceptable.

B.2 Expected response

B.2.1 Scope and content

<1> Introduction

ECSS-E-ST-10-03_0750405

- a. The TSPE shall contain a description of the purpose, objective, content and the reason prompting its preparation.

ECSS-E-ST-10-03_0750406

- b. Any open issue, assumption and constraint relevant to this document shall be stated and described.

<2> Applicable and reference documents

ECSS-E-ST-10-03_0750407

- a. The TSPE shall list the applicable and reference documents in support to the generation of the document.

<3> Definitions and abbreviations

ECSS-E-ST-10-03_0750408

- a. The TSPE shall list the applicable dictionary or glossary and the meaning of specific terms or abbreviations utilized in the document.

<4> Requirements to be verified

ECSS-E-ST-10-03_0750409

- a. The TSPE shall list the requirements to be verified (extracted from the VCD) in the specific test and provides traceability where in the test the requirement is covered.

<5> Test approach and test requirements

ECSS-E-ST-10-03_0750410

- a. The TSPE shall summarize the approach to the test activity and the associated requirements as well as the prerequisites to start the test.

<6> Test description

ECSS-E-ST-10-03_0750411

- a. The TSPE shall summarize the configuration of the item under test, the test set-up, the necessary GSE, the test tools, the test conditions and the applicable constraints.

<7> Test facility

ECSS-E-ST-10-03_0750412

- a. The TSPE shall describe the applicable test facility requirements together with the instrumentation and measurement **uncertainties**, data acquisition and test space segment equipment to be used.

<8> Test sequence

ECSS-E-ST-10-03_0750413

- a. The TSPE shall describe the test activity flow and the associated requirements.

ECSS-E-ST-10-03_0750414

- b. When constraints are identified on activities sequence, the TSPE shall specify them including necessary timely information between test steps.

<9> Pass/fail criteria

ECSS-E-ST-10-03_0750415

- a. The TSPE shall list the test pass/fail criteria in relation to the inputs and output.

ECSS-E-ST-10-03_0750416

- b. <<deleted>>

<10> Test documentation

ECSS-E-ST-10-03_0750417

- a. The TSPE shall list the requirements for the involved documentation, including test procedure, test report and PA and QA records.

<11> Test organization

ECSS-E-ST-10-03_0750418

- a. The TSPE shall describe the overall test responsibilities, participants to be involved and the schedule outline.

NOTE Participation list is often limited to organisation and not individual name.

B.2.2 Special remarks

None.

Annex C (normative)

Test procedure (TPRO) - DRD

C.1 DRD identification

C.1.1 Requirement identification and source document

This DRD is called from ECSS-E-ST-10-03, requirement 4.3.3.4a.

C.1.2 Purpose and objective

The Test Procedure (TPRO) gives directions for conducting a test activity in terms of description, resources, constraints and step-by-step procedure, and provides detailed step-by-step instructions for conducting test activities with the selected test facility and set-up in agreement with the relevant AIT [Plan](#) and the test requirements. It contains the activity objective, the applicable documents, the references to the relevant test specification and the test facility configuration, the participants required, the list of configured items under test and tools and the step-by-step activities.

The TPRO is used and filled-in as appropriate during the execution and becomes the “as-run” procedure.

The TPRO is prepared for each test to be conducted at each verification level. The same procedure can be used in case of recurring tests.

It incorporates the requirements of the test specification (DRD Annex B) and uses detailed information contained in other project documentation (e.g. drawings, ICDs).

Several procedures often originate from a single test specification. In certain circumstances involving a test facility (for example during environmental tests) several test procedures can be combined in an overall integrated test procedure.

The “as-run” procedure becomes part of the relevant test report (see ECSS-E-ST-10-02).

Overlaps with the test specification are minimized (see Annex B).

C.2 Expected response

C.2.1 Scope and contents

<1> Introduction

ECSS-E-ST-10-03_0750419

- a. The TPRO shall contain a description of the purpose, objective, content and the reason prompting its preparation.

ECSS-E-ST-10-03_0750420

- b. Any open issue, assumption and constraint relevant to this document shall be stated and described.

<2> Applicable and reference documents

ECSS-E-ST-10-03_0750421

- a. The TPRO shall list the applicable and reference documents in support to the generation of the document.

<3> Definitions and abbreviations

ECSS-E-ST-10-03_0750422

- a. The TPRO shall list the applicable dictionary or glossary and the meaning of specific terms or abbreviations utilized in the document.

<4> Requirements mapping w.r.t. the TSPE

ECSS-E-ST-10-03_0750423

- a. The TPRO shall provide a mapping matrix to the TSPE giving traceability towards the test requirement.

<5> Item under test

ECSS-E-ST-10-03_0750424

- a. The TPRO shall describe the item under test configuration, including any reference to the relevant test configuration list, and any deviation from the specified standard.

ECSS-E-ST-10-03_0750425

- b. The software version of the item under test shall be identified.

<6> Test set-up

ECSS-E-ST-10-03_0750426

- a. The TPRO shall describe the test set-up to be used.

<7> GSE and test tools required

ECSS-E-ST-10-03_0750427

- a. The TPRO shall identify the GSE and test tools to be used in the test activity including test script(s), test software and database(s) versioning number.

<8> Test instrumentation

ECSS-E-ST-10-03_0750428

- a. The TPRO shall identify the test instrumentation, with measurement **uncertainties**, to be used, including fixtures.

<9> Test facility

ECSS-E-ST-10-03_0750429

- a. The TPRO shall identify the applicable test facility and any data handling system.

<10> Test conditions

ECSS-E-ST-10-03_0750430

- a. The TPRO shall list the applicable standards, the applicable test conditions, in terms of levels, duration and tolerances, and the test data acquisition and reduction.

<11> Documentation

ECSS-E-ST-10-03_0750431

- a. The TPRO shall describe how the applicable documentation is used to support the test activity.

<12> Participants

ECSS-E-ST-10-03_0750432

- a. The TPRO shall list the allocation of responsibilities and resources.

<13> Test constraints and operations

ECSS-E-ST-10-03_0750433

- a. The TPRO shall identify special, safety and hazard conditions, operational constraints, rules for test management relating to changes in procedure, failures, reporting and signing off procedure.

ECSS-E-ST-10-03_0750434

- b. The TPRO shall describe QA and PA aspects applicable to the test.

- c. The TPRO shall contain a placeholder for identifying:
 - 1. procedure variations, together with justification, and
 - 2. anomalies.

<14> **Step-by-step procedure**

ECSS-E-ST-10-03_0750436

- a. The TPRO shall provide detailed instructions, including expected results, with tolerances, pass/fail criteria, and identification of specific steps to be witnessed by QA personnel.

ECSS-E-ST-10-03_0750467

- b. The step-by-step instructions may be organized in specific tables.

ECSS-E-ST-10-03_0750438

- c. When the procedure is automated, the listing of the automated procedure shall be documented to a level allowing consistency check with the TPRO and the TPSE.

C.2.2 Special remarks

None.

Annex D (informative)

Guidelines for tailoring and verification of this standard

D.1 Introduction

Due to the fact that this standard addresses different type of products (e.g. space segment elements and various space segment equipment) and models (e.g. QM, FM, PFM), several options are left open in the standard for selection by the customer. The options are marked in the relevant tables by a “X”. Therefore tailoring cannot be avoided for this standard, this Annex gives guidelines for performing the tailoring and the standard verification.

Figure D-1 presents the logic for tailoring by the customer and the expected answer from the supplier in form of compliance and verification matrices.

D.2 Tailoring guidelines

The tailoring is applied in three steps:

- First step: Tailoring is based upon the type of product and selected model philosophy. It consists of the selection of the relevant clauses as presented in Figure D-2.

NOTE Should your model philosophy combine several models (e.g. QM+FM, or PFM+FM) the relevant clauses for both models need to be selected and merged when performing the second step.

- Second step: The second tailoring consists in the consolidating Table 5-1, Table 5-3, Table 5-5, Table 6-1, Table 6-3 and Table 6-5 as they were selected in the First step.
- Third step: The clause and Table called up on Table(s) consolidated at the Second step needs to be added, appropriately merged and tailored.

At the end of the three steps, a new document is build which is the tailored Testing standard for a project application.

The supplier responds to this document by a compliance matrix.

When performing the three above steps the following points needs to be covered:

- review the terms in clause 3 to ensure their proper use when performing the tailoring steps;
- agree, as needed, on the nature of the item (space segment equipment versus space segment element) as per requirement 4.1b, and for equipment, agree the type of, or combination of types (as per Table 5-1 or Table 5-3 or Table 5-5);

- agree on Test block definition as per requirement 4.3.2.1b in particular for equipment;
- establish test matrix and test flow based on Figure 5-1 and Table 5-1 or Table 5-3 or Table 5-5 for equipment and Table 6-1, Table 6-3 or Table 6-5 for space segment element;
- tailor the corresponding test level and duration based on corresponding Table 5-1 and Table 5-2 or Table 5-4 or Table 5-6 for equipment and Table 6-2, Table 6-4 or Table 6-6 for space segment element;
- take the requirements of clauses 5.5 or 6.5 in accordance with the test table(s) (see column "Reference clause") and tailor them;

NOTE When several models are considered reference from various tables need to be considered taking into account the tailoring performed for each model.

- include clause 4.6 in case of re-testing;
- include clause 7 in case of PFM or FM stand-alone space segment element.

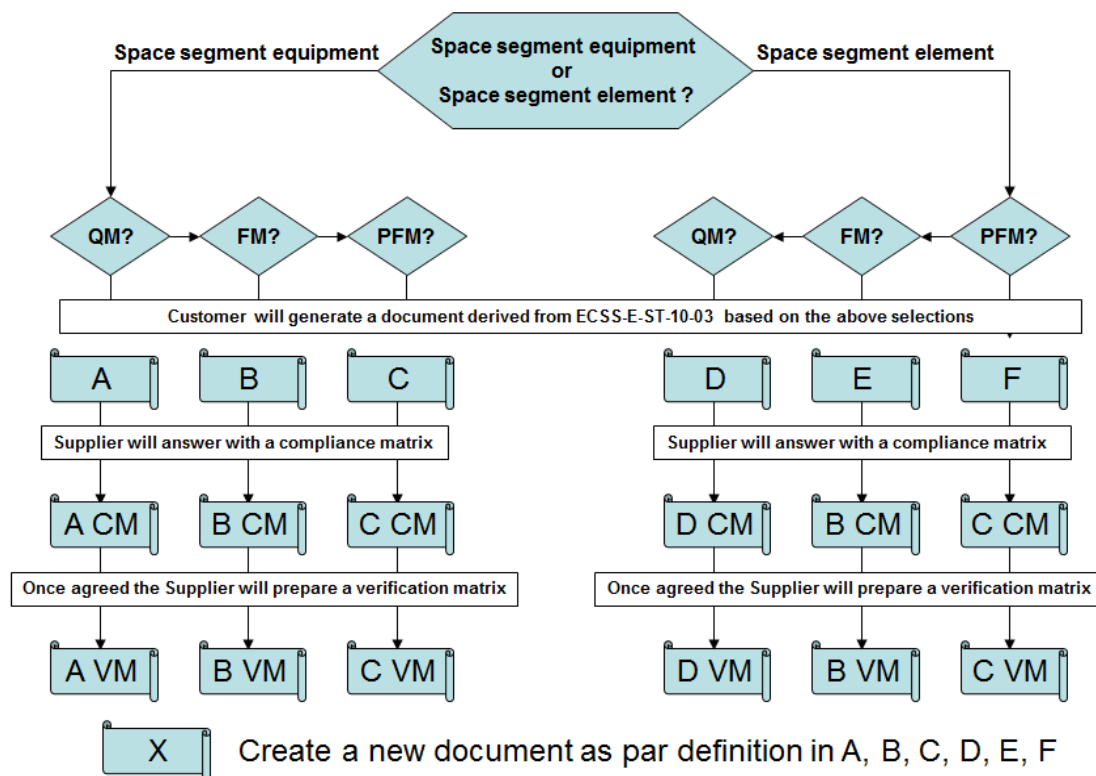


Figure D-1: Logic for customer tailoring and supplier answer through compliance and verification matrix

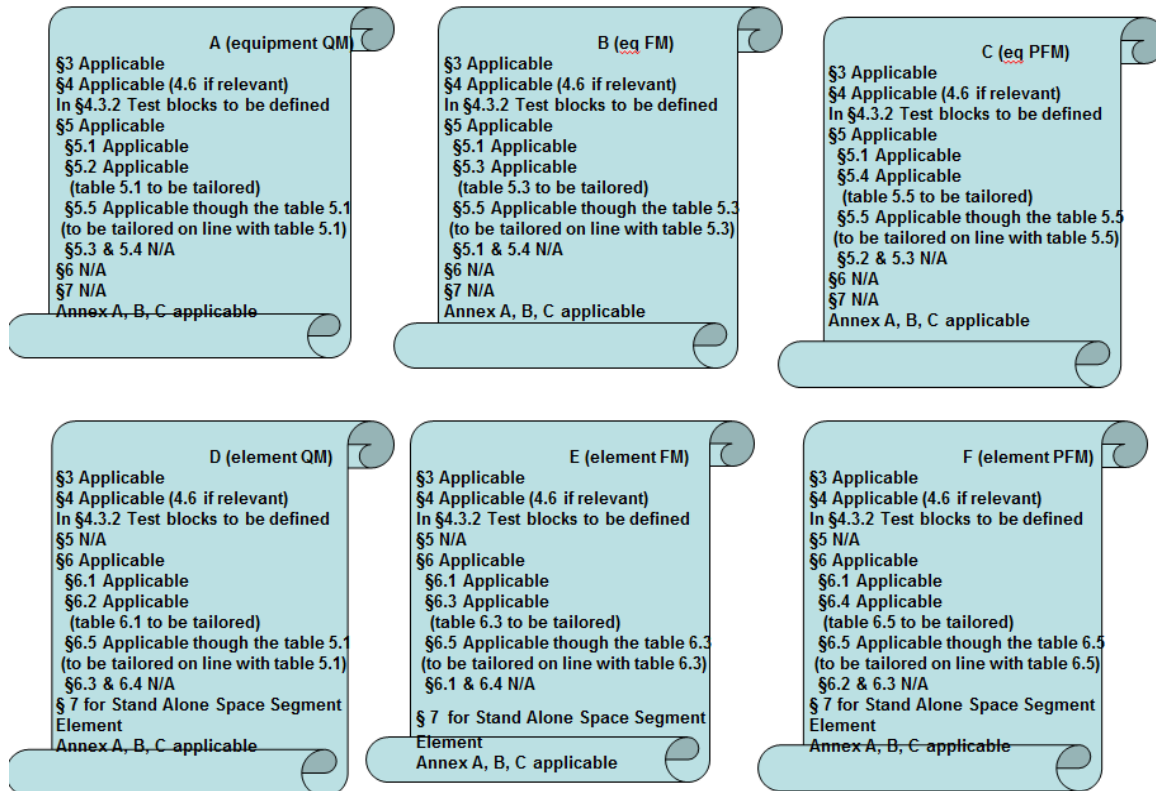


Figure D-2: Clauses selection in First step of the tailoring

D.3 Verification guidelines

When preparing the verification close-out document (VCD) against the tailored standard derived from this standard (see D.2) it is not considered necessary to have a close-out for all requirements.

The Table D-1 identifies the need for verification close-out.

Table D-1: Guideline for verification close-out

Clause	Verification close-out	Comment
4.1	No	(*)
4.2	No	(*)
4.3	No	(*)
4.4	Yes	
4.5	No	(*)
4.6	No	(*)
5.1	No	(*)
5.2 Table 5-1	No	
5.2 Table 5-2	Yes	
5.3 Table 5-3	No	
5.3 Table 5-4	Yes	

Clause	Verification close-out	Comment
5.4 Table 5-5	No	
5.4 Table 5-6	Yes	
5.5	Yes	
6.1	No	(*)
6.2 Table 6-1	No	
6.2 Table 6-2	Yes	
6.3 Table 6-3	No	
6.3 Table 6-4	Yes	
6.4 Table 6-5	No	
6.4 Table 6-6	Yes	
6.5	Yes	
7	No	(*)
Annex A, B, C	No	DRDs
(*) Verification is done when reviewing and agreeing on the test documentation.		

Bibliography

ECSS-S-ST-00	ECSS system - Description, implementation and general requirements
ECSS-M-ST-10	Space project management - Project planning and implementation
ECSS-E-HB-10-02	Space engineering - Verification guidelines
ECSS-E-ST-31-02	Space engineering - Qualification of two-phase heat transport equipment
ECSS-E-HB-32-25	Space engineering - Mechanical shock design and verification handbook
EA-4/02, 2013	Expression of the uncertainty of measurement in calibration
EA-4/16, Dec 2003	EA guidelines on the expression of uncertainty in quantitative testing
ISO/IEC 17025	General requirements for the competence of testing and calibration laboratories
JCGM 100 series	Evaluation of measurement data